

TEST REPORT

Product Name: Smart Watch

Trademark: N/A

SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7, S8, S9, S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S,

Model Number: T32S, T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27,

E86, E87, E88, E89, E80, E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900, E88pro, E88mini, F100, F12, F100, F18, F45, F60, F11, F12, F28, F80, M6, M5, M4S, X5

Prepared For: Shenzhen Xiangmingda Technology Co., Ltd.

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Sample Received Date: May. 31, 2022

Sample tested Date: May.31, 2022 to Jun. 06, 2022

Issue Date: Jun. 06, 2022

Report No.: CTB220606026RFX

Test Standards ETSI EN 300 328 V2.2.2 (2019-07)

Test Results PASS

Chen Whan

Remark: This is Bluetooth BLE radio test report.

Compiled by: Reviewed by: Approved by:

Arron Itu

Chen Zheng Arron Liu

Bin Mei / Director

The test report is effective only with both signature and specialized stamp. This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen CTB Testing Technology Co., Ltd. this report can't be reproduced except in full. The tested sample(s) and the sample information are provided by the client.

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(Note: N/A means not applicable)



1. VERSION

Report No.	Issue Date	Description	Approved
CTB220606026RFX	Jun. 06, 2022	Original	Valid

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2. TEST SUMMARY

The Product has been tested according to the following specifications:

Standard	ETSI EN 300 328 V2.2.2		
Test Item	Test Requirement	Test Method	Results
	Transmitter Parameters		0 0
RF Output Power	Clause 4.3.2.2	Clause 5.4.2	PASS
Power Spectral Density	Clause 4.3.2.3	Clause 5.4.3	PASS
Duty cycle, Tx-Sequence, Tx-gap	Clause 4.3.2.4	Clause 5.4.4	N/A ¹
Medium Utilization (MU) factor	Clause 4.3.2.5	Clause 5.4.5	N/A ²
Adaptivity (adaptive equipment using modulations other than FHSS)	Clause 4.3.2.6	Clause 5.4.6	N/A ³
Occupied Channel Bandwidth	Clause 4.3.2.7	Clause 5.4.7	PASS
Transmitter unwanted emissions in the out-of-band domain	Clause 4.3.2.8	Clause 5.4.8	PASS
Transmitter unwanted emissions in the spurious domain	Clause 4.3.2.9	Clause 5.4.9	PASS
	Receiver Parameters	6' 6' 6'	0' 0'
Receiver spurious emissions	Clause 4.3.2.10	Clause 5.4.10	PASS
Receiver Blocking	Clause 4.3.2.11	Clause 5.4.11	PASS
Geo-location capability	Clause 4.3.2.12	Clause 5.4.12	N/A ⁴

Remark:

N/A¹: Because these requirements apply to non-adaptive frequency hopping equipment mode and RF output power of greater than or equal to 10 dBm.

N/A²: Because these requirements apply to non-adaptive frequency hopping equipment mode and RF output power of greater than or equal to 10 dBm.

N/A³: Because these requirements apply to adaptive equipment mode and RF output power of greater than or equal to 10 dBm.

N/A⁴: Only for equipment with geo-location capability

Tx: In this whole report Tx (or tx) means Transmitter.

Rx: In this whole report Rx (or rx) means Receiver.

RF: In this whole report RF means Radiated Frequency.

CH:In this whole report CH means channel.

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3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Item	Uncertainty
Occupancy bandwidth	54.3kHz
Conducted output power Above 1G	0.9dB
Conducted output power below 1G	0.9dB
Power Spectral Density , Conduction	0.9dB
Conduction spurious emissions	2.0dB
Out of band emission	2.0dB
3m camber Radiated spurious emission(30MHz-1GHz)	4.6dB
3m chamber Radiated spurious emission(1GHz-18GHz)	5.1dB
3m chamber Radiated spurious emission(18GHz-40GHz)	3.4dB
Receiver Reference Sensitivity level	1.9dB
humidity uncertainty	5.5%
Temperature uncertainty	0.63℃
frequency	1×10 ⁻⁷

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4. PRODUCT INFORMATION AND TEST SETUP

4.1 Product Information

Model(s):

SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7,

S8, S9, S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S, T32S, T34S, T45S, T60, T66, T11, T68, T60, T60, TW26, TW27

T32S, T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27,

E86, E87, E88, E89, E80, E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900, E88pro, E88mini, F100, F12, F100, F18,

F45, F60, F11, F12, F28, F80, M6, M5, M4S, X5

Model Description:

All the model are the same circuit and RF module, only for model

name. Test sample model: SW/29

Bluetooth Version: Bluetooth V5.0

Hardware Version: V1.0 Software Version: V1.0

Operation Frequency: Bluetooth: 2402-2480MHz

Max. RF output power: Bluetooth: -1.48dBm

Type of Modulation: Bluetooth: GFSK

Antenna installation: Bluetooth: Internal antenna

Antenna Gain: Bluetooth: 1.0Bi

Ratings: DC 5V charging from adapter

Battery DC 3.7V

4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP Photographs for the actual connections between Product and support equipment.

4.3 Support Equipment

Item	Equipment	Mfr/Brand	Model/Type No.	Series No.	Note
\$ 9 B	AC adapter	Shenzhen Xiangmingda Technology Co., Ltd.	EE-0501000E	N/A	AE

Notes:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

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4.4 Channel List

CH No.	Frequency (MHz)	CH No.	Frequency (MHz)	CH No.	Frequency (MHz)	CH No.	Frequency (MHz)
0	2402	8 T	2404	2	2406	3	2408
4	2410	5	2412	6	2414	C 7	2416
8	2418	9	2420	10	2422	11	2424
12	2426	13	2428	14	2430	15	2432
16	2434	17	2436	18	2438	19	2440
20	2442	21	2444	22	2446	23	2448
24	2450	25	2452	26	2454	27	2456
28	2458	29	2460	30	2462	31	2464
32	2466	33	2468	34	2470	35	2472
36	2474	37	2476	38	2478	39	2480

4.5 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

Test mode	Low channel	Middle channel	High channel
Transmitting(GFSK)	2402MHz	2440MHz	2480MHz
Receiving(GFSK)	2402MHz	2440MHz	2480MHz

4.6 Test Environment

Humidity(%):	54
Atmospheric Pressure(kPa):	101
Normal Voltage(DC)(V):	5 4 4 4 4 4
Normal Temperature(°C):	23
Low Temperature(°C):	0
High Temperature(°C):	40

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5. TEST FACILITY AND TEST INSTRUMENT USED

5.1 Test Facility

All measurement facilities used to collect the measurement data are located at Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Street, Baoan District, Shenzhen China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

5.2 Test Instrument Used

RF conduction and RadiationTest equipment

No.	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	Spectrum Analyzer	Agilent	N9020A	MY52090073	2022.08.05
2	Power Sensor	Agilent	U2021XA	MY56120032	2022.08.05
3	Power Sensor	Agilent	U2021XA	MY56120034	2022.08.05
4	Communication test set	R&S	CMW500	108058	2022.08.05
5	Spectrum Analyzer	R&S	FSP40	100550	2022.08.05
6	Signal Generator	Agilent	N5181A	MY49060920	2022.08.16
7	Signal Generator	Agilent	N5182A	MY47420195	2022.08.05
8	Communication test set	Agilent	E5515C	MY50102567	2022.08.16
9	band rejection filter	Shenxiang	MSF2400-2483. 5MS-1154	2018101500 1	2022.08.05
10	band rejection filter	Shenxiang	MSF5150-5850 MS-1155	2018101500 1	2022.08.05
11	band rejection filter	Xingbo	XBLBQ-DZA120	190821-1-1	2022.08.05
12	BT&WI-FI Automatic test software	Micowave	MTS8310	Ver. 2.0.0.0	2022.08.05
13	Rohde & Schwarz SFU Broadcast Test System	R&S	SFU	101017	2022.08.05
14	Temperature humidity chamber	Hongjing	TH-80CH	DG-15174	2022.08.05
15	234G Automatic test software	Micowave	MTS8200	Ver. 2.0.0.0	2022.08.05
16	966 chamber	C.R.T.	966 Room	966	2024.08.11
17	Receiver	R&S	ESPI	100362	2022.08.05
18	Amplifier	HP	8447E	2945A02747	2022.08.05
19	Amplifier	Agilent	8449B	3008A01838	2022.08.05

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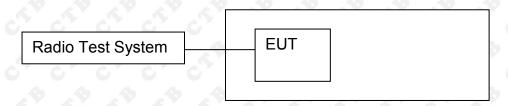
20	TRILOG Broadband Antenna	Schwarzbeck	VULB 9163	869	2022.08.07
21	Horn Antenna	Schwarzbeck	BBHA9120D	1911	2022.08.08
22	Software	Fala	EZ-EMC	FA-03A2 RE	2022.08.05
23	3-Loop Antenna	Daze	ZN30401	17014	2022.08.05
24	loop antenna	ZHINAN	ZN30900A	100 A	2022.08.05
25	Horn antenna	A/H/System	SAS-574	588	2022.08.05
26	Amplifier	AEROFLEX	1 5	S/N/ 097	2022.08.05

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6. RF OUTPUT POWER

6.1 Block Diagram Of Test Setup



6.2 Limit

For adaptive equipment using wide band modulations other than FHSS, the maximum RF output power shall be 20 dBm.

The maximum RF output power for non-adaptive equipment shall be declared by the supplier and shall not exceed 20 dBm. See clause 5.3.1 m). For non-adaptive equipment using wide band modulations other than FHSS, the maximum RF output power shall be equal to or less than the value declared by the supplier.

This limit shall apply for any combination of power level and intended antenna assembly.

	Limit	
6	20dBm	67 67

6.3 Test procedure

Step 1:

- Use a fast power sensor suitable for 2.4 GHz and capable of minimum 1 MS/s.
- Use the following settings:
- Sample speed 1 MS/s or faster.
- The samples shall represent the RMS power of the signal.
- Measurement duration: For non-adaptive equipment: equal to the observation period defined in clause 4.3.1.3.2 or clause 4.3.2.4.2. For adaptive equipment, the measurement duration shall be long enough to ensure a minimum number of bursts (at least 10) are captured.

NOTE 1: For adaptive equipment, to increase the measurement accuracy, a higher number of bursts may be used.

Step 2:

- For conducted measurements on devices with one transmit chain:
- Connect the power sensor to the transmit port, sample the transmit signal and store the raw data. Use these stored samples in all following steps.
- For conducted measurements on devices with multiple transmit chains:
- Connect one power sensor to each transmit port for a synchronous measurement on all transmit ports.
- Trigger the power sensors so that they start sampling at the same time. Make sure the time difference between the samples of all sensors is less than 500 ns.
- For each individual sampling point (time domain), sum the coincident power samples



of all ports and store them. Use these summed samples in all following steps.

Step 3:

• Find the start and stop times of each burst in the stored measurement samples. The start and stop times are defined as the points where the power is at least 30 dB below the highest value of the stored samples in step 2.

NOTE 2: In case of insufficient dynamic range, the value of 30 dB may need to be reduced appropriately.

Step 4:

• Between the start and stop times of each individual burst calculate the RMS power over the burst using the formula below. Save these Pburst values, as well as the start and stop times for each burst.

$$P_{burst} = \frac{1}{k} \sum_{n=1}^{k} P_{sample}(n)$$

with 'k' being the total number of samples and 'n' the actual sample number

Step 5:

• The highest of all Pburst values (value "A" in dBm) will be used for maximum e.i.r.p. calculations.

Step 6:

- · Add the (stated) antenna assembly gain "G" in dBi of the individual antenna.
- If applicable, add the additional beamforming gain "Y" in dB.
- If more than one antenna assembly is intended for this power setting, the maximum overall antenna gain (G or G + Y) shall be used.
- The RF Output Power (P) shall be calculated using the formula below:

$$P = A + G + Y$$

 This value, which shall comply with the limit given in clause 4.3.1.2.3 or clause 4.3.2.2.3, shall be recorded in the test report.

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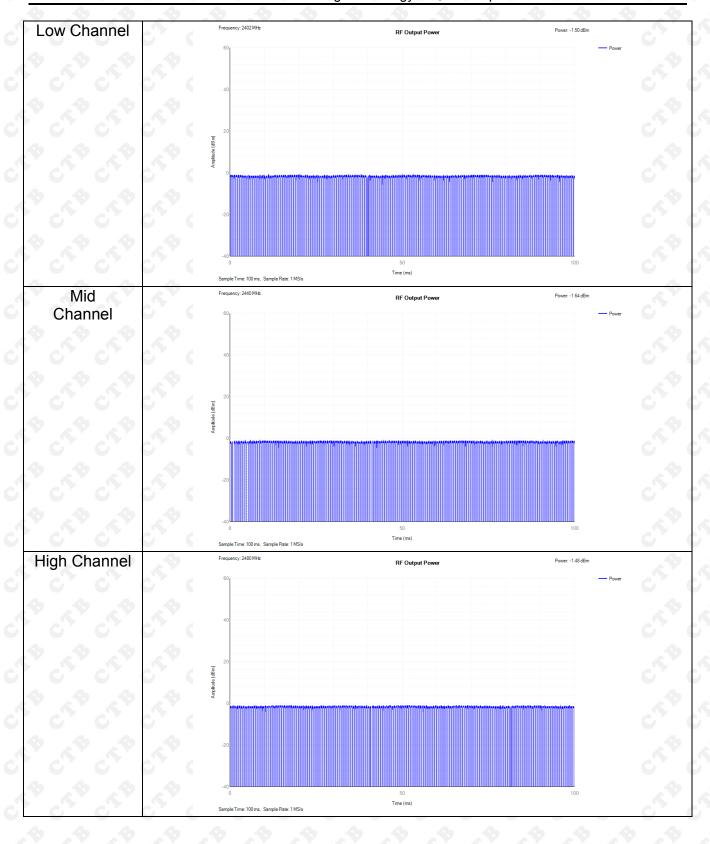
6.4 Test Result

	Test conditions	EIRP (dBm)				
Modulation	(Temperature)	Low Channel	Middle Channel	High Channel		
	Normal	-1.50	-1.64	-1.48		
GFSK	Low	-1.66	-1.71	-1.64		
	High	-1.59	-1.76	-1.49		
8 8 8	Limit & & &	≤1	00mW (20dB	m) 👃 🕠		
Remark: P = A	+ G + Y,G=1dBi,x=100%	6	63	3		

Remark: This Report only show the test plots of the worst case.

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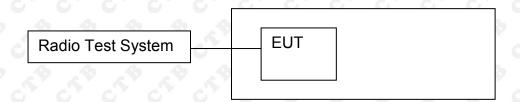






7. POWER SPECTRAL DENSITY

7.1 Block Diagram Of Test Setup



7.2 Limit

For equipment using wide band modulations other than FHSS, the maximum Power Spectral Density is limited to 10 dBm per MHz.

Ş	Limit
	10dBm/MHz

7.3 Test procedure

Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

Start Frequency: 2 400 MHz

Stop Frequency: 2 483,5 MHz

· Resolution BW: 10 kHz

Video BW: 30 kHz

Sweep Points: > 8 350

NOTE: For spectrum analysers not supporting this number of sweep points, the frequency band may be segmented.

Detector: RMS

Trace Mode: Max Hold

 Sweep time: 10 s; the sweep time may be increased further until a value where the sweep time has no impact on the RMS value of the signal

For non-continuous signals, wait for the trace to stabilize.

Save the data (trace data) set to a file.



Step 2:

For conducted measurements on smart antenna systems using either operating mode 2 or operating mode 3 (see clause 5.1.3.2), repeat the measurement for each of the transmit ports. For each sampling point (frequency domain), add up the coincident power values (in mW) for the different transmit chains and use this as the new data set.

Step 3:

Add up the values for power for all the samples in the file using the formula below.

$$P_{Sum} = \sum_{n=1}^{k} P_{sample}(n)$$

with 'k' being the total number of samples and 'n' the actual sample number

Step 4:

Normalize the individual values for power (in dBm) so that the sum is equal to the RF Output Power (e.i.r.p.) measured in clause 5.3.2 and save the corrected data. The following formulas can be used:

$$\begin{split} C_{Corr} &= P_{Sum} - P_{e.i.r.p.} \\ P_{Samplecorr}(n) &= P_{Sample}(n) - C_{Corr} \end{split}$$

with 'n' being the actual sample number

Step 5:

Starting from the first sample PSamplecorr(n) (lowest frequency), add up the power (in mW) of the following samples representing a 1 MHz segment and record the results for power and position (i.e. sample #1 to sample #100). This is the Power Spectral Density (e.i.r.p.) for the first 1 MHz segment which shall be recorded.

Step 6:

Shift the start point of the samples added up in step 5 by one sample and repeat the procedure in step 5 (i.e. sample #2 to sample #101).

Step 7:

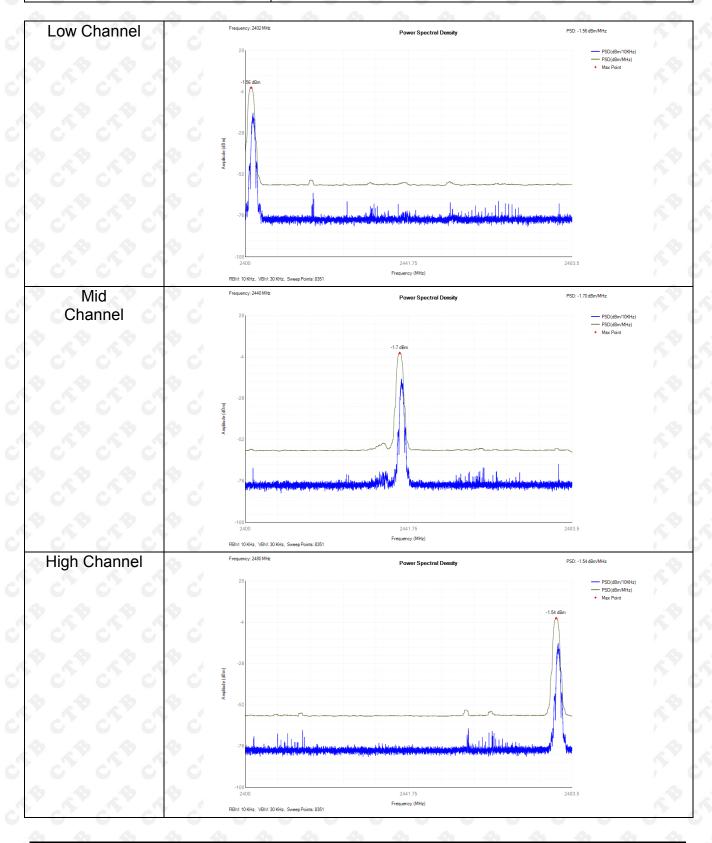
Repeat step 6 until the end of the data set and record the Power Spectral Density values for each of the 1 MHz segments.

From all the recorded results, the highest value is the maximum Power Spectral Density for the UUT. This value, which shall comply with the limit given in clause 4.3.2.3.3, shall be recorded in the test report.



7.4 Test Result

Madulation	Test conditions	Maximum e.i.r.p. Spectral Density (dBm/MHz)					
Modulation	Test conditions	Low Channel	Middle Channel	High Channel			
GFSK	GFSK Normal		<	-1.54			
	Limit	≤10dBm/MHz					

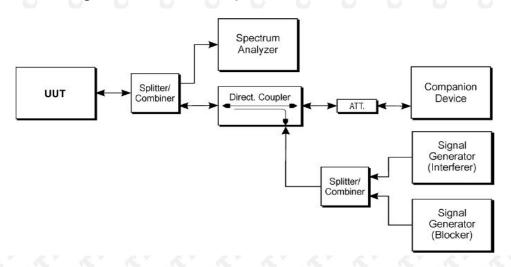


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8. ADAPTIVITY

8.1 Block Diagram Of Test Setup



8.2 Limit

The frequency range of the equipment is determined by the lowest and highest

Non-LBT based Detect and Avoid:

- 1 The frequency shall remain unavailable for a minimum time equal to 1 second after which the channel maybe considered again as an 'available' channel;
 - 2 COT ≤ 40 ms;
 - 3 Idle Period = 5% of COT;
 - 4 Detection threshold level = -70dBm/MHz + 20 Pout E.I.R.P (Pout in dBm);

LBT based Detect and Avoid (Frame Based Equipment):

- 1 Minimum Clear Channel Assessment (CCA) time = 20 us;
- 2 CCA observation time declared by the supplier;
- $3 \text{ COT} = 1 \sim 10 \text{ ms};$
- 4 Idle Period = 5% of COT;
- 5 Detection threshold level = -70dBm/MHz + 20 Pout E.I.R.P (Pout in dBm);

LBT based Detect and Avoid (Load Based Equipment):

- 1 Minimum Clear Channel Assessment (CCA) time = 20 us;
- 2 CCA declared by the manufacturer:
- $3 \text{ COT} \le (13 / 32) * q \text{ ms}; q = [4~32]; 1.625 \text{ms}~13 \text{ms};$
- 4 Detection threshold level = -73dBm/MHz + 20 Pout E.I.R.P (dBm);

Short Control Signalling Transmissions:

Short Control Signalling Transmissions shall have a maximum duty cycle of 10% within an observation period of 50ms.

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8.3 Test procedure

Step 1:

The UUT may connect to a companion device during the test. The interference signal generator, the blocking signal generator, the spectrum analyser, the UUT and the companion device are connected using a set-up equivalent to the example given by figure 5 although the interference and blocking signal generator do not generate any signals at this point in time. The spectrum analyser is used to monitor the transmissions of the UUT in response to the interfering and the blocking signals.

Adjust the received signal level (wanted signal from the companion device) at the UUT to the value defined in table 6

The analyzer shall be set as follows:

- RBW: ≥ Occupied Channel Bandwidth (if the analyser does not support this setting, the highest available setting shall be used)
- VBW: 3 × RBW (if the analyser does not support this setting, the highest available setting shall be used)
- Detector Mode: RMS
- Centre Frequency: Equal to the centre frequency of the operating channel
- Span: 0 Hz
- Sweep time: > Channel Occupancy Time of the UUT
- Trace Mode: Clear/Write
- Trigger Mode: Video

Step 2:

Configure the UUT for normal transmissions with a sufficiently high payload to allow demonstration of compliance of the adaptive mechanism on the channel being tested

Using the procedure defined in clause 5.3.7.2.1.4, it shall be verified that the UUT complies with the maximum Channel Occupancy Time and minimum Idle Period

Step 3: Adding the interference signal

A 100 % duty cycle interference signal is injected on the current operating channel of the UUT. This interference signal shall be a band limited noise signal which has a flat power spectral density, and shall have a bandwidth greater than the Occupied Channel Bandwidth of the UUT. The maximum ripple of this interfering signal shall be ±1,5 dB within the Occupied Channel Bandwidth and the power spectral density.

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Step 4: Verification of reaction to the interference signal

The spectrum analyser shall be used to monitor the transmissions of the UUT on the selected operating channel with the interfering signal injected. This may require the spectrum analyser sweep to be triggered by the start of the interfering signal.

Using the procedure defined in clause 5.3.7.2.1.4, it shall be verified that:

The UUT shall stop transmissions on the current operating channel being tested.

Apart from Short Control Signalling Transmissions (see iii) below), there shall be no subsequent transmissions on this operating channel for a (silent) period defined in clause 4.3.2.5.1.2 step 2. After that, the UUT may have normal transmissions again for the duration of a single Channel Occupancy Time period. Because the interference signal is still present, another silent period as defined in clause 4.3.2.5.1.2 step 2 needs to be included. This sequence is repeated as long as the interfering signal is present.

The UUT may continue to have Short Control Signalling Transmissions on the operating channel while the interference signal is present. These transmissions shall comply with the limits

Alternatively, the equipment may switch to a non-adaptive mode

Step 5: Adding the blocking signal

With the interfering signal present, a 100 % duty cycle CW signal is inserted as the blocking signal

Repeat step 4 to verify that the UUT does not resume any normal transmissions

Step 6: Removing the interference and blocking signal

On removal of the interference and blocking signal the UUT is allowed to start transmissions again on this channel however, it shall be verified that this shall only be done after the period defined in clause 4.3.2.5.1.2 step 2.

Step 7:

The steps 2 to 6 shall be repeated for each of the frequencies to be tested.



8.4 Test Result

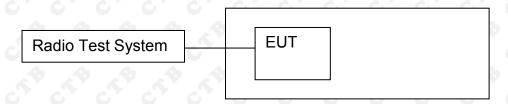
Remark: this requirement does not apply for equipment when operating in a mode where the RF Output power is less than 10 dBm e.i.r.p.

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9. OCCUPIED CHANNEL BANDWIDTH

9.1 Block Diagram Of Test Setup



9.2 Limit

The Occupied Channel Bandwidth shall fall completely within the band given in 2.4GHz to 2.4835GHz.

In addition, for non-adaptive systems using wide band modulations other than FHSS and with e.i.r.p greater than 10 dBm, the occupied channel bandwidth shall be less than 20 MHz.

9.3 Test procedure

Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

Centre Frequency: The centre frequency of the channel under test

Resolution BW: ~ 1 % of the span without going below 1 %

Video BW: 3 × RBW

Frequency Span: 2 × Nominal Channel Bandwidth

Detector Mode: RMS

Trace Mode: Max Hold

Sweep time: 1 s

Step 2:

Wait for the trace to stabilize.

Find the peak value of the trace and place the analyser marker on this peak.

Step 3:

Use the 99 % bandwidth function of the spectrum analyser to measure the Occupied Channel Bandwidth of the UUT.

This value shall be recorded.

NOTE: Make sure that the power envelope is sufficiently above the noise floor of the analyser to avoid the noise signals left and right from the power envelope being taken into account by this measurement.



9.4 Test Result

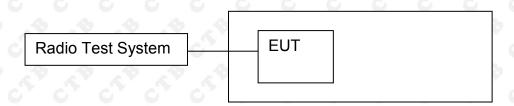
Modulation Frequency (MHz)		-	cy Range Hz)	Occupied Channel (MHz)		
OFOK	Low	2402.013	b 10	1.023		
GFSK	High	67/67	2480.013	1.027		





10. TRANSMITTER UNWANTED EMISSIONS IN THE OUT-OF-BAND DOMAIN

10.1 Block Diagram Of Test Setup



10.2 Limit

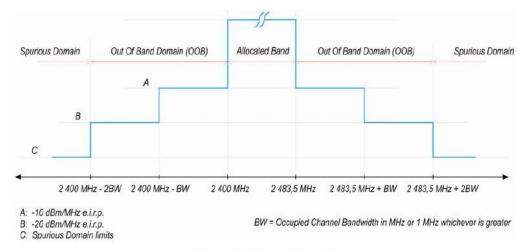


Figure 3: Transmit mask

10.3 Test procedure

The applicable mask is defined by the measurement results from the tests performed under clause 5.3.8 (Occupied Channel Bandwidth).

The test procedure is further as described under clause 5.3.9.2.1.

The Out-of-band emissions within the different horizontal segments of the mask provided in figures 1 and 3 shall be measured using the steps below. This method assumes the spectrum analyser is equipped with the Time Domain Power option.

Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

- Centre Frequency: 2 484 MHz

- Span: 0 Hz

Resolution BW: 1 MHzFilter mode: Channel filter

- Video BW: 3 MHz

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- Detector Mode: RMS

Trace Mode: Max Hold

- Sweep Mode: Continuous

- Sweep Points: Sweep Time [s] / (1 µs) or 5 000 whichever is greater

- Trigger Mode: Video trigger

NOTE 1: In case video triggering is not possible, an external trigger source may be used.

- Sweep Time: > 120 % of the duration of the longest burst detected during the measurement of the RF Output Power

Step 2 (segment 2 483,5 MHz to 2 483,5 MHz + BW):

- Adjust the trigger level to select the transmissions with the highest power level.
- For frequency hopping equipment operating in a normal hopping mode, the different hops will result in signal bursts with different power levels. In this case the burst with the highest power level shall be selected.
- Set a window (start and stop lines) to match with the start and end of the burst and in which the RMS power shall be measured using the Time Domain Power function.
- Select RMS power to be measured within the selected window and note the result which is the RMS power within this 1 MHz segment (2 483,5 MHz to 2 484,5 MHz). Compare this value with the applicable limit provided by the mask.
- Increase the centre frequency in steps of 1 MHz and repeat this measurement for every 1 MHz segment within the range 2 483,5 MHz to 2 483,5 MHz + BW. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + BW 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 3 (segment 2 483,5 MHz + BW to 2 483,5 MHz + 2BW):

• Change the centre frequency of the analyser to 2 484 MHz + BW and perform the measurement for the first 1 MHz segment within range 2 483,5 MHz + BW to 2 483,5 MHz + 2BW. Increase the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + 2 BW - 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 4 (segment 2 400 MHz - BW to 2 400 MHz):

• Change the centre frequency of the analyser to 2 399,5 MHz and perform the measurement for the first 1 MHz segment within range 2 400 MHz - BW to 2 400 MHz Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - BW + 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 5 (segment 2 400 MHz - 2BW to 2 400 MHz - BW):

• Change the centre frequency of the analyser to 2 399,5 MHz - BW and perform the measurement for the first 1 MHz segment within range 2 400 MHz - 2BW to 2 400 MHz - BW. Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover

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this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - 2BW + 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 6:

• In case of conducted measurements on equipment with a single transmit chain, the declared antenna assembly gain "G" in dBi shall be added to the results for each of the 1 MHz segments and compared with the limits

provided by the mask given in figure 1 or figure 3. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered.

- In case of conducted measurements on smart antenna systems (equipment with multiple transmit chains), the measurements need to be repeated for each of the active transmit chains. The declared antenna assembly gain "G" in dBi for a single antenna shall be added to these results. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered. Comparison with the applicable limits shall be done using any of the options given below:
- Option 1: the results for each of the transmit chains for the corresponding 1 MHz segments shall be added. The additional beamforming gain "Y" in dB shall be added as well and the resulting values compared with the limits provided by the mask given in figure 1 or figure 3.
- Option 2: the limits provided by the mask given in figure 1 or figure 3 shall be reduced by

10 × log10(Ach) and the additional beamforming gain "Y" in dB. The results for each of the transmit chains shall be individually compared with these reduced limits.

NOTE 2: Ach refers to the number of active transmit chains.

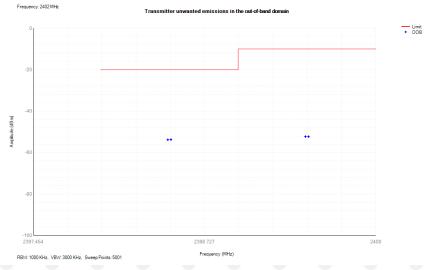
It shall be recorded whether the equipment complies with the mask provided in figure 1 or figure 3.

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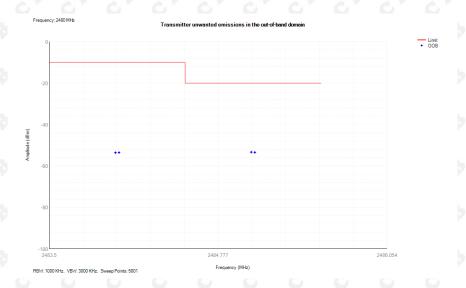


10.4 Test Result

Low Channel										
Test Freq (MHz)	Antenna	Freq(MHz)	Level	Limit						
2402	Antenna 1	2399.477	-52.3	-10						
2402	Antenna 1	2398.477	-53.73	-20						



High Channel											
Test Freq (MHz)	Antenna	Freq(MHz)	Level	Limit							
2480	Antenna 1	2484.027	-53.48	-10							
2480	Antenna 1	2485.027	-53.29	-20							

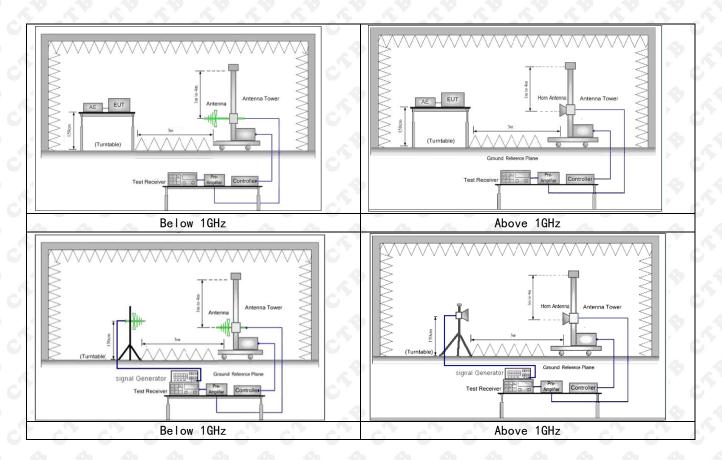


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11. TRANSMITTER UNWANTED EMISSIONS IN THE SPURIOUS DOMAIN

11.1 Block Diagram Of Test Setup



11.2 Limits

Frequency range	Maximum power, e.r.p. (≤ 1 GHz) e.i.r.p. (> 1 GHz)	RBW/VBW
30 MHz to 47 MHz	-36 dBm	100 kHz/300KHz
47 MHz to 74 MHz	-54 dBm	100 kHz/300KHz
74 MHz to 87,5 MHz	-36 dBm	100 kHz/300KHz
87,5 MHz to 118 MHz	-54 dBm	100 kHz/300KHz
118 MHz to 174 MHz	-36 dBm	100 kHz/300KHz
174 MHz to 230 MHz	-54 dBm	100 kHz/300KHz
230 MHz to 470 MHz	-36 dBm	100 kHz/300KHz
470 MHz to 694 MHz	-54 dBm	100 kHz/300KHz
694 MHz to 1 GHz	-36 dBm	100 kHz/300KHz
1 GHz to 12,75 GHz	-30 dBm	1 MHz/3MHz

11.3 Test Procedure

1. Scan from 30MHz to 12.75GHz, find the maximum radiation frequency to measure.

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The technique used to find the Spurious Emissions of the transmitter was the antenna substitution method. Substitution method was performed to determine the actual ERP/EIRP emission levels of the EUT.

Test procedure as below:

- 1) The EUT was powered ON and placed on a 1.5m high table at a 3 meter fully Anechoic Chamber. The antenna of the transmitter was extended to its maximum length. modulation mode and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- 2) The EUT was set 3 meters(above 18GHz the distance is 1 meter) away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- 3) The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 4) Steps 1) to 3) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 5) The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 6) A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 3) is obtained for this set of conditions.
- 7) The output power into the substitution antenna was then measured.
- 8) Steps 6) and 7)were repeated with both antennas polarized.
- 9) Calculate power in dBm by the following formula:

 $ERP(dBm) = P_{SG}(dBm) - cable loss(dB) + antenna gain(dBd)$

EIRP(dBm) = Psg (dBm) - cable loss (dB) + antenna gain (dBi)

EIRP=ERP+2.15dB

where:

Psg is the generator output power into the substitution antenna.

10) Test the EUT in the lowest channel , the Highest channel

Repeat above procedures until all frequencies measured was complete.



11.4 Test Results

Below 1GHz

Freq (MHz)	Rd_level (dBm)	Factor (dB)	Level (dBm)	Limit (dBm)	Over (dB)	detector	Height	Degree	Antenna polarization
CAT	5 S	CAN	C.S. C.	Low	/ Channe		CAN	4	65,05
46.404	-55.01	-12.47	-67.48	-36.00	-31.48	peak	1.5	204	ъ Н
66.860	-54.71	-12.65	-67.36	-54.00	-13.36	peak	1.9	152	H
104.317	-56.27	-12.00	-68.27	-54.00	-14.27	peak	1.3	156	♦ 4
217.719	-52.99	-10.56	-63.55	-54.00	-9.55	peak	1.8	321	C H C
327.344	-53.51	-10.18	-63.69	-36.00	-27.69	peak	1.4	102	P AH A
870.296	-52.04	-0.25	-52.29	-36.00	-16.29	peak	1.6	64	OHO
47.874	-55.36	-11.99	-67.35	-36.00	-31.35	peak	1.9	87	V
101.421	-55.28	-11.78	-67.06	-54.00	-13.06	peak	1.2	266	V
184.791	-55.51	-12.29	-67.81	-54.00	-13.81	peak	1.4	88	V
218.416	-53.33	-10.76	-64.08	-54.00	-10.08	peak	1.2	127	V
327.957	-53.35	-9.57	-62.92	-36.00	-26.92	peak	1.4	99	OVO
869.213	-52.55	-0.04	-52.58	-36.00	-16.58	peak	1.3	176	V
0	0,0	6	0,0	High	Channe		0.0	0	0 0
44.194	-55.50	-12.03	-67.53	-36.00	-31.53	peak	1.6	97	SH S
68.757	-54.80	-12.01	-66.80	-54.00	-12.80	peak	1.7	338	. Н
104.955	-55.69	-12.30	-67.99	-54.00	-13.99	peak	1.2	273	H
219.264	-52.80	-10.45	-63.25	-54.00	-9.25	peak	1.4	233	ъ Н
327.494	-52.98	-9.71	-62.69	-36.00	-26.69	peak	1.2	260	C H C
869.915	-52.27	0.09	-52.19	-36.00	-16.19	peak	1.7	180	P AP A
46.415	-54.81	-12.49	-67.29	-36.00	-31.29	peak	1.5	257	O.A.O.
101.819	-55.10	-12.60	-67.71	-54.00	-13.71	peak	1.8	138	V
183.517	-55.72	-12.20	-67.93	-54.00	-13.93	peak	1.0	57	V
217.670	-53.29	-10.50	-63.79	-54.00	-9.79	peak	1.1	163	V
327.321	-52.84	-9.76	-62.60	-36.00	-26.60	peak	1.8	186	V
869.831	-51.93	0.21	-51.72	-36.00	-15.72	peak	1.8	42	o V o

Remark:

Absolute Level = Receiver Reading + Factor Factor = Antenna Factor + Cable Loss – Pre-amplifier

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Above 1G:

Freq	Rd_level	Factor	Level	Limit	Over	dataatar	Hoight	Dograd	Antenna				
(MHz)	(dBm)	(dB)	(dBm)	(dBm)	(dB)	detector	Height	Degree	polarization				
	Low Channel												
4804	-54.92	8.41	-46.51	-30.00	-16.51	peak	1.0	20	Н				
7206	-52.26	12.55	-39.71	-30.00	-9.71	peak	1.7	335	H				
4804	-54.22	8.41	-45.81	-30.00	-15.81	peak	1.7	147	V				
7206	-52.24	12.55	-39.69	-30.00	-9.69	peak	1.4	211	~ V ~ ♦				
\$ A	\$,\$	\$ A	2 P 2 P	High	Channel	. D . D	A 4 A	\$ A	~ \$ ~ \$				
4960	-54.75	8.51	-46.24	-30.00	-16.24	peak	1.5	136	H				
7440	-52.25	12.69	-39.56	-30.00	-9.56	peak	1.1	230	C) H)				
4960	-54.86	8.51	-46.35	-30.00	-16.35	peak	1.2	90	V				
7440	-51.58	12.69	-38.89	-30.00	-8.89	peak	1.9	151	V				

Remark:

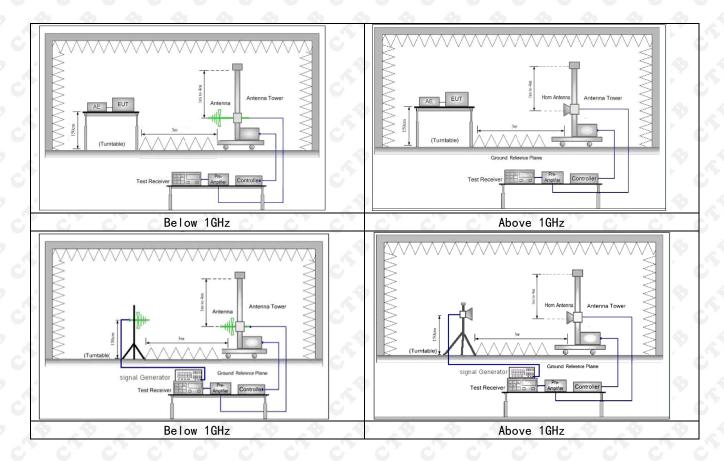
Absolute Level = Receiver Reading + Factor
Factor = Antenna Factor + Cable Loss – Pre-amplifier

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12. RECEIVER SPURIOUS EMISSIONS

12.1 Block Diagram Of Test Setup



12.2 Limits

Frequency(MHz)	Limit
30-1000	-57dBm
1000-12750	-47dBm

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12.3 **Test Procedure**

- 1. Scan from 30MHz to 12.75GHz, find the maximum radiation frequency to measure.
- 2. The technique used to find the Spurious Emissions of the transmitter was the antenna substitution method. Substitution method was performed to determine the actual ERP/EIRP emission levels of the EUT.

Test procedure as below:

- 1) The EUT was powered ON and placed on a 1.5m hight table at a 3 meter fully Anechoic Chamber. The antenna of the transmitter was extended to its maximum length. modulation mode and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- 2) The EUT was set 3 meters (above 18GHz the distance is 1 meter) away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- 3) The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.
- 4) Steps 1) to 3) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.
- 5) The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.
- 6) A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 3) is obtained for this set of conditions.
- 7) The output power into the substitution antenna was then measured.
- 8) Steps 6) and 7)were repeated with both antennas polarized.
- 9) Calculate power in dBm by the following formula:

```
ERP(dBm) = P_{SG}(dBm) - cable loss(dB) + antenna gain(dBd)
EIRP(dBm) = P<sub>SG</sub> (dBm) - cable loss (dB) + antenna gain (dBi)
EIRP=ERP+2.15dB
```

where:

Psg is the generator output power into the substitution antenna.

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11) Test the EUT in the lowest channel, the Highest channel

Repeat above procedures until all frequencies measured was complete.



12.4 Test Results

Below 1GHz

Freq (MHz)	Rd_level (dBm)	Factor (dB)	Level (dBm)	Limit (dBm)	Over (dB)	detector	Height	Degree	Antenna polarization
				Low	Channel				
45.666	-60.43	-12.36	-72.80	-57.00	-15.80	peak	1.8	119	SH S
66.854	-60.47	-11.76	-72.24	-57.00	-15.24	peak	1.3	133	ьн
105.484	-60.46	-12.20	-72.66	-57.00	-15.66	peak	1.8	255	HO
216.979	-62.20	-10.59	-72.79	-57.00	-15.79	peak	1.2	205	9 49 4
327.216	-61.94	-9.82	-71.75	-57.00	-14.75	peak	1.4	216	O'H O'
869.934	-68.77	-0.50	-69.27	-57.00	-12.27	peak	1.5	139	AH C
46.464	-60.65	-12.18	-72.83	-57.00	-15.83	peak	1.3	274	V
101.238	-60.84	-12.51	-73.35	-57.00	-16.35	peak	1.1	200	V
183.890	-62.70	-12.56	-75.27	-57.00	-18.27	peak	1.9	296	V
218.857	-61.20	-11.03	-72.22	-57.00	-15.22	peak	1.4	36	V
328.397	-59.81	-9.68	-69.50	-57.00	-12.50	peak	1.9	229	V
870.499	-69.74	-0.40	-70.14	-57.00	-13.14	peak	1.8	225	CVC
B CB	4 6 C	60	CB.	High	Channel	4 4 B	60	R P R	B CB C
45.997	-60.86	-11.89	-72.75	-57.00	-15.75	peak	1.6	352	OHO
66.591	-60.52	-12.28	-72.80	-57.00	-15.80	peak	1.6	1 1	SH
104.058	-60.91	-12.34	-73.24	-57.00	-16.24	peak	1.9	204	H,
218.123	-62.43	-11.04	-73.47	-57.00	-16.47	peak	1.2	130	H
325.794	-61.63	-9.42	-71.04	-57.00	-14.04	peak	1.8	295	b .4
871.455	-68.92	-0.06	-68.98	-57.00	-11.98	peak	1.2	256	CHC
48.385	-60.88	-12.61	-73.48	-57.00	-16.48	peak	1.1	245) V
99.973	-60.75	-12.01	-72.76	-57.00	-15.76	peak	1.1	174	OVO
184.866	-62.53	-12.09	-74.62	-57.00	-17.62	peak	1.2	59	V
217.171	-61.01	-11.27	-72.29	-57.00	-15.29	peak	1.3	58	V
326.858	-59.50	-10.00	-69.50	-57.00	-12.50	peak	1.2	44	V
869.741	-70.04	-0.32	-70.36	-57.00	-13.36	peak	1.5	69	V

Remark

Absolute Level = Receiver Reading + Factor

Factor = Antenna Factor + Cable Loss - Pre-amplifier

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Above 1G:

Freq	Rd_level	Factor	Level	Limit	Over	detector	Height	Dograd	Antenna			
(MHz)	(dBm)	(dB)	(dBm)	(dBm)	(dB)	detector	Height	Degree	polarization			
4 4	Low Channel											
2248.45	-61.32	3.12	-58.20	-47.00	-11.20	peak	1.7	29	Н			
2248.82	-60.14	3.14	-57.00	-47.00	-10.00	peak	1.2	111	V			
D CLD	Cha Ch	CIT C	C. C. C. C.	High	Channel	the sta	SP S	D CAD	CAP CAP			
2443.41	-59.72	3.52	-56.20	-47.00	-9.20	peak	1.3	149	ØH Ø			
2443.70	-62.39	3.56	-58.83	-47.00	-11.83	peak	1.6	30	V			

Remark:

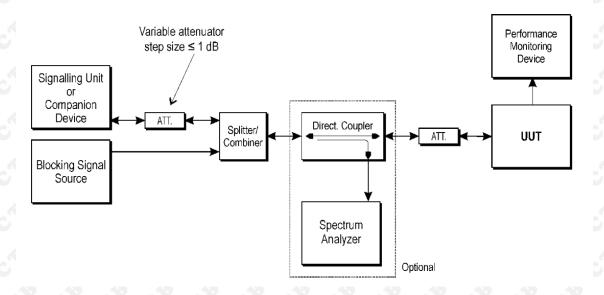
Absolute Level = Receiver Reading + Factor Factor = Antenna Factor + Cable Loss – Pre-amplifier

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13. RECEIVER BLOCKING

13.1 Block Diagram Of Test Setup



13.2 Limit

Table 14: Receiver Blocking parameters for Receiver Category 1 equipment

Wanted signal mean power from companion device (dBm) (see notes 1 and 4)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 4)	Type of blocking signal
(-133 dBm + 10 × log ₁₀ (OCBW)) or -68 dBm whichever is less (see note 2)	2 380 2 504		
(-139 dBm + 10 × log ₁₀ (OCBW)) or -74 dBm whichever is less (see note 3)	2 300 2 330 2 360 2 524 2 584 2 674	-34	CW

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P_{min} + 26 dB where P_{min} is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P_{min} + 20 dB where P_{min} is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 4: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

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Table 15: Receiver Blocking parameters receiver Category 2 equipment

Wanted signal mean power from companion device (dBm) (see notes 1 and 3)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 3)	Type of blocking signal
(-139 dBm + 10 × log ₁₀ (OCBW) + 10 dB) or (-74 dBm + 10 dB) whichever is less (see note 2)	2 380 2 504 2 300 2 584	-34	CW

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P_{min} + 26 dB where P_{min} is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

Table 16: Receiver Blocking parameters receiver Category 3 equipment

Wanted signal mean power from companion device (dBm) (see notes 1 and 3)	Blocking signal frequency	Blocking signal power (dBm)	Type of blocking signal
(See Hotes Fund 5)	(MHz)	(see note 3)	
(-139 dBm + 10 × log ₁₀ (OCBW) + 20 dB)	2 380		
or (-74 dBm + 20 dB) whichever is less	2 504	-34	CW
(see note 2)	2 300 2 584		

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P_{min} + 30 dB where P_{min} is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

13.3 Test procedure

Refer to ETSI EN 300 328 V2.2.2 (2020-07) Clause 5.4.11.2

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13.4 Test Result

Receiver Category 3					
Transmitting	Measured PER(%)	Limit (%)			
2402	-58	Frequency(MHz) 2380	Power(dB)	0.37	10
2402	-58	2504	-34	0.26	10
2402	-58	2300	-34	0.21	10
2402	-58	2584	-34	0.55	10
2441	-58	2380	-34	0.29	10
2441	-58	2504	-34	0.68	10
2441	-58	2300	-34	0.40	10
2441	-58	2584	-34	0.60	10
2480	-58	2380	-34	0.56	10
2480	-58	2504	-34	0.65	10
2480	-58	2300	-34	0.66	10
2480	-58	2584	-34	0.54	10
		s the worst case tes		4	. 4

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14. EUT PHOTOGRAPHS

Refer to Report No.: CTB220608002REX for EUT external and internal photos.

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15. EUT TEST SETUP PHOTOGRAPHS

Spurious emissions



******* END OF REPORT ******

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TEST REPORT

Product Name: Smart Watch

Trademark: N/A

Model Number:

SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7, S8, S9,

Report No.: CTB220607005RHX

S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S, T32S, T34S,

T45S, T60, T66, T11, T68, T69, T90, TW26, TW27, E86, E87, E88, E89,

E80, E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900, E88pro, E88mini, F100, F12, F100, F18, F45, F60, F11, F12, F28, F80,

M6, M5, M4S, X5

Prepared For: Shenzhen Xiangmingda Technology Co., Ltd.

Address: 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial Zone),

Huangbu Community, Hangcheng Street, Baoan District, Shenzhen

Manufacturer: Shenzhen Xiangmingda Technology Co., Ltd.

Address: 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial Zone),

Huangbu Community, Hangcheng Street, Baoan District, Shenzhen

Prepared By: Shenzhen CTB Testing Technology Co., Ltd.

Address: Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Community, Xinqiao

Street, Baoan District, Shenzhen, Guangdong China

Sample Received Date: Apr. 31, 2022

Sample tested Date: Apr. 31, 2022 to Jun. 08, 2022

Issue Date: Jun. 08, 2022

Report No.: CTB220607005RHX

EN 62479:2010

Test Standards EN 50663:2017

Test Results PASS

Chan Zhan

Remark: This is RED health test report.

Compiled by: Reviewed by: Approved by:

Arron Itu

Chen Zheng Arron Liu

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3.1 Limits	
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1. VERSION

Report No.	Issue Date	Description	Approved
CTB220607005RHX	Jun. 8, 2022	Original	Valid

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2. GENERAL INFORMATION

2.1 Product Information

Model(s):

SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7,

Report No.: CTB220607005RHX

S8, S9, S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S,

T32S, T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27,

E86, E87, E88, E89, E80, E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900, E88pro, E88mini, F100, F12, F100, F18,

F45, F60, F11, F12, F28, F80, M6, M5, M4S, X5

All the model are the same circuit and RF module, only for model Model Description:

name. Test sample model: SW/29

Bluetooth Version: Bluetooth V5.0

Hardware Version: V1.0 Software Version: V1.0

Bluetooth: 2402-2480MHz **Operation Frequency:**

Max. RF output power: Bluetooth: -1.48dBm

Bluetooth: GFSK Type of Modulation: Antenna installation: Internal antenna

Antenna Gain: 1.0dBi

Ratings: DC 5V charging from adapter

Battery DC 3.7V

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3. Health Requirements

3.1 Limits

According to Council Recommendation: the criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation.

Reference levels for electric, magnetic and electromagnetic fields (10MHz to 300GHz) Low-power electronic and electrical equipment is deemed to comply with the provisions of this standard if it can be demonstrated using routes B, C or D that the available antenna power and/or the average total radiated power is less than or equal to the applicable low-power exclusion level Pmax.

Annex A contains example values for Pmax derived from existing exposure limits listed in the bibliography, such as the ICNIRP guidelines [1], IEEE Std C95.1-1999 [2], and IEEE Std C95.1-2005 [3].

For wireless devices operated close to a person's body with available antenna powers and/or average total radiated powers higher than the Pmax values given in Annex A, the alternative Pmax values (called Pmax'), described in Annex B can also be used.

For low power equipment using pulsed signals, other limits may apply in addition to those considered in Annex A and Annex B. Both ICNIRP guidelines [1] and IEEE standards [2], [3] have specific restrictions on exposures to pulsed fields, and the requirements of those standards with respect to exposure to pulses shall be met. Annex C discusses this topic further.

Exposure tier	Region of body	Exclusion level Pmax
General public	Head and trunk	20mW(13dBm)
General public	Limbs	40mW(16dBm)

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3.2 Exposure Evaluation

Mode	The worst e.i.r.p. (dBm)	Pmax(dBn)	Result
Bluetooth Classic	-0.48	13	PASS

Remark:

- 1,refer to RF test report for e.i.r.p.
- 2, After performed the test at low/middle/high channel, the record is the worst.

******** END OF REPORT *******

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TEST REPORT

Product Name: Smart Watch

Trademark: N/A

Model Number:

SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7, S8, S9,

S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S, T32S, T34S,

T45S, T60, T66, T11, T68, T69, T90, TW26, TW27, E86, E87, E88, E89,

E80, E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900,

E88pro, E88mini, F100, F12, F100, F18, F45, F60, F11, F12, F28, F80,

M6, M5, M4S, X5

Prepared For: Shenzhen Xiangmingda Technology Co., Ltd.

Address: 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial Zone),

Huangbu Community, Hangcheng Street, Baoan District, Shenzhen

Manufacturer: Shenzhen Xiangmingda Technology Co., Ltd.

Address: 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial Zone),

Huangbu Community, Hangcheng Street, Baoan District, Shenzhen

Prepared By: Shenzhen CTB Testing Technology Co., Ltd.

Address: Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Community,

Xingiao Street, Baoan District, Shenzhen, Guangdong China

Sample

Received Date: Apr. 31, 2022

Sample tested

Date: Apr. 31, 2022 to Jun. 08, 2022

Issue Date: Jun. 08, 2022

Report No.: CTB220608002REX

Test Standards ETSI EN 301 489-1 V2.2.3 (2019-11)

ETSI EN 301 489-17 V3.2.4(2020-09)

Test Results PASS

Remark: This is EMC test report.

Compiled by: Reviewed by: Approved by:

Arron Itu

Chen Zheng Arron Liu

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Bin Mei / Director

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(NIC	OTE: N/A MEANS NOT ADDITIONED	

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CTB220608002REX	Jun. 8, 2022	Original	Valid

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2. TEST SUMMARY

The Product has been tested according to the following specifications:

	EMISSION				
Standard	Test Item	Test result			
EN 55032	Conducted emissions from the AC mains power ports	Pass			
EN 55032	Asymmetric mode conducted emissions	N/A ¹			
EN 55032	Conducted differential voltage emissions	N/A ²			
EN 55032	Radiated emissions	Pass			
EN 61000-3-2	Harmonic current emission(H)	Pass			
EN 61000-3-3	Voltage fluctuations & flicker(F)	Pass			

IMMUNITY					
Standard	Standard Test Item				
IEC 61000-4-2	Electrostatic discharge (ESD)	Pass			
IEC 61000-4-3	Continuous RF electromagnetic field disturbances(RS)	Pass			
IEC 61000-4-4	Electrical fast transients/burst (EFT)	Pass			
IEC 61000-4-5	Surges	Pass			
IEC 61000-4-6	Radio frequency, common mode	Pass			
IEC 61000-4-11	Voltage dips and interruptions (DIPS)	Pass			

Remark:

- 1. Applicable to ports listed above and intended to connect to cables longer than 3 m.
- 2. The Product has no antenna port.
- 3. The Product belongs to Class A, and its power is less than 75W, so it deems to fulfil this standard without testing.
- 4. The EUT is powered by the DC battery nly and has no antenna port, the test item is not applicable.

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3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Report No.: CTB220608002REX

Test item	Value (dB)
Conducted Emission (150KHz-30MHz)	3.2
Radiated Emission(30MHz ~1000MHz)	4.8
Radiated Emission(1GHz ~6GHz)	4.9

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4. PRODUCT INFORMATION AND TEST SETUP

4.1 Product Information

SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7, S8,

\$9, \$10, T40, T42, T41, T41\$, T42\$, T43, T33\$, T30, T46\$, T32\$,

Model(s): T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27, E86, E87, E88, E89, E80, E66, E10, E90, E98, E200, E400, E500, E510, E600,

E800, E900, E88pro, E88mini, F100, F12, F100, F18, F45, F60, F11,

F12, F28, F80, M6, M5, M4S, X5

Model Description:

All the model are the same circuit and RF module, only for model

name. Test sample model: SW/29

Bluetooth Version: Bluetooth V5.0

Hardware Version: V1.0
Software Version: V1.0

Operation Frequency: Bluetooth: 2402-2480MHz

Max. RF output power: Bluetooth: -1.48dBm

Type of Modulation: Bluetooth: GFSK

Antenna installation: Internal antenna

Antenna Gain: 1.0dBi

Ratings: DC 5V charging from adapter

Battery DC 3.7V

4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

Item	Equipment	Mfr/Brand	Model/TypeNo.	SeriesNo.	Note
C.S.S	AC adapter	SHENZHEN ENGINE ELECTRONIC CO.,LTD	EE-0501000E	N/A	AE

Notes:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

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4.4 Test Mode

Test item	Test Mode	Test Voltage
Conducted emissions from the AC mains power ports (150KHz-30MHz) Class B	Charging	AC 230V/50Hz
Dadiated a viscia as (2014), 2014, 2014	Charging	AC 230V/50Hz
Radiated emissions(30MHz-6GHz)Class B	BT Linking	DC 3.7V
Electrostatic discharge (ESD) Air Discharge: ±2,4,8kV	Charging	AC 230V/50Hz
	BT Linking	DC 3.7V
Continuous RF electromagnetic field	Charging	AC 230V/50Hz
disturbances(RS) ⊠80MHz-6000MHz , 3V/m,80%	BT Linking	DC 3.7V

All test mode were tested and passed, only Conducted Emissions, Radiated Emissions Harmonic Current Emissions and Voltage Fluctuations and Flicker shows (1)sthe worst case mode which were recorded in this report.

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5. TEST FACILITY AND TEST INSTRUMENT USED

5.1 Test Facility

All measurement facilities used to collect the measurement data are located at Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Street, Baoan District, Shenzhen China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

Report No.: CTB220608002REX

5.2 Test Instrument Used

	Continuous disturbance						
No.	Equipment	Manufacturer	Manufacturer Model No.		Calibrated until		
1	AMN	ROHDE&SCHWARZ	ESH3-Z5	831551852	2022.08.05		
2	Pulse limiter	ROHDE&SCHWARZ	ESH3Z2	357881052	2022.08.05		
3	EMI TEST RECEIVER	ROHDE&SCHWARZ	ESCS30	834115/006	2022.08.05		
4	Coaxial cable	ZDECL	Z302S	18091904	2022.08.05		
5	AAN	Schwarzbeck	NTFM8158	183	2022.08.05		
6	Communication test set	Agilent	E5515C	MY50102567	2022.08.16		
7	Communication test set	R&S	CMW500	108058	2022.08.05		
8	EZ-EMC	Frad	EMC-con3A1.1	070	0',0'		

	Radiated emission							
No.	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until			
1	Double Ridged Broadband Horn Antenna	Schwarzbeck	BBHA 9120D	1911	2022.08.08			
2	TRILOG Broadband Antenna	Schwarzbeck	VULB 9168	869	2022.08.05			
3	Amplifier	Agilent	8449B	3008A01838	2022.08.05			
4	Amplifier	HP	8447E	2945A02747	2022.08.05			
5	EMI TEST RECEIVER	ROHDE&SCHWARZ	ESPI7	100362	2022.08.05			
6	Coaxial cable	ETS	RFC-SNS-100- NMS-80 NI	\$ 18 S	2022.08.05			
7	Coaxial cable	ETS	RFC-SNS-100- NMS-20 NI	& /s	2022.08.05			
8	Coaxial cable	ETS	RFC-SNS-100- SMS-20 NI	c7 c	2022.08.05			
9	Coaxial cable	ETS	RFC-NNS-100 -NMS-300 NI		2022.08.05			
10	Communication test set	Agilent	E5515C	MY50102567	2022.08.16			
11	Communication test set	R&S	CMW500	108058	2022.08.05			
12	EZ-EMC	Frad	EMC-con3A1.1	\$ 18	9 19 18			

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Electrostatic discharges No. Equipment Manufacturer Model No. Serial No. Calibrated until 2022.08.05 **TESTQ** 1 **ESD Simulator NSG437** 329 E5515C Communication test set Agilent MY50102567 2022.08.16 2 3 Communication test set R&S CMW500 108058 2022.08.05

	Radio frequency electromagnetic field								
No.	Equipment	Manufacturer	Type No.	Serial No.	Calibrated until				
1	Signal Generator	Agilent	N5181A	2106070101	2022.08.05				
2	Stacked Double LogPer. Antenna	SKET	STLP 9129 Plus	2106070106	2022.08.05				
3	Switch Controller	SKET	RFSU-DC18G -4C	2106070105	2022.08.05				
4	RF Power Meter	Agilent	U2001	2106070102	2022.08.16				
5	E-Field Probe	Narda	EP-601	2106070107	2022.08.05				
6	Power Amplifier	SKET	HAP-80M01G- 250W	2106070103	2022.08.05				
7	Power Amplifier	SKET	HAP-01G 06G-75W	2106070104	2022.08.05				
8	Audio Analysis	R&S	UPV	2106070116	2022.08.16				
9	Audio Output Matching Network	SKET	RCO Network	2106070117	2022.08.16				
10	Communication test set	Agilent	E5515C	MY50102567	2022.08.16				
11	Communication test set	R&S	CMW500	108058	2022.08.05				
12	Test Sofiware	SKET	8 4 8	\$1.0	· 10				

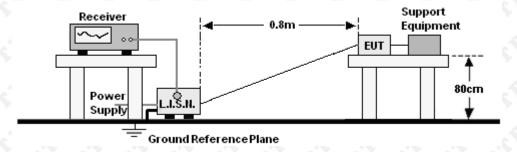
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Report No.: CTB220608002REX



6. CONDUCTED EMISSIONS

6.1 Block Diagram Of Test Setup



6.2 Limit

Limits for Conducted emissions at the mains ports of Class B MME

Frequency range	Limits dB(μV)	
(MHz)	Quasi-peak	Average
0,15 to 0,50	66 to 56*	56 to 46*
0,50 to 5	56	46
5 to 30	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

6.3 Test procedure

- a. The Product was placed on a nonconductive table 0.8m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).
- b. The RBW of the receiver was set at 9 kHz in150 kHz ~30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.

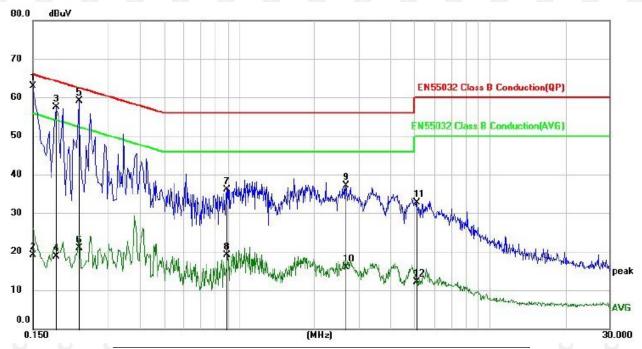
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6.4 Test Result

Temperature:	23 ℃	Relative Humidity:	54%
Pressure:	101kPa	Phase :	Lo 0 0 0
Test Mode	1(the worst data)	Remark:	N/A

Report No.: CTB220608002REX



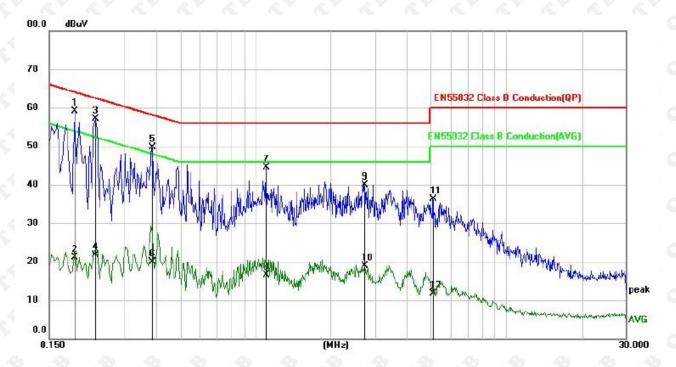
Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
*	0.1500	52.18	10.72	62.90	66.00	-3.10	QP	
	0.1500	8.32	10.72	19.04	56.00	-36.96	AVG	
	0.1860	46.74	10.70	57.44	64.21	-6.77	QP	
	0.1860	8.03	10.70	18.73	54.21	-35.48	AVG	
	0.2300	48.35	10.67	59.02	62.45	-3.43	QP	
	0.2300	10.25	10.67	20.92	52.45	-31.53	AVG	
	0.8900	25.47	10.60	36.07	56.00	-19.93	QP	
	0.8900	8.42	10.60	19.02	46.00	-26.98	AVG	
	2.6540	26.41	10.63	37.04	56.00	-18.96	QP	
	2.6540	5.24	10.63	15.87	46.00	-30.13	AVG	
	5.0980	22.14	10.65	32.79	60.00	-27.21	QP	
	5.0980	1.51	10.65	12.16	50.00	-37.84	AVG	
		* 0.1500 0.1500 0.1860 0.1860 0.2300 0.2300 0.8900 0.8900 2.6540 2.6540 5.0980	Mk. Freq. Level MHz dBuV * 0.1500 52.18 0.1500 8.32 0.1860 46.74 0.1860 8.03 0.2300 48.35 0.2300 10.25 0.8900 25.47 0.8900 8.42 2.6540 26.41 2.6540 5.24 5.0980 22.14	Mk. Freq. Level Factor MHz dBuV dB * 0.1500 52.18 10.72 0.1500 8.32 10.72 0.1860 46.74 10.70 0.1860 8.03 10.70 0.2300 48.35 10.67 0.2300 10.25 10.67 0.8900 25.47 10.60 2.6540 26.41 10.63 2.6540 5.24 10.63 5.0980 22.14 10.65	Mk. Freq. Level Factor ment MHz dBuV dB dBuV * 0.1500 52.18 10.72 62.90 0.1500 8.32 10.72 19.04 0.1860 46.74 10.70 57.44 0.1860 8.03 10.70 18.73 0.2300 48.35 10.67 59.02 0.2300 10.25 10.67 20.92 0.8900 25.47 10.60 36.07 0.8900 8.42 10.60 19.02 2.6540 26.41 10.63 37.04 2.6540 5.24 10.63 15.87 5.0980 22.14 10.65 32.79	Mk. Freq. Level Factor ment Limit MHz dBuV dB dBuV dBuV * 0.1500 52.18 10.72 62.90 66.00 0.1500 8.32 10.72 19.04 56.00 0.1860 46.74 10.70 57.44 64.21 0.2300 48.35 10.67 59.02 62.45 0.2300 10.25 10.67 20.92 52.45 0.8900 25.47 10.60 36.07 56.00 0.8900 8.42 10.60 19.02 46.00 2.6540 26.41 10.63 37.04 56.00 2.6540 5.24 10.63 15.87 46.00 5.0980 22.14 10.65 32.79 60.00	Mk. Freq. Level Factor ment Limit Margin MHz dBuV dB dBuV dBuV dB * 0.1500 52.18 10.72 62.90 66.00 -3.10 0.1500 8.32 10.72 19.04 56.00 -36.96 0.1860 46.74 10.70 57.44 64.21 -6.77 0.1860 8.03 10.70 18.73 54.21 -35[.48 0.2300 48.35 10.67 59.02 62.45 -3.43 0.2300 10.25 10.67 20.92 52.45 -31.53 0.8900 25.47 10.60 36.07 56.00 -19.93 0.8900 8.42 10.60 19.02 46.00 -26.98 2.6540 26.41 10.63 37.04 56.00 -18.96 2.6540 5.24 10.63 15.87 46.00 -30.13 5.0980 22.14 10.65 32.79 60	Mk. Freq. Level Factor ment Limit Margin MHz dBuV dB dBuV dBuV dB Detector * 0.1500 52.18 10.72 62.90 66.00 -3.10 QP 0.1500 8.32 10.72 19.04 56.00 -36.96 AVG 0.1860 46.74 10.70 57.44 64.21 -6.77 QP 0.1860 8.03 10.70 18.73 54.21 -35[.48 AVG 0.2300 48.35 10.67 59.02 62.45 -3.43 QP 0.2300 10.25 10.67 20.92 52.45 -31.53 AVG 0.8900 25.47 10.60 36.07 56.00 -19.93 QP 0.8900 8.42 10.60 19.02 46.00 -26.98 AVG 2.6540 26.41 10.63 37.04 56.00 -18.96 QP 2.6540 5.24 <

Remark: Result=Reading +Factor Over Limit=Result –Limit

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Temperature:	23 ℃	Relative Humidity:	54%
Pressure:	101kPa	Phase :	N S
Test Mode	1(the worst data)	Remark:	N/A



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	*	0.1900	48.34	10.70	59.04	64.04	-5.00	QP	
2		0.1900	10.34	10.70	21.04	54.04	-33.00	AVG	
3		0.2300	46.53	10.67	57.20	62.45	-5.25	QP	
4		0.2300	10.95	10.67	21.62	52.45	-30.83	AVG	
5		0.3860	39.13	10.59	49.72	58.15	-8.43	QP	
6		0.3860	9.40	10.59	19.99	48.15	-28.16	AVG	
7		1.1019	33.96	10.62	44.58	56.00	-11.42	QP	
8		1.1019	5.83	10.62	16.45	46.00	-29.55	AVG	
9		2.7139	29.31	10.63	39.94	56.00	-16.06	QP	
10		2.7139	8.29	10.63	18.92	46.00	-27.08	AVG	
11		5.1100	25.58	10.65	36.23	60.00	-23.77	QP	
12		5.1100	1.01	10.65	11.66	50.00	-38.34	AVG	
_									

Remark: Result=Reading +Factor Over Limit=Result –Limit

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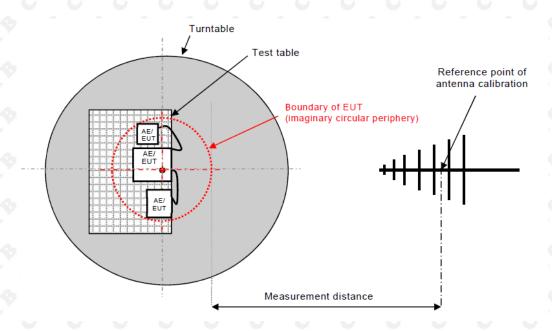
Report No.: CTB220608002REX



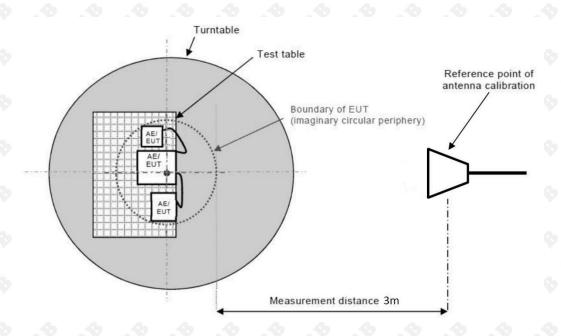
7. RADIATEDEMISSIONS TEST

7.1 Block Diagram Of Test Setup

30MHz ~ 1GHz:



Above 1GHz:



7.2 Limits

Limits for radiated disturbance of Class B MME

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Shenzhen CTB Testing Technology Co., Ltd.

	Frequency (MHz)	Quasi-peak limits at 3m dB(μV/m)
	30-230	40
8	230-1000	47

Frequency (GHz)	limit above 1G at 3m dB(μV/m)		
	Average	peak	
. 1-3	50	70	
3-6	54	74	

Note: The lower limit shall apply at the transition frequencies.

7.3 Test Procedure

30MHz ~ 1GHz:

- a. The Product was placed on the nonconductive turntable 0.8mabove the ground in a semi anechoic chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz:

- a. The Product was placed on the non-conductive turntable 0.8m above the ground in a full anechoic chamber..
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

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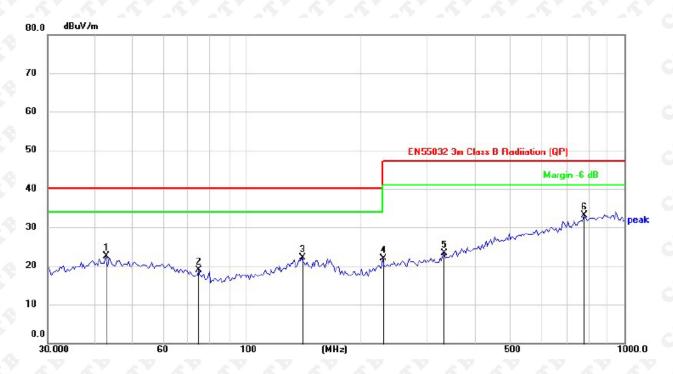


7.4 Test Results

Below 1GHz

Temperature:	23 ℃	Relative Humidity:	54%
Pressure:	101kPa	Polarization :	Horizontal
Test Mode	1(the worst data)	Remark:	N/A

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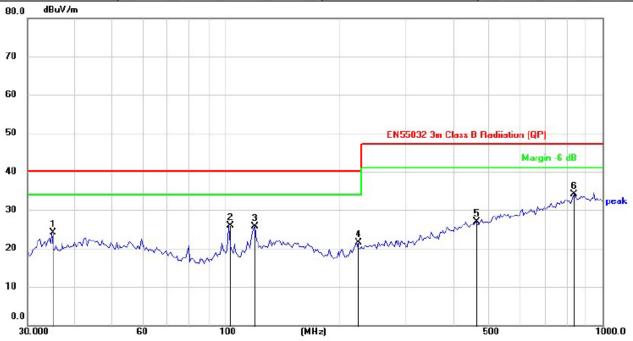


No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
4		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
1		42.6000	27.87	-5.37	22.50	40.00	-17.50	QP
2		75.3142	27.81	-8.90	18.91	40.00	-21.09	QP
3		140.3421	27.50	-5.44	22.06	40.00	-17.94	QP
4		229.2931	27.95	-5.95	22.00	40.00	-18.00	QP
5		334.2722	27.23	-4.01	23.22	47.00	-23.78	QP
6	*	782.3453	27.40	5.67	33.07	47.00	-13.93	QP

Remark: Result=Reading +Factor Over Limit=Result -Limit

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Temperature:	23 ℃	Relative Humidity:	54%
Pressure:	101kPa	Polarization :	Vertical
Test Mode	1(the worst data)	Remark:	N/A



No.	Mk.	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
1		34.8212	30.58	-6.52	24.06	40.00	-15.94	QP
2		102.3597	34.41	-8.49	25.92	40.00	-14.08	QP
3		119.8556	32.66	-6.91	25.75	40.00	-14.25	QP
4		223.3415	27.88	-6.42	21.46	40.00	-18.54	QP
5		462.3455	27.12	-0.19	26.93	47.00	-20.07	QP
6	*	839.1818	27.96	6.10	34.06	47.00	-12.94	QP

Remark: Result=Reading +Factor Over Limit=Result -Limit

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Above 1GHz

Temperature:	23 ℃	Relative Humidity:	54%
Pressure:	101kPa	Polarization :	Horizontal
Test Mode	1(the worst data)	Remark:	N/A

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Det.
1	1967.90	45.92	1.43	47.35	70.00	-22.65	peak
2	1967.72	27.62	1.43	29.05	50.00	-20.95	AVG
3	3774.92	43.81	5.76	49.57	74.00	-24.43	peak
4	3777.28	26.55	5.76	32.30	54.00	-21.70	AVG
5	4839.30	42.52	9.60	52.12	74.00	-21.88	peak
6	4843.54	24.84	9.60	34.43	54.00	-19.57	AVG

Remark: Result=Reading +Factor
Over Limit=Result -Limit

Temperature:	23 ℃	Relative Humidity:	54%
Pressure:	101kPa	Polarization :	Vertical
Test Mode	1(the worst data)	Remark:	N/A

No	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Det.
1	1995.06	47.31	1.51	48.81	70.00	-21.19	peak
2	1994.31	29.85	1.51	31.36	50.00	-18.64	AVG
3	3807.35	47.02	5.88	52.90	74.00	-21.10	peak
4	3810.06	28.99	5.88	34.87	54.00	-19.13	AVG
5	4771.94	45.31	9.36	54.67	74.00	-19.33	peak
6	4770.61	27.52	9.36	36.87	54.00	-17.13	AVG

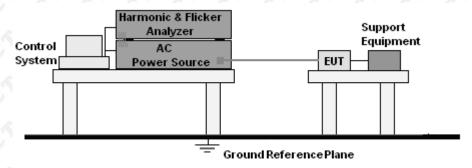
Remark: Result=Reading +Factor
Over Limit=Result -Limit

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8. HARMONIC CURRENT EMISSION(H)

8.1 Block Diagram of Test Setup



8.2 Limit

EN IEC 61000-3-2:2019 Clause 7.

8.3 Test Procedure

- a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from Product was chosen. The measure time shall be not less than the time necessary for the Product to be exercised.8.4

Test Results

Temperature:	23 °C	Relative Humidity:	54%
Pressure:	101kPa	Test Mode	1(the worst data)
Remark:	N/A	Test results	N/A

Remark: No limits apply for equipment with an active input power up to and including 75W.

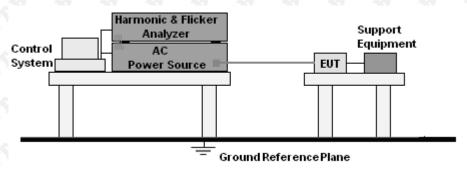
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9. VOLTAGE FLUCTUATIONS &FLICKER(F)

9.1 Block Diagram of Test Setup



9.2 Limit

EN 61000-3-3:2013/A1:2019 Clause 5.

9.3 Test Procedure

- a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick test, the measure time shall include that part of whole operation cycle in which the Product produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

9.4 Test Results

Temperature:	23 °C	Relative Humidity:	54%
Pressure:	101kPa	Test Mode	1(the worst data)
Remark:	N/A	Test results	Pass

Remark: Due to the maximum r.m.s input current (including inrush current) does not exceed 20A, and the supply current after inrush in within a variation band of 1.5A, it's not applicable to test the manual switching.

Since the EUT is working in steady state with very low supply current, it will not cause any fluctuations and flicker on the supply system. Considering this, no flicker and voltage fluctuation test had been performed on the EUT, and the EUT can be deemed to comply with the standard accordingly without testing.

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10. IMMUNITY TEST OF GENERAL THE PERFORMANCE CRITERIA

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Product Standard	ETSI EN 301 489-1				
	eria are used to take a decision on whether a radio equipment				
passes or fails immur					
	e present document two categories of performance criteria apply:				
	for continuous phenomena. for transient phenomena.				
	performance criteria depends upon the type of radio equipment				
and/or its intended ap	oplication. Thus, the present document only contains general commonly used for the assessment of radio equipment.				
6 6 6 6	During the test, the equipment shall:				
C C C C	•continue to operate as intended;				
Performance criteria for continuous	•not unintentionally transmit;				
phenomena	•not unintentionally change its operating state;				
C'TY C'TY C'TY	•not unintentionally change critical stored data.				
Ch Ch Ch	For all ports and transient phenomena with the exception described below, the following applies:				
crocrocro	•The application of the transient phenomena shall not result in a change of the mode of operation (e.g. unintended transmission) or the loss of critical stored data.				
CLA CLA CLA	•After application of the transient phenomena, the equipment shall operate as intended.				
Performance criteria	For surges applied to symmetrically operated wired network ports intended to be connected directly to outdoor lines the following criteria applies:				
for transient	For products with only one symmetrical port intended for				
phenomena	connection to outdoor lines, loss of function is allowed, provided the function is self-recoverable, or can be otherwise restored. Information stored in non-volatile memory, or protected by a battery				
	backup, shall not be lost.				
	•For products with more than one symmetrical port intended for connection to outdoor lines, loss of function on the port under test is allowed, provided the function is self-recoverable. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.				

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According To EN 301489 -17standard, The General Performance Criteria As Following:

General performance criteria

The performance criteria are:

- performance criteria A for immunity tests with phenomena of a continuous nature;
- performance criteria B for immunity tests with phenomena of a transient nature;
- performance criteria C for immunity tests with power interruptions exceeding a certain time.

The equipment shall meet the minimum performance criteria as specified in the following clauses.

Table 1: Performance criteria

Criteria	During the test	After test (i.e. as a result of the application of the test)
CAN CAN	Shall operate as intended. (see note). Shall be no loss of function. Shall be no unintentional transmissions.	Shall operate as intended. Shall be no degradation of performance. Shall be no loss of function. Shall be no loss of critical stored data.
C B TO	May be loss of function.	Functions shall be self-recoverable. Shall operate as intended after recovering. Shall be no loss of critical stored data.
C T T C T T	May be loss of function.	Functions shall be recoverable by the operator. Shall operate as intended after recovering. Shall be no loss of critical stored data.

NOTE: Operate as intended during the test allows a level of degradation in accordance with clause 6.2.2.

Minimum performance level

For equipment that supports a PER or FER, the minimum performance level shall be a PER or FER less than or equal to $10\,\%$.

For equipment that does not support a PER or a FER, the minimum performance level shall be no loss of the wirelesstransmission function needed for the intended use of the equipment.

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Performance criteria for Continuous phenomena applied to Transmitters (CT)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage Theperformance criteria A shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does notoccur. In systems using acknowledgement signals, it is recognized that an ACKnowledgement (ACK) or NotACKnowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Transient phenomena applied to Transmitters (TT)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 msduration, for which performance criteria C shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does notoccur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) ornot-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmissionresulting from the application of the test is correctly interpreted.

Performance criteria for Continuous phenomena applied toReceivers (CR)

The performance criteria A shall apply.

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. Insystems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and stepsshould be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Transient phenomena applied toReceivers (TR)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 msdurationfor which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. Insystems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

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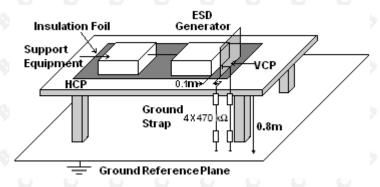
11. ELECTROSTATIC DISCHARGE (ESD)

11.1 Test Specification

Test Port : Enclosure port
Discharge Impedance : 330 ohm / 150 pF
Discharge Mode : Single Discharge

Discharge Period : one second between each discharge

11.2 Block Diagram of Test Setup



11.3 Test Procedure

- a. Electrostatic discharges were applied only to those points and surfaces of the Product that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selectedpoints in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the Product.
- e. Contact discharges were applied to the non-insulating coating, with the pointedtip of the generator penetrating the coating and contacting the conductingsubstrate.
- f. Air discharges were applied with the round discharge tip of the dischargeelectrode approaching the Product as fast as possible (without causing mechanicaldamage) to touch the Product. After each discharge, the ESD generator was removed from the Product and re-triggered for a new single discharge. The testwas repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the Product. The ESDgenerator was positioned vertically at a distance of 0.1 meters from the Productwith the discharge electrode touching the HCP.

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h. At least ten single discharges (in the most sensitive polarity) were applied to thecenter of one vertical edge of the Vertical Coupling Plane in sufficiently differentpositions that the four faces of the Product were completely illuminated. The VCP(dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the Product.

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11.4 Test Results

Temperature :	23℃	Relative Humidity:	54%
Pressure :	101kPa	Test Mode :	Mode1, Mode2

Discharg e Method	Discharge Position	Voltage (±kV)	Min. No. of Discharge per polarity (Each Point)	PerformanceCriterion
Contact Discharge	Conductive Surfaces	4	10	, A
	Indirect Discharge HCP	4 4	10	A A
	Indirect Discharge VCP	4	10	A A
	Slots, Apertures, and Insulating Surfaces	8	10	A A

Note: A: No performance degradation during test.

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B: During the test, the EUT shut down, after the test, it reset by itself.

C: During the test, the EUT shut down, after the test, it reset by user.



12. CONTINUOUS RF ELECTROMAGNETIC FIELD DISTURBANCES(RS)

12.1 Test Specification

Test Port : Enclosure port

Step Size : 1%

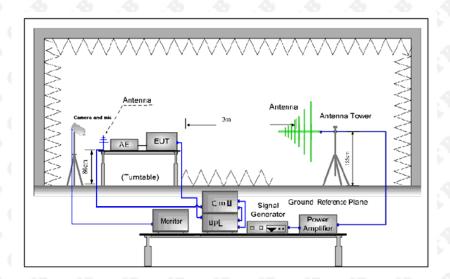
Modulation : 1kHz, 80% AM

Dwell Time : 1 second

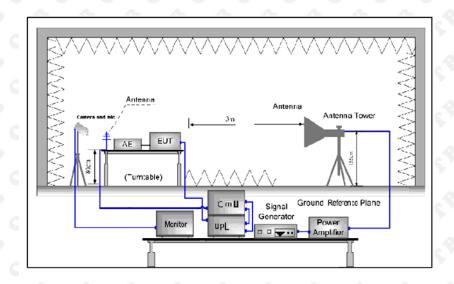
Polarization : Horizontal & Vertical

12.2 Block Diagram of Test Setup

Below 1GHz:



Above 1GHz:



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12.3 TestProcedure

a. The testing was performed in a fully-anechoic chamber. The transmit antenna was located at a distance of 3 meters from the Product.

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- b. The frequency range is swept from 80MHz to 6000MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave, and the step size was 1%.
- c. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to be able to respond, but should not exceed 5 s at each of the frequencies during the scan.
- d. The test was performed with the Product exposed to both vertically and horizontally polarized fields on each of the four sides.
- e. For Broadcast reception function: Group 2 not apply in this test.

12.4 Test Results

Temperature :	23℃	Relative Humidity:	54%
Pressure :	101kPa	Test Mode :	Mode1, Mode2

Frequency	Position	Field Strength (V/m)	PerformanceCriterion
	S. C. S. C.	Cr Cr Cr	
80 - 6000MHz	Front, Right, Back, Left	3	A
0 0	0 0 0	0 0 0	0 0 0 0

Note: A: No performance degradation during test.

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13. ELECTRICAL FAST TRANSIENTS/BURST (EFT)

13.1 Test Specification

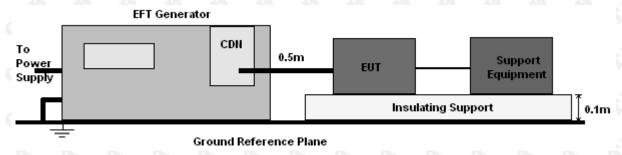
Test Port : input a.c. power port

Impulse Frequency: 5 kHzImpulse Wave-shape: 5/50 nsBurst Duration: 15 msBurst Period: 300 ms

Test Duration : 2 minutes per polarity

13.2 Block Diagram of EUT Test Setup

For input a.c.power port:



13.3 Test Procedure

- a. The Product and support units were located on a non-conductive table above ground reference plane.
- b. A 0.5m-long power cord was attached to Product during the test.

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13.4 Test Results

N/A

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14. SURGES IMMUNITY TEST

14.1 Test Specification

Test Port : input a.c. power port

Wave-Shape : Open Circuit Voltage - 1.2 / 50 us

Short Circuit Current - 8 / 20 us

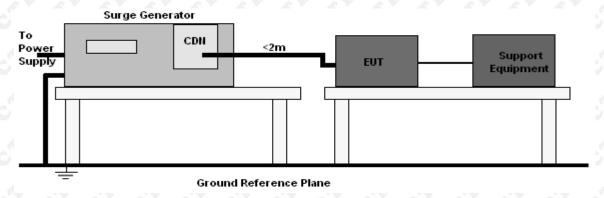
Report No.: CTB220608002REX

Pulse Repetition Rate : 1 pulse / min.

Phase Angle : 0° / 90° / 180° / 270°

Test Events: 5 pulses (positive & negative) for each polarity

14.2 Block Diagram of EUT Test Setup



14.3 Test Procedure

- a. The surge is to be applied to the Product power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave.
- b. The power cord between the Product and the coupling/decoupling networks shall be 2 meters in length (or shorter). Interconnection line between the Product and the coupling/decoupling networks shall be 2 meters in length (or shorter).

14.4 Test Result

N/A

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15. CONTINUOUS INDUCED RF DISTURBANCES (CS)

15.1 Test Specification

Test Port : input a.c.power port

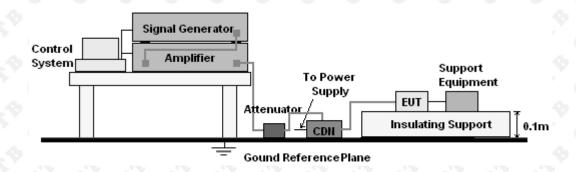
Step Size : 1%

Modulation : 1kHz, 80% AM

Dwell Time : 1 second

15.2 Block Diagram of EUT Test Setup

For input a.c. power port:



15.3 Test Procedure

For input a.c.power port:

- a. The Product and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- b. The frequency range is swept from 150 kHz to 10MHz, 10MHz to 30MHz, 30MHz to 80MHz with the signal 80% amplitude modulated with a 1 kHz sine wave, and the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the Product to be able to respond.

15.4 Test Result

N/A

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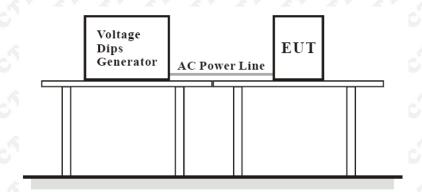
16. VOLTAGE DIPS AND INTERRUPTIONS (DIPS)

16.1 Test Specification

Test Port : input a.c. power port

Phase Angle : 0°, 180° Test cycle : 3 times

16.2 Block Diagram of EUT Test Setup



16.3 Test Procedure

- a. The Product and support units were located on a non-conductive table above ground floor.
- b. Set the parameter of tests and then perform the test software of test simulator.
- c. Conditions changes to occur at 0 degree crossover point of the voltage waveform.

16.4 Test Result

N/A

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Report No.: CTB220608002REX



17. **EUT PHOTOGRAPHS**

External Photos EUT Photo 1



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EUT Photo 3

EUT Photo 4

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EUT Photo 5

EUT Photo 6

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Internal photos EUT Photo 1

EUT Photo 2

EUT Photo 3

EUT Photo 4

EUT Photo 5

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18. EUT TEST SETUP PHOTOGRAPHS

Conducted emissions



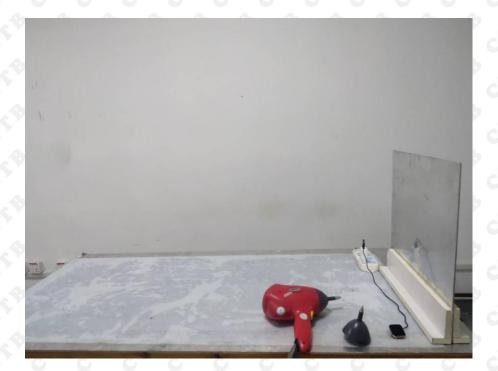
Radiated emissions below 1G



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ESD



RS



**** END OF REPORT ***

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CERTIFICATE OF CONFORMITY

EU - The Radio Equipment Directive (RED) -

No.: CTB220608002REX-ZS

Applicant: Shenzhen Xiangmingda Technology Co., Ltd.

Address : 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial Zone),

Huangbu Community, Hangcheng Street, Baoan District, Shenzhen

Manufacturer : Shenzhen Xiangmingda Technology Co., Ltd.

Address : 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial Zone),

Huangbu Community, Hangcheng Street, Baoan District, Shenzhen

Product : Smart Watch

Trade Name : N/A

Model(s)

: SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7, S8, S9, S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S, T32S, T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27, E86, E87, E88, E89, E80, E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900,

E88pro, E88mini, F100, F12, F100, F18, F45, F60, F11, F12, F28, F80,

M6, M5, M4S, X5

The tests that base on the above designated product Complies with the essential requirements of Directive 2014/53/EU relating to Electrical Equipment designed for use within Radio and telecommunications terminal equipment.

The test results apply only to the particular sample tested and the applicative tests carried out. The CE markings as shown below can be affixed on product after manufacturer carry out all stipulation activities integrally of above mentioned Regulation (Directive) and preparation of necessary technical documentation as well as the conformity declaration.

This statement is based on a single evaluation of sample of above mentioned product. It does not imply an assessment of the whole production process.

Other relevant Regulation (Directive) requirement have to be observed.





Jun. 23, 2022



Shenzhen CTB Testing Technology Co., Ltd

Add: Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Community, Xinqiao Street, Baoan District, Shenzhen, Guangdong, China.

Web: http://www.ctb-lab.net Tel: 4008-707-283 Email: ctb@ctb-lab.net



CERTIFICATE OF CONFORMITY

EU - The Radio Equipment Directive (RED) -

No.: CTB220608002REX-ZS

Category	Test Standards	Test Report No.
Health and Safety	EN IEC 62368-1:2020+A11:2020	CTB220622011RSX
(Article 3.1a)	EN 62479:2010 EN 50663:2017	CTB220607005RHX
EMC (Article	ETSI EN 301 489-1 V2.2.3 (2019-11)	CTD220600002DEV
(Article 3.1b)	ETSI EN 301 489-17 V3.2.4(2020-09)	CTB220608002REX
Radio Aspects (Article 3.2)	ETSI EN 300 328 V2.2.2 (2019-07)	CTB220606026RFX CTB220609003RFX

The tests that base on the above designated product Complies with the essential requirements of Directive 2014/53/EU relating to Electrical Equipment designed for use within Radio and telecommunications terminal equipment.

The test results apply only to the particular sample tested and the applicative tests carried out. The CE markings as shown below can be affixed on product after manufacturer carry out all stipulation activities integrally of above mentioned Regulation (Directive) and preparation of necessary technical documentation as well as the conformity declaration.

This statement is based on a single evaluation of sample of above mentioned product. It does not imply an assessment of the whole production process.

Other relevant Regulation (Directive) requirement have to be observed.





Jun. 23, 2022



Add: Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Community, Xinqiao Street, Baoan District, Shenzhen, Guangdong, China.



TEST REPORT

Product Name: Smart Watch

Trademark: N/A

Model Number:

SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7,

Report No.: CTB220609003RFX

S8, S9, S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S,

T32S, T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27,

E86, E87, E88, E89, E80, E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900, E88pro, E88mini, F100, F12, F100, F18,

F45, F60, F11, F12, F28, F80, M6, M5, M4S, X5

Prepared For: Shenzhen Xiangmingda Technology Co., Ltd.

8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial

Address: Zone), Huangbu Community, Hangcheng Street, Baoan District,

Shenzhen

Manufacturer: Shenzhen Xiangmingda Technology Co., Ltd

8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial

Address: Zone), Huangbu Community, Hangcheng Street, Baoan District,

Shenzhen

Prepared By: Shenzhen CTB Testing Technology Co., Ltd.

Address: Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Community,

Xinqiao Street, Baoan District, Shenzhen, Guangdong China

Sample Received Date: May. 31, 2022

Sample tested Date: May.31, 2022 to Jun. 09, 2022

Issue Date: Jun. 09, 2022

Report No.: CTB220609003RFX

Test Standards ETSI EN 300 328 V2.2.2 (2019-07)

Test Results PASS

Chen Wha

Remark: This is Bluetooth radio test report.

Compiled by: Reviewed by:

Chen Zheng Arron Liu

Approved by:

Bin Mei / Director

G TEC

The test report is effective only with both signature and specialized stamp. This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen CTB Testing Technology Co., Ltd. this report can't be reproduced except in full. The tested sample(s) and the sample information are provided by the client.

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Arron Itu

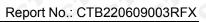




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(Note: N/A means not applicable)



1. VERSION

Report No.	Issue Date	Description	Approved
CTB220609003RFX	Jun. 09, 2022	Original	Valid

Report No.: CTB220609003RFX

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TEST SUMMARY

The Product has been tested according to the following specifications:

Standard	ETSI EN 300 328 V2.2.2				
Test Item	Test Requirement	Test Method	Results		
Transmitter Parameters	0,0,0,0		5 6 6		
RF Output Power	Clause 4.3.1.2	Clause 5.4.2	PASS		
Power Spectral Density	Clause 4.3.2.3	Clause 5.4.3	N/A ¹		
Duty cycle, Tx-Sequence, Tx-gap	Clause 4.3.1.3	Clause 5.4.2	N/A ²		
Accumulated Transmit time, Frequency Occupation & Hopping Sequence	Clause 4.3.1.4	Clause 5.4.4	PASS		
Hopping Frequency Separation	Clause 4.3.1.5	Clause 5.4.5	PASS		
Medium Utilization	Clause 4.3.1.6	Clause 5.4.2	N/A ²		
Adaptivity	Clause 4.3.1.7	Clause 5.4.6	N/A ³		
Occupied Channel Bandwidth	Clause 4.3.1.8	Clause 5.4.7	PASS		
Transmitter unwanted emissions in the OOB domain	Clause 4.3.1.9	Clause 5.4.8	PASS		
Transmitter unwanted emissions in the spurious domain	Clause 4.3.1.10	Clause 5.4.9	PASS		
Receiver Parameters					
Receiver spurious emissions	Clause 4.3.1.11	Clause 5.4.10	PASS		
Receiver Blocking	Clause 4.3.1.12	Clause 5.4.11	PASS		
Geo-location capability	Clause 4.3.1.13	Clause 5.4.12	N/A ⁴		

Remark:

N/A1: Only for equipment using wide band modulations other than FHSS

N/A²: Only for non-Adaptive equipment.

N/A³:The maximum ouput power of EUT less than 10dBm, so not applicable

N/A⁴: Only for equipment with geo-location capability

Tx: In this whole report Tx (or tx) means Transmitter.

Rx: In this whole report Rx (or rx) means Receiver.

RF: In this whole report RF means Radiated Frequency.

CH:In this whole report CH means channel.

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3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Item	Uncertainty
Occupancy bandwidth	54.3kHz
Conducted output power Above 1G	0.9dB
Conducted output power below 1G	0.9dB
Power Spectral Density , Conduction	0.9dB
Conduction spurious emissions	2.0dB
Out of band emission	2.0dB
3m camber Radiated spurious emission(30MHz-1GHz)	4.6dB
3m chamber Radiated spurious emission(1GHz-18GHz)	5.1dB
3m chamber Radiated spurious emission(18GHz-40GHz)	3.4dB
Receiver Reference Sensitivity level	1.9dB
humidity uncertainty	5.5%
Temperature uncertainty	0.63℃
frequency	1×10-7

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4. PRODUCT INFORMATION AND TEST SETUP

4.1 Product Information

SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T, S7,

Report No.: CTB220609003RFX

S8, S9, S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S, T32S, T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27,

Model(s): E86, E87, E88, E89, E80, E66, E10, E90, E98, E200, E400, E500,

E510, E600, E800, E900, E88pro, E88mini, F100, F12, F100, F18,

F45, F60, F11, F12, F28, F80, M6, M5, M4S, X5

Model Description:

All the model are the same circuit and RF module, only for model

name. Test sample model: SW/29

Bluetooth Version: Bluetooth 5.0

Hardware Version: V1.0 Software Version: V1.0

Operation Frequency: Bluetooth: 2402-2480MHz

Max. RF output power: Bluetooth: 2.64dBm

Type of Modulation: Bluetooth: GFSK, $\pi/4$ DQPSK, 8DPSK

Antenna installation: Bluetooth: Internal antenna

Antenna Gain: Bluetooth: 1.0dBi

Ratings: DC 5V charging by adapter

DC 3.7V by battery

4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

Г						
	Item	Equipment	Mfr/Brand	Model/Type	Series	Note
	1	AC adapter	Shenzhen Xiangmingda Technology Co., Ltd.	EE-0501000E	N/A	AE

Notes:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

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Channel List

СН	Frequency (MHz)	СН	Frequency (MHz)	СН	Frequency (MHz)	СН	Frequency (MHz)
0	2402	19	2403	2	2404	3	2405
4	2406	5	2407	6	2408	7	2409
8	2410	9	2411	10	2412	11	2413
12	2414	13	2415	14	2416	15	2417
16	2418	17	2419	18	2420	19	2421
20	2422	21	2423	22	2424	23	2425
24	2426	25	2427	26	2428	27	2429
28	2430	29	2431	30	2432	31	2433
32	2434	33	2435	34	2436	35	2437
36	2438	37	2439	38 <	2440	39	2441
40	2442	41	2443	42	2444	43	2445
44	2446	45	2447	46	2448	47	2449
48	2450	49	2451	50	2452	51	2453
52	2454	53	2455	54	2456	55	2457
56	2458	57	2459	58	2460	59	2461
60	2462	61	2463	62	2464	63	2465
64	2466	65	2467	66	2468	67	2469
68	2470	69	2471	70	2472	71	2473
72	2474	73	2475	74	2476	75	2477
76	2478	77	2479	78	2480	79	0 0

Shenzhen CTB Testing Technology Co., Ltd.

Test Mode 4.5

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

Test mode	Low channel	Middle channel	High channel
Transmitting (GFSK/Π/4DQPSK/8DPSK)	2402MHz	2441MHz	2480MHz
Receiving (GFSK/Π/4DQPSK/8DPSK)	2402MHz	2441MHz	2480MHz

Test Environment

Humidity(%):	54
Atmospheric Pressure(kPa):	101
Normal Voltage(AC):	120V
Normal Temperature(°C)	23
Low Temperature(°C)	
High Temperature(°C)	40 0 0 0 0 0

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5. TEST FACILITY AND TEST INSTRUMENT USED

5.1 Test Facility

All measurement facilities used to collect the measurement data are located at Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Street, Baoan District, Shenzhen China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

5.2 Test Instrument Used

No.	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until	
1 .	Spectrum Analyzer	Agilent	N9020A	MY52090073	2022.08.05	
2	Power Sensor	Agilent	U2021XA	MY56120032	2022.08.05	
3	Power Sensor	Agilent	U2021XA	MY56120034	2022.08.05	
4	Communication test set	R&S	CMW500	108058	2022.08.05	
5	Spectrum Analyzer	R&S	FSP40	100550	2022.08.05	
6	Signal Generator	Agilent	N5181A	MY49060920	2022.08.16	
7	Signal Generator	Agilent	N5182A	MY47420195	2022.08.05	
8	Communication test set	Agilent	E5515C	MY50102567	2022.08.16	
9	band rejection filter	Shenxiang	MSF2400-2483. 5MS-1154	2018101500 1	2022.08.05	
10	band rejection filter	Shenxiang	MSF5150-5850 MS-1155	2018101500 1	2022.08.05	
11	band rejection filter	Xingbo	XBLBQ-DZA120	190821-1-1	2022.08.05	
12	BT&WI-FI Automatic test software	Micowave	MTS8310	Ver. 2.0.0.0	2022.08.05	
13	Rohde & Schwarz SFU Broadcast Test System	R&S	SFU	101017	2022.08.05	
14	Temperature humidity chamber	Hongjing	TH-80CH	DG-15174	2022.08.05	
15	234G Automatic test software	Micowave	MTS8200	Ver. 2.0.0.0	2022.08.05	
16	966 chamber	C.R.T.	966 Room	966	2024.08.11	
17	Receiver	R&S	ESPI	100362	2022.08.05	
18	Amplifier	HP	8447E	2945A02747	2022.08.05	
19	Amplifier	Agilent	8449B	3008A01838	2022.08.05	
20	TRILOG Broadband Antenna	Schwarzbeck	VULB 9163	869	2022.08.07	

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Shenzhen CTB Testing Technology Co., Ltd.

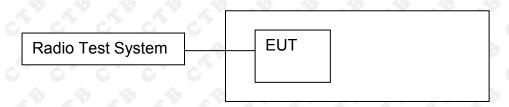
21	Horn Antenna	Schwarzbeck	BBHA9120D	1911	2022.08.08
22	Software	Fala	EZ-EMC	FA-03A2 RE	2022.08.05
23	3-Loop Antenna	Daze	ZN30401	17014	2022.08.05
24	loop antenna	ZHINAN	ZN30900A		2022.08.05
25	Horn antenna	A/H/System	SAS-574	588	2022.08.05
26	Amplifier	AEROFLEX	210	S/N/ 097	2022.08.05

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6. RF OUTPUT POWER

Block Diagram Of Test Setup



6.2 Limit

For adaptive equipment using wide band modulations other than FHSS, the maximum RF output power shall be 20 dBm.

The maximum RF output power for non-adaptive equipment shall be declared by the supplier and shall not exceed 20 dBm. See clause 5.3.1 m). For non-adaptive equipment using wide band modulations other than FHSS, the maximum RF output power shall be equal to or less than the value declared by the supplier.

This limit shall apply for any combination of power level and intended antenna assembly.

	Limit	
6	20dBm	67 67

Test procedure 6.3

Step 1:

- Use a fast power sensor suitable for 2.4 GHz and capable of minimum 1 MS/s.
- Use the following settings:
- Sample speed 1 MS/s or faster.
- The samples shall represent the RMS power of the signal.
- Measurement duration: For non-adaptive equipment: equal to the observation period defined in clause 4.3.1.3.2 or clause 4.3.2.4.2. For adaptive equipment, the measurement duration shall be long enough to ensure a minimum number of bursts (at least 10) are captured.

NOTE 1: For adaptive equipment, to increase the measurement accuracy, a higher number of bursts may be used.

Step 2:

- For conducted measurements on devices with one transmit chain:
- Connect the power sensor to the transmit port, sample the transmit signal and store the raw data. Use these stored samples in all following steps.
- For conducted measurements on devices with multiple transmit chains:
- Connect one power sensor to each transmit port for a synchronous measurement on all transmit ports.
- Trigger the power sensors so that they start sampling at the same time. Make sure the time difference between the samples of all sensors is less than 500 ns.
- For each individual sampling point (time domain), sum the coincident power samples

Web: http://www.ctb-lab.net



of all ports and store them. Use these summed samples in all following steps.

Step 3:

• Find the start and stop times of each burst in the stored measurement samples. The start and stop times are defined as the points where the power is at least 30 dB below the highest value of the stored samples in step 2.

NOTE 2: In case of insufficient dynamic range, the value of 30 dB may need to be reduced appropriately.

Step 4:

• Between the start and stop times of each individual burst calculate the RMS power over the burst using the formula below. Save these Pburst values, as well as the start and stop times for each burst.

$$P_{burst} = \frac{1}{k} \sum_{n=1}^{k} P_{sample}(n)$$

with 'k' being the total number of samples and 'n' the actual sample number

Step 5:

 The highest of all Pburst values (value "A" in dBm) will be used for maximum e.i.r.p. calculations.

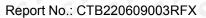
Step 6:

- · Add the (stated) antenna assembly gain "G" in dBi of the individual antenna.
- If applicable, add the additional beamforming gain "Y" in dB.
- If more than one antenna assembly is intended for this power setting, the maximum overall antenna gain (G or G + Y) shall be used.
- The RF Output Power (P) shall be calculated using the formula below:

$$P = A + G + Y$$

 This value, which shall comply with the limit given in clause 4.3.1.2.3 or clause 4.3.2.2.3, shall be recorded in the test report.

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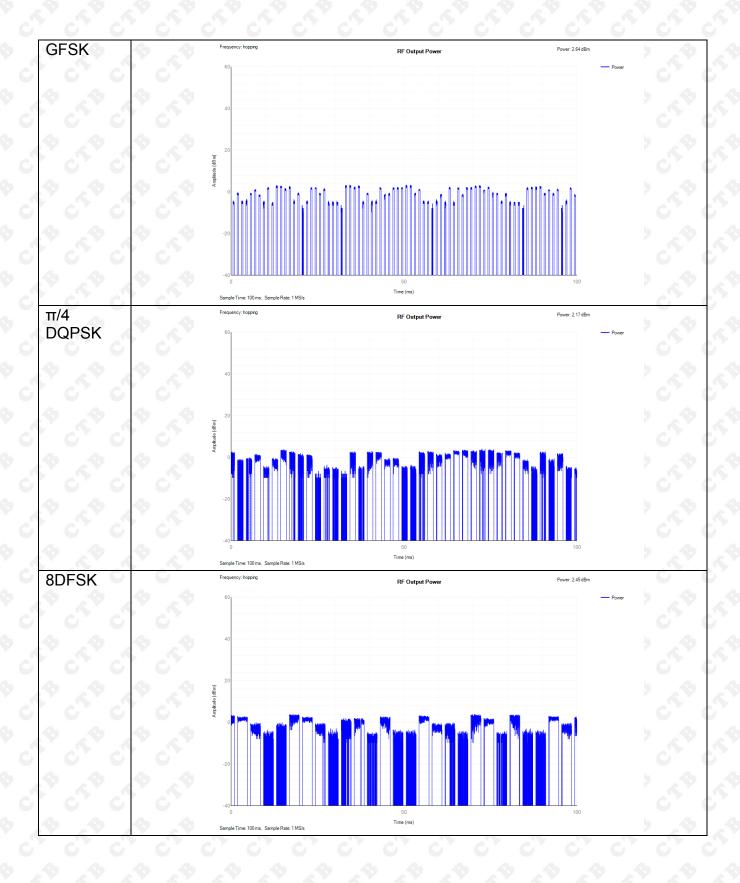
6.4 Test Result

Modulation	Test conditions	EIRP (dBm) Hopping mode	
Modulation	(Temperature)		
C C C	Normal	2.64	
GFSK	Lower	2.36	
67 67 6	Upper	2.16	
57 57	Normal	2.17	
π/4DQPSK	Lower	2.45	
C C C	Upper	-1.02	
10000	Normal	2.45	
8DPSK	Lower	2.21	
Cry Cry	Upper	2.75	
Limit	P P P P	≤100mW (20dBm)	

Remark: This Report only show the test plots of the worst case.

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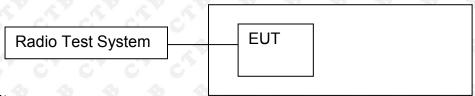






7. ACCUMULATED TRANSMIT TIME, MINIMUM FREQUENCY OCCUPATION AND HOPPING SEQUENCE

7.1 Block Diagram Of Test Setup



7.2 Limit

Adaptive Frequency Hopping equipment shall be capable of operating over a minimum of 70 % of the band specified in clause 1.

The Accumulated Transmit Time on any hopping frequency shall not be greater than 400 ms within any observation period of 400 ms multiplied by the minimum number of hopping frequencies (N) that have to be used. In order for the equipment to comply with the Frequency Occupation requirement, it shall meet either of the following two options:

Option 1: Each hopping frequency of the hopping sequence shall be occupied at least once within a period not exceeding four times the product of the dwell time and the number of hopping frequencies in use.

Option 2: The occupation probability for each frequency shall be between $((1 / U) \times 25 \%)$ and 77 % where U is the number of hopping frequencies in use.

The hopping sequence(s) shall contain at least N hopping frequencies at all times, where N is 15 or 15 divided by the minimum Hopping Frequency Separation in MHz, whichever is the greater.

7.3 Test procedure

Step 1:

- The output of the transmitter shall be connected to a spectrum analyzer or equivalent.
- The analyzer shall be set as follows:
- Centre Frequency: Equal to the hopping frequency being investigated
- Frequency Span: 0 Hz
- RBW: ~ 50 % of the Occupied Channel Bandwidth
- VBW: ≥ RBW
- Detector Mode: RMS
- Sweep time: Equal to the applicable observation period (see clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2)
- Number of sweep points: 30 000
- Trace mode: Clear / Write

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- Trigger: Free Run

Step 2:

• Save the trace data to a file for further analysis by a computing device using an appropriate software application or program.

Step 3:

 Identify the data points related to the frequency being investigated by applying a threshold.

The data points resulting from transmissions on the hopping frequency being investigated are assumed to have much higher levels compared to data points resulting from transmissions on adjacent hopping frequencies. If a clear determination between these transmissions is not possible, the RBW in step 1 shall be further reduced. In addition, a channel filter may be used.

• Count the number of data points identified as resulting from transmissions on the frequency being investigated and multiply this number by the time difference between two consecutive data points.

Step 4:

• The result in step 3 is the Accumulated Transmit Time which shall comply with the limit provided in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2 and which shall be recorded in the test report.

Step 5:

NOTE 1: This step is only applicable for equipment implementing Option 1 in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2 for complying with the Frequency Occupation requirement and the manufacturer decides to demonstrate compliance with this requirement via measurement.

Make the following changes on the analyser and repeat step 2 and step 3.

Sweep time: 4 × Dwell Time × Actual number of hopping frequencies in use

The hopping frequencies occupied by the equipment without having transmissions during the dwell time (blacklisted frequencies) should be taken into account in the actual number of hopping frequencies in use. If this number cannot be determined (number of blacklisted frequencies unknown) it shall be assumed that the equipment uses the maximum possible number of hopping frequencies.

• The result shall be compared to the limit for the Frequency Occupation defined in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2. The result of this comparison shall be recorded in the test report.

Step 6:

- Make the following changes on the analyzer:
- Start Frequency: 2 400 MHz
- Stop Frequency: 2 483,5 MHz
- RBW: ~ 50 % of the Occupied Channel Bandwidth (single hopping frequency)

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- VBW: ≥ RBW

- Detector Mode: RMS

- Sweep time: 1 s

- Trace Mode: Max Hold

- Trigger: Free Run

NOTE 2: The above sweep time setting may result in long measuring times. To avoid such long measuring times, an FFT analyser could be used.

- Wait for the trace to stabilize. Identify the number of hopping frequencies used by the hopping sequence.
- The result shall be compared to the limit (value N) defined in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2. This value shall be recorded in the test report.

For equipment with blacklisted frequencies, it might not be possible to verify the number of hopping frequencies in use. However they shall comply with the requirement for Accumulated Transmit Time and Frequency Occupation assuming the minimum number of hopping frequencies (N) defined in clause 4.3.1.4.3.1 or clause 4.3.1.4.3.2 is used.

Step 7:

• For adaptive equipment, using the lowest and highest -20 dB points from the total spectrum envelope obtained in step 6, it shall be verified whether the equipment uses 70 % of the band specified in clause 1. The result shall be recorded in the test report.

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7.4 Test Result

Accumulated Transmit Time

arriarate a rrarior				
Channel	Modulation	Accumulated Transmit Time (ms)	Limit (ms)	Result
	GFSK	120.263	400	Pass
LCH	π/4DQPSK	258.646	400	Pass
4.4.4	8DPSK	355.101	400	Pass
	GFSK	120.582	400	Pass
HCH	π/4DQPSK	250.461	400	Pass
	8DPSK	294.474	400	Pass

Minimum Frequency Occupation

mann i roquonoy	Cocapation			
Channel	Modulation	Occupied period	Limit	Result
CA CA CA	GFSK	2	CA CA CA	Pass
LCH	π/4DQPSK	0 40 0		Pass
	8DPSK	3	4≥X≥1	Pass
7 67 67	GFSK	2 6 1 6 ° C	4≥∧≥1	Pass
HCH	π/4DQPSK	4 4 4 A		Pass
	8DPSK	2		Pass

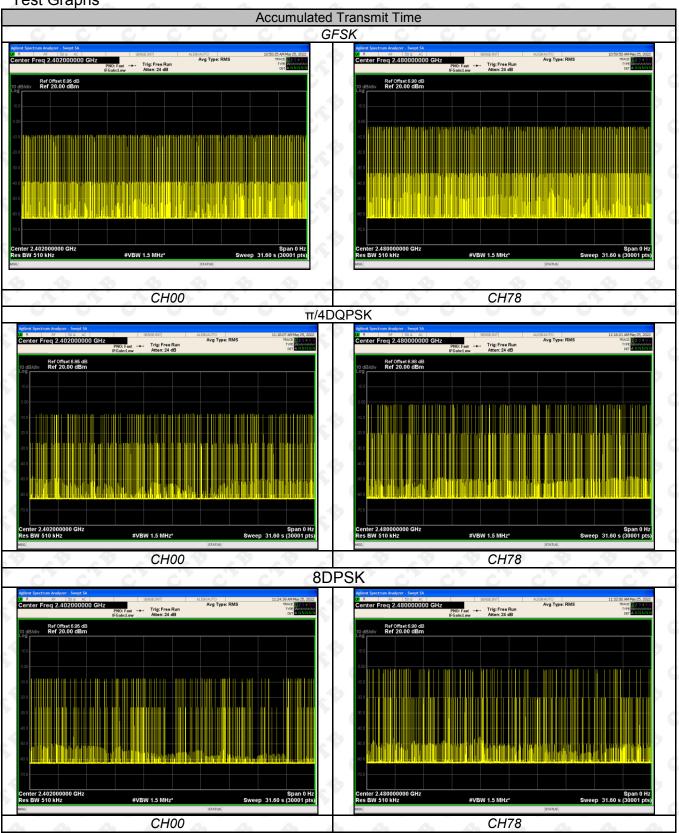
Hopping Sequence

pping ocque	1100					<u> </u>
Modulatio n	One pulse time (ms)	Number of Hopping Channel	Limit	-20 dB Bandwidth (%)	Limit	Result
GFSK	0.377	79	A VA	95.3	70 % of the	CA CA C
π/4DQPS K	1.637	79	≥15	95.7	band 2400MHz-2	Pass
8DPSK	2.887	79	67	95.8	483.5MHz	To to the

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Test Graphs



Hopping Sequence					
GFSK	π/4DQPSK				

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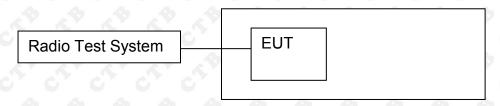


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8. HOPPING FREQUENCY SEPARATION

8.1 Block Diagram Of Test Setup



8.2 Limit

For Non-adaptive frequency hopping systems

The minimum Hopping Frequency Separation shall be equal to Occupied Channel Bandwidth (see clause 5.3.1.5.3) of a single hop, with a minimum separation of 100 kHz. For Adaptive frequency hopping systems

The minimum Hopping Frequency Separation shall be 100 kHz.

8.3 Test procedure

The Hopping Frequency Separation as defined in clause 4.3.1.5 shall be measured and recorded using any of the following options. The selected option shall be stated in the test report.

Option 1

Step 1:

- The output of the transmitter shall be connected to a spectrum analyser or equivalent.
- The analyser shall be set as follows:
- Centre Frequency: Centre of the two adjacent hopping frequencies
- Frequency Span: Sufficient to see the complete power envelope of both hopping frequencies
- RBW: 1 % of the span
- VBW: 3 × RBW
- Detector Mode: RMSTrace Mode: Max Hold
- Sweep time: 1 s

Step 2:

- Wait for the trace to stabilize.
- Use the marker function of the analyser to define the frequencies corresponding to the lower -20 dBr point and the upper -20 dBr point for both hopping frequencies F1 and F2. This will result in F1 $_{\text{L}}$ and F1 $_{\text{H}}$ for hopping frequency F1 and in F2 $_{\text{L}}$ and F2 $_{\text{H}}$ for hopping frequency F2. These values shall be recorded in the report.

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Step 3:

- Calculate the centre frequencies F1c and F2c for both hopping frequencies using the formulas below. These values shall be $F1_c = \frac{F1_L + F1_H}{2} \quad F2_c = \frac{F2_L + F2_H}{2}$
- Calculate the -20 dBr channel bandwidth (BW_{CHAN}) using the formula below. This value shall be recorded in the report.

 Calculate the Hopping Frequency Separation (FHS) using the formula below. This value shall be recorded in the report.

$$F_{HS} = F_{2c} - F_{1c}$$

• Compare the measured Hopping Frequency Separation with the limit defined in clause 4.3.1.5.3. In addition, for non-Adaptive Frequency Hopping equipment, the Hopping Frequency Separation shall be equal to or greater than Occupied Channel Bandwidth as defined in clause 4.3.1.8 or:

F_{HS} ≥ Occupied Channel Bandwidth

• See figure 4:

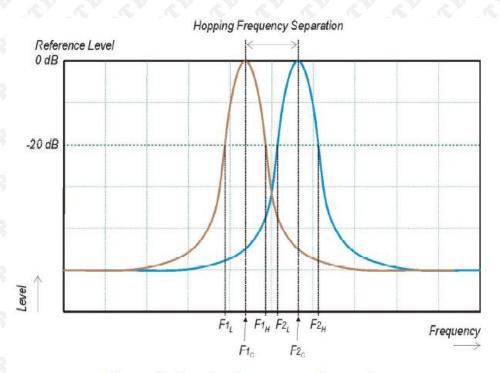


Figure 4: Hopping Frequency Separation

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For adaptive equipment, in case of overlapping channels which will prevent the definition of the -20 dBr reference points F1_H and F2_L, a higher reference level (e.g. -10 dBr or - 6 dBr) may be chosen to define the reference points F1_L; F1_H; F2_L and F2_H.

Alternatively, special test software may be used to:

- force the UUT to hop or transmit on a single Hopping Frequency by which the -20 dBr reference points can be measured separately for the two adjacent Hopping Frequencies; and/or
- force the UUT to operate without modulation by which the centre frequencies F1C and F2C can be measured directly.

The method used to measure the Hopping Frequency Separation shall be documented in the test report.

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8.4 Test Result

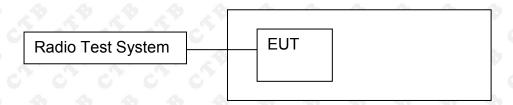
Mo	ode	Measurement (MHz)	Limit (MHz)	Result
CIT C	DH1	0.9982	0.1	CLB CLB CL
GFSK	DH3	0.9991	0.1	PASS
CTP C	DH5	1.0103	0.1	ord ord or

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9. OCCUPIED CHANNEL BANDWIDTH

9.1 Block Diagram Of Test Setup



9.2 Limit

The Occupied Channel Bandwidth shall fall completely within the band given in 2.4GHz to 2.4835GHz.

In addition, for non-adaptive systems using wide band modulations other than FHSS and with e.i.r.p greater than 10 dBm, the occupied channel bandwidth shall be less than 20 MHz.

9.3 Test procedure

Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

Centre Frequency: The centre frequency of the channel under test

Resolution BW: ~ 1 % of the span without going below 1 %

• Video BW: 3 × RBW

Frequency Span: 2 × Nominal Channel Bandwidth

Detector Mode: RMS

Trace Mode: Max Hold

Sweep time: 1 s

Step 2:

Wait for the trace to stabilize.

Find the peak value of the trace and place the analyser marker on this peak.

Step 3:

Use the 99 % bandwidth function of the spectrum analyser to measure the Occupied Channel Bandwidth of the UUT.

This value shall be recorded.

NOTE: Make sure that the power envelope is sufficiently above the noise floor of the analyser to avoid the noise signals left and right from the power envelope being taken into account by this measurement.

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9.4 Test Result

Modulation	Frequency (MHz)		icy Range IHz)	Occupied Channel (MHz)
OFOK DITA	Low	2402.001	c /c	0.859
GFSK DH1	High	4 182	2480.002	0.858
π/4-DQPSK	Low	2402.002	6 16	1.189
2DH3	High	29/29	2480.001	1.193
8DPSK	Low	2401.996	0 10	1.188
3DH5	High		2479.994	1.199

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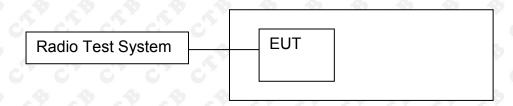






10. TRANSMITTER UNWANTED EMISSIONS IN THE OUT-OF-BAND DOMAIN

10.1 Block Diagram Of Test Setup



10.2 Limit

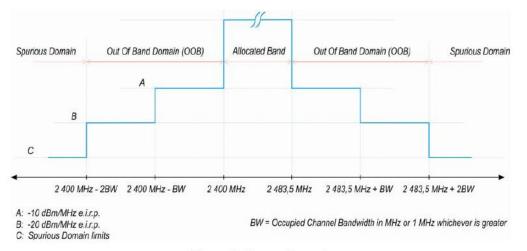


Figure 3: Transmit mask

10.3 Test procedure

The applicable mask is defined by the measurement results from the tests performed under clause 5.3.8 (Occupied Channel Bandwidth).

The test procedure is further as described under clause 5.3.9.2.1.

The Out-of-band emissions within the different horizontal segments of the mask provided in figures 1 and 3 shall be measured using the steps below. This method assumes the spectrum analyser is equipped with the Time Domain Power option.

Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

- Centre Frequency: 2 484 MHz

- Span: 0 Hz

- Resolution BW: 1 MHz

- Filter mode: Channel filter

- Video BW: 3 MHz

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Detector Mode: RMS

- Trace Mode: Max Hold

- Sweep Mode: Continuous

- Sweep Points: Sweep Time [s] / (1 µs) or 5 000 whichever is greater

- Trigger Mode: Video trigger

NOTE 1: In case video triggering is not possible, an external trigger source may be used.

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- Sweep Time: > 120 % of the duration of the longest burst detected during the measurement of the RF Output Power

Step 2 (segment 2 483,5 MHz to 2 483,5 MHz + BW):

- Adjust the trigger level to select the transmissions with the highest power level.
- For frequency hopping equipment operating in a normal hopping mode, the different hops will result in signal bursts with different power levels. In this case the burst with the highest power level shall be selected.
- Set a window (start and stop lines) to match with the start and end of the burst and in which the RMS power shall be measured using the Time Domain Power function.
- Select RMS power to be measured within the selected window and note the result which is the RMS power within this 1 MHz segment (2 483,5 MHz to 2 484,5 MHz). Compare this value with the applicable limit provided by the mask.
- Increase the centre frequency in steps of 1 MHz and repeat this measurement for every 1 MHz segment within the range 2 483,5 MHz to 2 483,5 MHz + BW. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + BW 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 3 (segment 2 483,5 MHz + BW to 2 483,5 MHz + 2BW):

• Change the centre frequency of the analyser to 2 484 MHz + BW and perform the measurement for the first 1 MHz segment within range 2 483,5 MHz + BW to 2 483,5 MHz + 2BW. Increase the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + 2 BW - 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 4 (segment 2 400 MHz - BW to 2 400 MHz):

• Change the centre frequency of the analyser to 2 399,5 MHz and perform the measurement for the first 1 MHz segment within range 2 400 MHz - BW to 2 400 MHz Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - BW + 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

Step 5 (segment 2 400 MHz - 2BW to 2 400 MHz - BW):

 Change the centre frequency of the analyser to 2 399,5 MHz - BW and perform the measurement for the first 1 MHz segment within range 2 400 MHz - 2BW to 2 400 MHz -BW. Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover

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this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - 2BW + 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

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Step 6:

• In case of conducted measurements on equipment with a single transmit chain, the declared antenna assembly gain "G" in dBi shall be added to the results for each of the 1 MHz segments and compared with the limits

provided by the mask given in figure 1 or figure 3. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered.

- In case of conducted measurements on smart antenna systems (equipment with multiple transmit chains), the measurements need to be repeated for each of the active transmit chains. The declared antenna assembly gain "G" in dBi for a single antenna shall be added to these results. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered. Comparison with the applicable limits shall be done using any of the options given below:
- Option 1: the results for each of the transmit chains for the corresponding 1 MHz segments shall be added. The additional beamforming gain "Y" in dB shall be added as well and the resulting values compared with the limits provided by the mask given in figure 1 or figure 3.
- Option 2: the limits provided by the mask given in figure 1 or figure 3 shall be reduced by

10 × log10(Ach) and the additional beamforming gain "Y" in dB. The results for each of the transmit chains shall be individually compared with these reduced limits.

NOTE 2: Ach refers to the number of active transmit chains.

It shall be recorded whether the equipment complies with the mask provided in figure 1 or figure 3.

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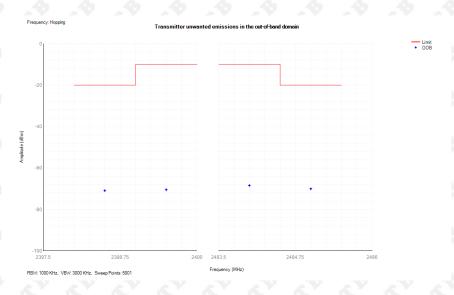




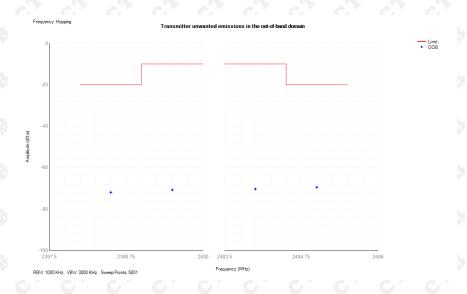
10.4 Test Result

Modulation : GFSK (the worst data)

Low Channel										
Test Freq (MHz) Antenna Freq(MHz) Level Limit										
2402 Antenna 1 2399.5 -70.45 -10										
2402										



High Channel											
Test Freq (MHz) Antenna Freq(MHz) Level Limit											
2480	Antenna 1	2484	-68.41	-10							
2480	Antenna 1	2485	-70.02	-20							

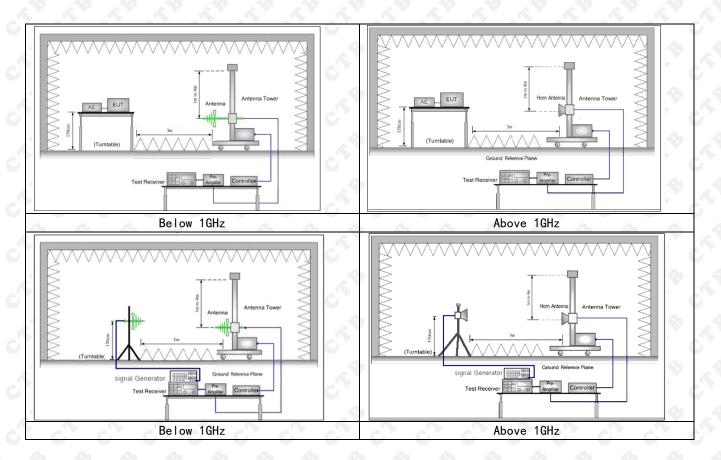


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TRANSMITTER UNWANTED EMISSIONS IN THE SPURIOUS DOMAIN

11.1 Block Diagram Of Test Setup



11.2 Limits

Maximum power,	
	RBW/VBW
e.i.r.p. (> 1 GHz)	
-36 dBm	100 kHz/300KHz
-54 dBm	100 kHz/300KHz
-36 dBm	100 kHz/300KHz
-54 dBm	100 kHz/300KHz
-36 dBm	100 kHz/300KHz
-54 dBm	100 kHz/300KHz
-36 dBm	100 kHz/300KHz
-54 dBm	100 kHz/300KHz
-36 dBm	100 kHz/300KHz
-30 dBm	1 MHz/3MHz
	e.r.p. (≤ 1 GHz) e.i.r.p. (> 1 GHz) -36 dBm -54 dBm -36 dBm -54 dBm -36 dBm -54 dBm -54 dBm -36 dBm -36 dBm -36 dBm

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11.3 Test Procedure

30MHz ~ 1GHz:

- a. The Product was placed on the nonconductive turntable 1.5m above the ground in a full anechoic chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz:

- a. The Product was placed on the non-conductive turntable 1.5 m above the ground in a full anechoic chamber..
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

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11.4 Test Results

Modulation: GFSK (the worst data)

Below 1GHz

Freq (MHz)	Rd_level (dBm)	Factor (dB)	Level (dBm)	Limit (dBm)	Over (dB)	detector	Height	Degree	Antenna polarization
4	0 0		0 0	Low	Channe	0 0	A A	0 0	400
46.460	-55.06	-12.51	-67.56	-36.00	-31.56	peak	1.5	311	А
66.772	-55.27	-11.81	-67.07	-54.00	-13.07	peak	1.2	217	ψ H _☉
104.707	-55.62	-12.05	-67.66	-54.00	-13.66	peak	1.4	308	Ĥ
219.215	-53.60	-10.74	-64.34	-54.00	-10.34	peak	1.6	286	♦ H♦
328.295	-53.45	-9.50	-62.95	-36.00	-26.95	peak	1.4	88	CH C
870.486	-52.46	-0.09	-52.55	-36.00	-16.55	peak	1.3	206	A HA
46.775	-55.10	-12.20	-67.31	-36.00	-31.31	peak	1.9	40	CVC
102.031	-54.61	-11.90	-66.51	-54.00	-12.51	peak	1.6	268	V
184.127	-56.06	-11.92	-67.98	-54.00	-13.98	peak	1.5	120	V
217.140	-53.61	-11.27	-64.88	-54.00	-10.88	peak	1.5	22	V
327.141	-52.81	-9.47	-62.28	-36.00	-26.28	peak	0 1.7	146	♦ V♦
870.187	-51.84	-0.57	-52.41	-36.00	-16.41	peak	1.7	326	CVC
P & P	A 40 A	B B	A P	High	Channe	1 C P C	B CB	40	P P
45.312	-54.87	-12.12	-66.99	-36.00	-30.99	peak	1.6	33	CH C
68.511	-54.65	-11.77	-66.42	-54.00	-12.42	peak	1.8	346	Н
105.015	-55.77	-11.82	-67.59	-54.00	-13.59	peak	1.4	130	H
216.928	-52.94	-11.18	-64.12	-54.00	-10.12	peak	1.8	132	Ĥ
326.097	-53.06	-10.09	-63.16	-36.00	-27.16	peak	1.4	33	◆ H◆
870.569	-51.91	-0.21	-52.12	-36.00	-16.12	peak	1.1	34	cH c
48.101	-54.82	-12.34	-67.16	-36.00	-31.16	peak	1.5	151	∨
100.103	-54.62	-12.46	-67.09	-54.00	-13.09	peak	1.7	149	CV C
182.451	-55.57	-11.75	-67.32	-54.00	-13.32	peak	1.5	195	V
218.602	-53.29	-11.26	-64.55	-54.00	-10.55	peak	1.2	312	V
326.439	-53.54	-10.01	-63.55	-36.00	-27.55	peak	1.5	143	V
872.093	-52.53	-0.49	-53.02	-36.00	-17.02	peak	1.8	252	V

Remark:

Absolute Level = Receiver Reading + Factor Factor = Antenna Factor + Cable Loss – Pre-amplifier

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Above 1GHz

Freq	Rd_level	Factor	Level	Limit	Over	detector	Height	Degree	Antenna
(MHz)	(dBm)	(dB)	(dBm)	(dBm)	(dB)	detector	rieigni	Degree	polarization
40	6 C	40	es es	Low	Channe		()	6 G	C' C'
4804	-54.29	8.41	-45.88	-30.00	-15.88	peak	1.5	267	н
7206	-53.02	12.55	-40.47	-30.00	-10.47	peak	1.2	67	H
4804	-54.73	8.41	-46.32	-30.00	-16.32	peak	1.1	322	V V
7206	-51.63	12.55	-39.08	-30.00	-9.08	peak	1.6	27	SV S
, P	\$ A	A P &	\$ _\$	High	Channe	*	5 P S	\$ A	7 4 7 4
4960	-54.43	8.51	-45.92	-30.00	-15.92	peak	1.0	102	C Al
7440	-52.85	12.69	-40.16	-30.00	-10.16	peak	1.8	17	Н
4960	-54.65	8.51	-46.14	-30.00	-16.14	peak	1.1	148	V
7440	-51.73	12.69	-39.04	-30.00	-9.04	peak	1.6	91	√° V√°

Remark:

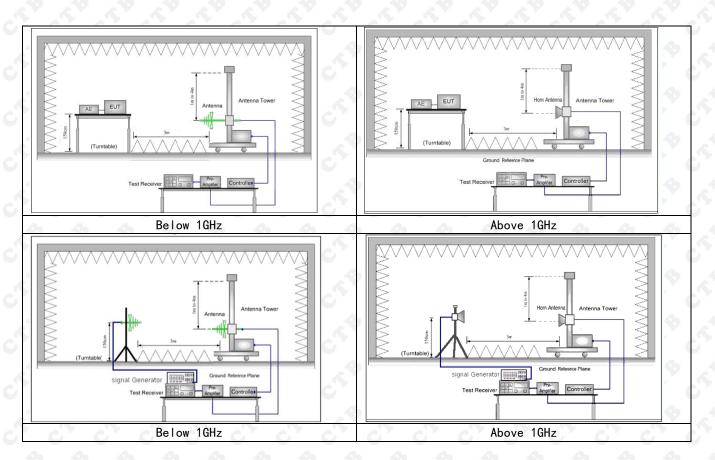
Absolute Level = Receiver Reading + Factor Factor = Antenna Factor + Cable Loss – Pre-amplifier

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11. RECEIVER SPURIOUS EMISSIONS

12.1 Block Diagram Of Test Setup



12.2 Limits

Frequency(MHz)	Limit
30-1000	-57dBm
1000-12750	-47dBm

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12.3 Test Procedure

30MHz ~ 1GHz:

- a. The Product was placed on the nonconductive turntable 1.5m above the ground in a full anechoic chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz:

- a. The Product was placed on the non-conductive turntable 1.5 m above the ground in a full anechoic chamber..
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

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Test Results 12.4

Modulation : GFSK (the worst data)

Below 1GHz

Freq (MHz)	Rd_level (dBm)	Factor (dB)	Level (dBm)	Limit (dBm)	Over (dB)	detector	Height	Degree	Antenna polarization
B TB	40 4	200	40	Low	Channel	1 TO 1	D VD	15	Co Co
45.887	-60.62	-12.37	-72.99	-57.00	-15.99	peak	1.7	321	Н
68.455	-60.68	-12.47	-73.15	-57.00	-16.15	peak	1.2	148	H
106.041	-60.58	-12.57	-73.14	-57.00	-16.14	peak	o 1.1 o	330	⇔ H⇔
218.594	-62.38	-10.53	-72.91	-57.00	-15.91	peak	1.5	44	H
325.696	-61.33	-9.56	-70.89	-57.00	-13.89	peak	1.3	253	♦ H♦
871.345	-69.37	-0.63	-70.00	-57.00	-13.00	peak	1.5	296	CH C
46.232	-60.17	-12.65	-72.82	-57.00	-15.82	peak	1.8	235	V
101.199	-61.50	-12.01	-73.51	-57.00	-16.51	peak	1.2	159	V
182.329	-61.99	-12.04	-74.03	-57.00	-17.03	peak	1.9	13	V
217.841	-60.46	-10.87	-71.33	-57.00	-14.33	peak	1.7	118	V
327.773	-59.03	-9.59	-68.61	-57.00	-11.61	peak	1.1	83	V
869.200	-70.27	-0.08	-70.35	-57.00	-13.35	peak	1.4	355	♦ V
C'	C C	C	c' c	High	Channe	ic' c'	6	C' C	6 6
46.027	-60.60	-11.89	-72.49	-57.00	-15.49	peak	1.4	108	A HA
66.770	-60.05	-12.14	-72.18	-57.00	-15.18	peak	1.7	173	CH C
105.993	-60.63	-12.04	-72.66	-57.00	-15.66	peak	1.6	128	H
219.530	-62.07	-10.56	-72.64	-57.00	-15.64	peak	1.8	324	A HA
325.949	-61.84	-10.03	-71.87	-57.00	-14.87	peak	1.8	66	Ĥ
870.807	-68.92	-0.10	-69.02	-57.00	-12.02	peak	1.6	54	♦ H♦
46.037	-60.43	-11.92	-72.35	-57.00	-15.35	peak	1.0	112	V
99.769	-61.34	-12.59	-73.93	-57.00	-16.93	peak	1.3	300	♦ V♦
184.020	-62.81	-12.12	-74.93	-57.00	-17.93	peak	1.9	328	CV
216.910	-61.04	-10.87	-71.90	-57.00	-14.90	peak	1.5	244	V
328.224	-59.12	-10.05	-69.17	-57.00	-12.17	peak	1.6	311	V
869.792	-70.06	-0.59	-70.65	-57.00	-13.65	peak	1.7	80	V

Remark:

Absolute Level = Receiver Reading + Factor Factor = Antenna Factor + Cable Loss – Pre-amplifier

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Above 1GHz

///		A 1000 A		478-					
Freq	Rd_level	Factor	Level	Limit	Over	detector	r Hoight	Height Degree	Antenna
(MHz)	(dBm)	(dB)	(dBm)	(dBm)	(dB)	detector	neignt	Degree	polarization
4 A	D CO	CP C	b Ab	Low	Channel	0 50	KB K	D AD	50 50
2248.49	-61.28	3.12	-58.16	-47.00	-11.16	peak	1.3	225	AH A
2248.78	-60.11	3.13	-56.98	-47.00	-9.98	peak	1.8	234	V
	C C	, 6,	C.	High	Channe	C C			
2443.43	-59.77	3.52	-56.25	-47.00	-9.25	peak	1.5	225	H
2443.66	-62.45	3.54	-58.91	-47.00	-11.91	peak	1.1	67	V

Remark:

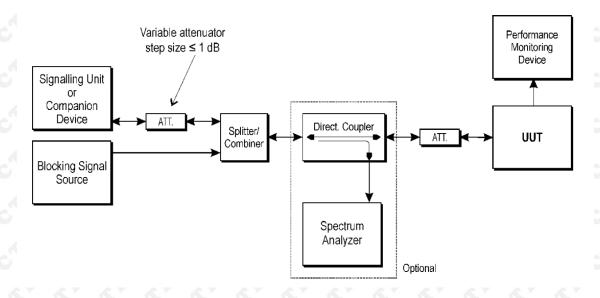
Absolute Level = Receiver Reading + Factor Factor = Antenna Factor + Cable Loss – Pre-amplifier

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12. RECEIVER BLOCKING

13.1 Block Diagram Of Test Setup



13.2 Limit

Table 14: Receiver Blocking parameters for Receiver Category 1 equipment

Wanted signal mean power from companion device (dBm) (see notes 1 and 4)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 4)	Type of blocking signal
(-133 dBm + 10 × log ₁₀ (OCBW)) or -68 dBm whichever is less (see note 2)	2 380 2 504		
(-139 dBm + 10 × log ₁₀ (OCBW)) or -74 dBm whichever is less (see note 3)	2 300 2 330 2 360 2 524 2 584 2 674	-34	CW

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P_{min} + 26 dB where P_{min} is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P_{min} + 20 dB where P_{min} is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 4: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

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Table 15: Receiver Blocking parameters receiver Category 2 equipment

Wanted signal mean power from companion device (dBm) (see notes 1 and 3)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 3)	Type of blocking signal
(-139 dBm + 10 × log ₁₀ (OCBW) + 10 dB) or (-74 dBm + 10 dB) whichever is less (see note 2)	2 380 2 504 2 300 2 584	-34	CW

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P_{min} + 26 dB where P_{min} is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

Table 16: Receiver Blocking parameters receiver Category 3 equipment

Wanted signal mean power from	Blocking	Blocking	Type of blocking
companion device (dBm) (see notes 1 and 3)	signal frequency	signal power (dBm)	signal
,	(MHz)	(see note 3)	
(-139 dBm + 10 × log ₁₀ (OCBW) + 20 dB)	2 380		
or (-74 dBm + 20 dB) whichever is less	2 504	-34	CW
(see note 2)	2 300		
,/	2 584		

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P_{min} + 30 dB where P_{min} is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

13.3 Test procedure

Refer to ETSI EN 300 328 V2.2.2 (2019-07) Clause 5.4.11.2.

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13.4 Test Result

Modulation : GFSK (the worst data)

Receiver Category 2							
GFSK	P _{min} (dBm)	Blocking	Blocking	Measured	Limit		
Transmitting	r min(dDill)	Frequency(MHz)	Power(dB)	PER(%)	(%)		
2402	-68	2380	-34	0.55	10		
2402	-68	2504	-34	0.62	10		
2402	-68	2300	-34	0.45	10		
2402	-68	2584	-34	0.46	10		
2441	-68	2380	-34	0.48	10		
2441	-68	2504	-34	0.25	10		
2441	-68	2300	-34	0.20	10		
2441	-68	2584	-34	0.37	10		
2480	-68	2380	-34	0.75	10		
2480	-68	2504	-34	0.39	10		
2480	-68	2300	-34	0.52	10		
2480	-68	2584	-34	0.20	10		

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13. EUT PHOTOGRAPHS

External Photos EUT Photo 1

EUT Photo 2

EUT Photo 3

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EUT Photo 5





EUT Photo 7

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Internal photos



EUT Photo 2

EUT Photo 3

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EUT Photo 5



EUT Photo 6

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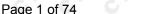
14. EUT TEST SETUP PHOTOGRAPHS

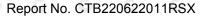
Spurious emissions



******** END OF REPORT *******

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TEST REPORT EN IEC 62368-1

Audio/video, information and communication technology equipment Part 1: Safety requirements

Report Number.....: CTB220622011RSX

Date of issue: June 23, 2022

Total number of pages: 74

Testing laboratory

Name: Shenzhen CTB Testing Technology Co., Ltd.

Address Floor 1&2, Building A, No. 26 of Xinhe Road, Xingiao Community,

Xinqiao Street, Baoan District, Shenzhen, Guangdong, China

Applicant's name.....: Shenzhen Xiangmingda Technology Co., Ltd.

Address 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial

Zone), Huangbu Community, Hangcheng Street, Baoan District,

Shenzhen

Test specification:

Standard: EN IEC 62368-1:2020+A11:2020

Test procedure.....: Safety report

Non-standard test method.....: N/A

TRF template used: IECEE OD-2020-F1:2020, Ed.1.3

Test Report Form No.....: IEC62368_1E

Test Report Form(s) Originator....: UL(US)

Master TRF: Dated 2021-02-04

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Note:

If there is any objection to the inspection results in this report, please submit a written report to the company within 15 days from the date of receiving the report. The test report is effective only with both signature and specialized stamp. This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen CTB Testing Technology Co., Ltd. this report can't be reproduced except in full. The tested sample(s) and the sample information are provided by the client. "*" indicates the testing items were fulfilled by subcontracted lab. "#" indicates the items are not in CNAS accreditation scope.



Report No. CTB220622011RSX



Test item

Test item description Smart Watch

Model/Type reference...... SW/29, T48, T49, T12, E300, S2, S2P, S3, S5, S6, S6P, S6T,

S7, S8, S9, S10, T40, T42, T41, T41S, T42S, T43, T33S, T30, T46S, T32S, T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27, E86, E87, E88, E89, E80, E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900, E88pro, E88mini, F100, F12, F100, F18, F45, F60, F11, F12, F28, F80, M6, M5, M4S, X5

Trade Mark(s): N/A

Manufacturer name Shenzhen Xiangmingda Technology Co., Ltd.

Zone), Huangbu Community, Hangcheng Street, Baoan District,

Shenzhen

Ratings...... 5V=== 1A



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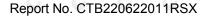
Report No. CTB220622011RSX

Test item particulars:		
Product group:		
Classification of use by:		
	Skilled person Skil	
Supply connection:	☐ AC mains ☐ DC mains	
	☐ not mains connected: (supplied by external power	
	supply)	
Complete Laborator		
Supply tolerance::	+10%/-10% +20%/-15%	
	+ %/- %	
	None √6	
Supply connection – type:	☐ pluggable equipment type A -	
	non-detachable supply cord	
	appliance coupler	
	☐ direct plug-in	
0, 0, 0, 0, 0, 0	pluggable equipment type B -	
PART PART PART	non-detachable supply cord	
	appliance coupler	
9 40 40 40 40 40 40	permanent connection	
	☐ mating connector ☐ other: supplied by direct plug-	
Considered current rating of protective	type external power supply ☐ 16 A;	
device:	Location:	
6, 6, 6, 6, 6, 6, 6	N/A □ Suitaing □ Squipment	
Equipment mobility:	☐ movable ☐ hand-held ☐ transportable	
	☐ direct plug-in ☐ stationary ☐ for building-in	
9 40 40 40 40 40 40	☐ wall/ceiling-mounted ☐ SRME/rack-mounted	
	other:	
Overvoltage category (OVC):		
	OVC IV other: not directly connect to AC	
Class of aguinment	mains ☐ Class I ☐ Class II ☐ Class III	
Class of equipment:	□ Not classified □	
Special installation location:	N/A □ restricted access area	
) 4) 4) 4) 4) 4) 4)	outdoor location	
Pollution degree (PD):	☐ PD 1 ☐ PD 2 ☐ PD 3	
Manufacturer's specified T _{ma} :	25 °C Outdoor: minimum °C	
IP protection class:	☐ IP	
Power systems:	☐ TN ☐ TT ☐ IT - V L-L	
Altitude during operation (m):	☐ Hot AC mains ☐ 2000 m or less ☐ m	
	<u>4</u> 4 4 4 4 4 4 4	
Altitude of test laboratory (m):		
Mass of equipment (kg):	0.04 kg	

Shenzhen CTB Testing Technology Co., Ltd.
Add:Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Street, Baoan District, Shenzhen, Guangdong, China
Tel: 4008-707-283 Web: http://www.ctb-lab.net Email: ctb@ctb-lab.

Email: ctb@ctb-lab.net







Possible test case verdicts:

- test case does not apply to the test object....: N/A(Not applicable)

- test object does meet the requirement....... P (Pass)

- test object does not meet the requirement....: F (Fail)

Testing:

Date of receipt of test item May 31, 2022

Date (s) of performance of tests May 31 - June 22, 2022

Laboratory sample number...... 220531006-1X

General remarks:

The test results presented in this report relate only to the object tested.

This report shall not be reproduced, except in full, without the written approval of the Issuing testing laboratory.

Laboratory CTB. The authenticity of this Test Report and its contents can be verified by contacting CTB, responsible for this Test Report.

"(See Enclosure #)" refers to additional information appended to the report.

"(See appended table)" refers to a table appended to the report.

Throughout this report a \square comma / \boxtimes point is used as the decimal separator.

General product information and other remarks:

-Instructions and equipment marking related to safety is applied in the language that is acceptable in the country in which the equipment is to be sold.

- -The product was submitted and tested for use at the ambient temperature (Tma) of 25 °C. for no declaration from manufacturer.
- -All test(s) were performed on model "SW/29" to represent other models also.
- -All models are identical except model name and appearance difference.





Copy of marking plate:

The artwork below may be only a draft.

Smart Watch Model: SW/29 Input: 5V=== 1A Shenzhen Xiangmingda Technology Co., Ltd. MADE IN CHINA

Remark for above marking:

- 1. The height of graphical symbols shall not be less than 5 mm;
- 2. The height of letters and numerals shall not be less than 2 mm;
- 3. The height dimension of CE mark should not less than 5mm, the height dimension of WEEE symbol should not less than 7mm.

Note: xxx means importer company name; yyy means importer company address information. Alternatively, Importer and importer address information provided in the instructions.

List of Attachments (including a total number of pages in each attachment):

ATTACHMENT NO.1: EN IEC 62368-1:2020+A11:2020. (NATIONAL DEVIATION).

ATTACHMENT NO. 2: PHOTO DOCUMENTATION.

Summary of testing:

The submitted sample were tested and found to compliance with requirements of the standards EN IEC 62368-1:2020+A11:2020.

Testing location

Laboratory name.....: Shenzhen CTB Testing Technology Co., Ltd.

Testing location/address : Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Community, Xinqiao

Street, Baoan District, Shenzhen, Guangdong, China.

Tested By : Aiden

(Test Engineer)

Reviewed By : Finerb Bai

(Supervisor)

Approved By : Kubo Lee

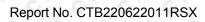
(Chief Engineer)

Shenzhen CTB Testing Technology Co., Ltd.

Add:Floor 1&2, Building A, No. 26 of Xinhe Road, Xinqiao Street, Baoan District,

Shenzhen, Guangdong, China

Tel: 4008-707-283 Web: http://www.ctb-lab.net Email: ctb@ctb-lab.net





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Clause	Possible Hazard				
5	Electrically-caused injury				
Class and Energy Source	Body Part		Safeguards	ds	
(e.g. ES3: Primary circuit)	(e.g. Ordinary)	В	S	R	
ES1: All internal circuit inside the enclosure	Ordinary	N/A	N/A	N/A	
6	Electrically-caused fire				
Class and Energy Source	Material part		Safeguards		
(e.g. PS2: 100 Watt circuit)	(e.g. Printed board)	В	1 st S	2 nd S	
PS3: All internal circuit inside the enclosure	Plastic enclosure	See 6.3	V-0 or better	N/A	
PS3: All internal circuit inside the enclosure	PCB	See 6.3	V-1 or better	N/A	
PS3: All internal circuit inside the enclosure	Internal/external wiring	N/A	N/A	See 6.5	
PS3: All internal circuit inside the enclosure	Other combustible components / materials	See 6.3	See 6.4.5, 6.4.6	N/A	
7	Injury caused by hazardous	substances			
Class and Energy Source	Body Part	Safeguards			
(e.g. Ozone)	e.g., Skilled) B	S	R		
Li-ion battery	Skilled	See Annex M	N/A	N/A	
8	Mechanically-caused injury				
Class and Energy Source	Body Part		Safeguards		
(e.g. MS3: Plastic fan blades)	(e.g. Ordinary)	В	S	R	
MS1: Equipment Mass	Ordinary	N/A	N/A	N/A	
MS1: Sharp edges and corners	Ordinary	N/A	N/A	N/A	
9	Thermal burn				
Class and Energy Source	Body Part		Safeguards		
(e.g. TS1: Keyboard caps)	(e.g., Ordinary)	В	S	R	
TS1: All accessible parts	Ordinary	N/A	N/A	N/A	
10	Radiation				
Class and Energy Source	Body Part		Safeguards		
(e.g. RS1: PMP sound output)	(e.g., Ordinary)	В	S	R	
RS1: LED indicator	Ordinary	N/A	N/A	N/A	

Shenzhen CTB Testing Technology Co., Ltd.
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Tel: 4008-707-283 Web: http://www.ctb-lab.net Email: ctb@ctb-lab.



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Report No. CTB220622011RSX

ENERGY SOURCE DIAGRAM

Optional. Manufacturers are to provide the energy sources diagram identify declared energy sources and identifying the demarcations are between power sources. Recommend diagram be provided included in power supply and multipart systems.

Insert diagram below. Example diagram designs are; Block diagrams; image(s) with layered data; mechanical drawings

Se	e above ta	able	
A 97		. V <u> </u>	

oxtimes es oxtimes ps oxtimes ms oxtimes ts oxtimes rs



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Report No. CTB220622011RSX

IEC 62368-1			B 4 B 6
Clause	Requirement + Test	Result - Remark	Verdict

4	GENERAL REQUIREMENTS		
4.1.1	Acceptance of materials, components and subassemblies	(See appended table 4.1.2)	P
4.1.2	Use of components	Components which are certified to IEC and/or national standards are used correctly within their ratings. Components not covered by IEC standards are tested under the conditions present in the equipment. See also Annex G	PC
4.1.3	Equipment design and construction	No accessible part which could cause injury. Also see sub-clause B.2, B.3 and B.4	P
4.1.4	Specified ambient temperature for outdoor use (°C)	Indoor used.	N/A
4.1.5	Constructions and components not specifically covered	go go go go	N/A
4.1.8	Liquids and liquid filled components (LFC)	(See G.15)	N/A
4.1.15	Markings and instructions	(See Annex F)	Р
4.4.3	Safeguard robustness	For adhesives securing parts (internal secondary wires) serving as safeguards, see Annex P.4. Others see below.	P
4.4.3.1	General	See below.	o P
4.4.3.2	Steady force tests	(See Clause T.3, T.4, T.5)	Р
4.4.3.3	Drop tests	(See Annex T.7)	ΦP
4.4.3.4	Impact tests	(See Annex T.6)	N/A
4.4.3.5	Internal accessible safeguard tests	No such part.	N/A
4.4.3.6	Glass impact tests		N/A
4.4.3.7	Glass fixation tests	No such glass.	N/A
0'	Glass impact test (1J)	0,0,0,0	N/A
C B	Push/pull test (10 N)	CO CO CO CO	N/A
4.4.3.8	Thermoplastic material tests	0,0,0,0	Р
4.4.3.9	Air comprising a safeguard	See Annex T	P
4.4.3.10	Accessibility, glass, safeguard effectiveness	All safeguards remain effective.	P





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	IEC 62368-1		
Clause	Requirement + Test	Result - Remark	Verdict
4.4.4	Displacement of a safeguard by an insulating liquid	P CF CF CF C	N/A
4.4.5	Safety interlocks	(See Annex K)	N/A
4.5	Explosion		Р
4.5.1	General	No explosion observed during normal / abnormal / single fault conditions.	P
4.5.2	No explosion during normal/abnormal operating condition	(See Clause B.2, B.3)	PS
A P	No harm by explosion during single fault conditions	(See Clause B.4)	₽ P
4.6	Fixing of conductors	. 0, 0, 0, 0	Р
P P	Fix conductors not to defeat a safeguard	A A A A	P
0	Compliance is checked by test:	(See Clause T.2)	Р
4.7	Equipment for direct insertion into mains socket	-outlets	N/A
4.7.2	Mains plug part complies with relevant standard:	0 0 0 0	N/A
4.7.3	Torque (Nm):	42 42 42 42	N/A
4.8	Equipment containing coin/button cell batteries		N/A
4.8.1	General	No lithium coin/button batteries are used.	N/A
4.8.2	Instructional safeguard:	CA CA CA CA	N/A
4.8.3	Battery compartment door/cover construction		N/A
44	Open torque test	40 40 40 40	N/A
4.8.4.2	Stress relief test	A A A A	N/A
4.8.4.3	Battery replacement test	CA CA CA CA	N/A
4.8.4.4	Drop test		N/A
4.8.4.5	Impact test	S . S . S . S . S	N/A
4.8.4.6	Crush test	4 4 4 4	N/A
4.8.5	Compliance	7 67 67 67 6	N/A
. 4	30N force test with test probe	.0 .0 .0 .0	N/A
6	20N force test with test hook		N/A
4.9	Likelihood of fire or shock due to entry of conductive object		N/A
4.10	Component requirements		N/A
4.10.1	Disconnect Device	(See Annex L)	N/A
4.10.2	Switches and relays	(See Annex G) No such component.	N/A



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Clause	Requirement + Test	Result - Remark	Verdic
2 . 4	ELECTRICALLY-CAUSED INJURY	-	Р
5		•••	P
5.2	Classification and limits of electrical energy source	KY KY KY KY	Y 4
5.2.2	ES1, ES2 and ES3 limits	See below.	P
5.2.2.2	Steady-state voltage and current limits:	(See appended table 5.2)	P
5.2.2.3	Capacitance limits	(See appended table 5.2)	Р
5.2.2.4	Single pulse limits	(See appended table 5.2)	N/A
5.2.2.5	Limits for repetitive pulses	(See appended table 5.2)	N/A
5.2.2.6	Ringing signals	(See Annex H)	N/A
5.2.2.7	Audio signals	(See Clause E.1)	Р
5.3	Protection against electrical energy sources	CAN CAN CAN CAN	Р
5.3.1	General Requirements for accessible parts to ordinary, instructed and skilled persons		P
5.3.1 a)	Accessible ES1/ES2 derived from ES2/ES3 circuits		Р
5.3.1 b)	Skilled persons not unintentional contact ES3 bare conductors	The Can Can Can	N/A
5.3.2.1	Accessibility to electrical energy sources and safeguards	AB AB AB AB	N/A
	Accessibility to outdoor equipment bare parts	0 0 0 0	N/A
5.3.2.2	Contact requirements	See below.	Р
9 49	Test with test probe from Annex V	0 0 0 0	_
5.3.2.2 a)	Air gap – electric strength test potential (V):	(See appended table 5.4.9)	Р
5.3.2.2 b)	Air gap – distance (mm):	0 0 0 0	N/A
5.3.2.3	Compliance	7 6 6 6	Р
5.3.2.4	Terminals for connecting stripped wire	P P P P	ΦP
5.4	Insulation materials and requirements		Р
5.4.1.2	Properties of insulating material	P P P P	P
5.4.1.3	Material is non-hygroscopic	Hygroscopic materials are not used for insulating material. Also see sub-clause 5.4.8 and 5.4.9.1	P
5.4.1.4	Maximum operating temperature for insulating materials	(See appended table)	P
5.4.1.5	Pollution degrees:	Pollution degree 2 considered	ΦP
5.4.1.5.2	Test for pollution degree 1 environment and for an insulating compound		N/A
5.4.1.5.3	Thermal cycling test	To to to to	N/A
5.4.1.6	Insulation in transformers with varying dimensions	D1 D1 D1 D1	N/A

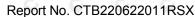
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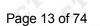
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Clause	Requirement + Test	Result - Remark	Verdict
5.4.1.7	Insulation in circuits generating starting pulses		N/A
5.4.1.8	Determination of working voltage:	(See appended table)	P
5.4.1.9	Insulating surfaces	Considered.	Р
5.4.1.10	Thermoplastic parts on which conductive metallic parts are directly mounted	THE LEW CLES	P
5.4.1.10.2	Vicat test:	(See appended table 5.4.1.10.2)	N/A
5.4.1.10.3	Ball pressure test	(See appended table 5.4.1.10.3)	P
5.4.2	Clearances	See below.	Р
5.4.2.1	General requirements	C & & & & & & & & & & & & & & & & & & &	P
,	Clearances in circuits connected to AC Mains, Alternative method	(See Annex X)	P
5.4.2.2	Procedure 1 for determining clearance		N/A
9	Temporary overvoltage	A A A A	_
5.4.2.3	Procedure 2 for determining clearance	, , , , , , ,	Р
5.4.2.3.2.2	a.c. mains transient voltage	C B C B C B C B C	_
5.4.2.3.2.3	d.c. mains transient voltage	No such transient	_
5.4.2.3.2.4	External circuit transient voltage:	No such transient	_
5.4.2.3.2.5	Transient voltage determined by measurement:	A A A A	
5.4.2.4	Determining the adequacy of a clearance using an electric strength test	(See appended table 5.4.2)	N/A
5.4.2.5	Multiplication factors for clearances and test voltages	The City City City C	N/A
5.4.2.6	Clearance measurement	(See appended table 5.4.2)	P
5.4.3	Creepage distances	, , , , , , ,	Р
5.4.3.1	General	C 2 C 2 C 2 C 2	P
5.4.3.3	Material group		_
5.4.3.4	Creepage distances measurement	(See appended table 5.4.3)	Р
5.4.4	Solid insulation	A A A A	Р
5.4.4.1	General requirements	CA CA CA CA	Р
5.4.4.2	Minimum distance through insulation:	(See appended table 5.4.4.2)	Р
5.4.4.3	Insulating compound forming solid insulation	S S S S S	N/A
5.4.4.4	Solid insulation in semiconductor devices	40 40 40 40	N/A
5.4.4.5	Insulating compound forming cemented joints	No such construction within the EUT	N/A
5.4.4.6	Thin sheet material	CA CA CA CA	Р





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Clause	Requirement + Test	Result - Remark	Verdict
5.4.4.6.1	General requirements		Р
5.4.4.6.2	Separable thin sheet material	.0 .0 .0 .0	ΦP
C C	Number of layers (pcs):	7 6 6 6 6	Р
5.4.4.6.3	Non-separable thin sheet material	No such construction within the EUT	N/A
9 49	Number of layers (pcs)	0 0 0 0	N/A
5.4.4.6.4	Standard test procedure for non-separable thin sheet material:	(See appended table 5.4.9)	N/A
5.4.4.6.5	Mandrel test	CA CA CA CA	N/A
5.4.4.7	Solid insulation in wound components		N/A
5.4.4.9	Solid insulation at frequencies >30 kHz, E _P , K _R , d, V _{PW} (V)	(See appended Table 5.4.4.9)	N/A
CTP	Alternative by electric strength test, tested voltage (V), K_R	(See appended Tables 5.4.4.9 and 5.4.9)	N/A
5.4.5	Antenna terminal insulation	A 4 4 A	₽ P
5.4.5.1	General	, 0, 0, 0, 0	Р
5.4.5.2	Voltage surge test	A B B B	P
5.4.5.3	Insulation resistance (M Ω)	0,0,0,0	Р
1 1 1	Electric strength test	(See appended table 5.4.9)	P
5.4.6	Insulation of internal wire as part of supplementary safeguard	A A A A	N/A
5.4.7	Tests for semiconductor components and for cemented joints	\$ \$ \$ \$ \$	N/A
5.4.8	Humidity conditioning		Р
SP	Relative humidity (%), temperature (°C), duration (h)	Start Start	_
5.4.9	Electric strength test	See below.	Р
5.4.9.1	Test procedure for type test of solid insulation:	(See appended table 5.4.9)	Р
5.4.9.2	Test procedure for routine test	.0 .0 .0 .0	N/A
5.4.10	Safeguards against transient voltages from external circuits		N/A
5.4.10.1	Parts and circuits separated from external circuits	CA CLACA CLACA	N/A
5.4.10.2	Test methods	5 5 5 5	N/A
5.4.10.2.1	General	2 C2 C3 C5 C5	N/A
5.4.10.2.2	Impulse test	(See appended table 5.4.9)	N/A
5.4.10.2.3	Steady-state test:	(See appended table 5.4.9)	N/A



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5.4.10.3	Verification for insulation breakdown for impulse test		N/A
5.4.11	Separation between external circuits and earth	CA CLACKA CLACK	N/A
5.4.11.1	Exceptions to separation between external circuits and earth	RA RA RA RA	N/A
5.4.11.2	Requirements		N/A
C.T. P	SPDs bridge separation between external circuit and earth	The Contraction of	N/A
	Rated operating voltage U _{op} (V):	A A A A	_
0, 0	Nominal voltage U _{peak} (V):	0,0,0,0	_
16	Max increase due to variation ΔU _{sp} :	CA CA CA CA	_
0	Max increase due to ageing ΔUsa:		_
5.4.11.3	Test method and compliance:	(See appended table 5.4.9)	N/A
5.4.12	Insulating liquid	No insulating liquid used.	N/A
5.4.12.1	General requirements	57 57 57 57 57 6	N/A
5.4.12.2	Electric strength of an insulating liquid:	(See appended table 5.4.9)	N/A
5.4.12.3	Compatibility of an insulating liquid:	(See appended table 5.4.9)	N/A
5.4.12.4	Container for insulating liquid:	.0 .0 .0 .0	N/A
5.5	Components as safeguards		Р
5.5.1	General	See the following details.	P
5.5.2	Capacitors and RC units	See below.	Р
5.5.2.1	General requirement	P P P P	N/A
5.5.2.2	Safeguards against capacitor discharge after disconnection of a connector	(See appended table 5.5.2.2)	N/A
5.5.3	Transformers	7 67 67 67 6	Р
5.5.4	Optocouplers	(See sub-clause 5.4 or Clause G.12)	N/A
5.5.5	Relays	(See sub-clause 5.4)	N/A
5.5.6	Resistors	(See Clause G.10)	N/A
5.5.7	SPDs	(See Clause G.8)	N/A
5.5.8	Insulation between the mains and an external circuit consisting of a coaxial cable:		N/A
5.5.9	Safeguards for socket-outlets in outdoor equipment	CA CA CA CA	N/A
, 3,	RCD rated residual operating current (mA):	0, 0, 0, 0	_
5.6	Protective conductor	ST CT CT CT	N/A
5.6.2	Requirement for protective conductors		N/A



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Clause	Requirement + Test	Result - Remark	Verdic
5.6	Protective conductor		N/A
5.6.2	Requirement for protective conductors	0.0.0.0	N/A
5.6.2.1	General requirements	7 67 67 67 6	N/A
5.6.2.2	Colour of insulation	P. P. P. P.	N/A
5.6.3	Requirement for protective earthing conductors		N/A
10	Protective earthing conductor size (mm²):	PA PA PA PA	_
C	Protective earthing conductor serving as a reinforced safeguard		N/A
C. S.	Protective earthing conductor serving as a double safeguard		N/A
5.6.4	Requirements for protective bonding conductors	J. C. C. C. C.	N/A
5.6.4.1	Protective bonding conductors	40 40 A0 A0	N/A
6	Protective bonding conductor size (mm²):	J. C. C. C. C.	5 —
5.6.4.2	Protective current rating (A):	0.0.0.0	N/A
5.6.5	Terminals for protective conductors		N/A
5.6.5.1	Terminal size for connecting protective earthing conductors (mm)	Ch Ch Ch Ch	N/A
100	Terminal size for connecting protective bonding conductors (mm):	47 47 47 47 A	N/A
5.6.5.2	Corrosion	4 4 4 4	N/A
5.6.6	Resistance of the protective bonding system	VA VA VA VA	N/A
5.6.6.1	Requirements		N/A
5.6.6.2	Test Method:	(See appended table 5.6.6)	N/A
5.6.6.3	Resistance (Ω) or voltage drop:	(See appended table 5.6.6)	N/A
5.6.7	Reliable connection of a protective earthing conductor	2000	N/A
5.6.8	Functional earthing	Ch Ch Ch Ch	N/A
- Ah	Conductor size (mm²):		N/A
C. C.	Class II with functional earthing marking:	Charles Charles	N/A
	Appliance inlet cl & cr (mm):	0 0 0 0	N/A
5.7	Prospective touch voltage, touch current and protective conductor current		P
5.7.2	Measuring devices and networks	4 4 4 4	4 P
5.7.2.1	Measurement of touch current	1 2 2 2	Р
5.7.2.2	Measurement of voltage	0 0 0 0	⊘ P
5.7.3	Equipment set-up, supply connections and earth connections		Р



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5.7.4	Unearthed accessible parts:	(See appended table 5.7.4)	Р			
5.7.5	Earthed accessible conductive parts:	(See appended table 5.7.5)	N/A			
5.7.6	Requirements when touch current exceeds ES2 limits		N/A			
65	Protective conductor current (mA)	2, 2, 2, 2,	N/A			
b 40	Instructional Safeguard:	4 4 4 4	N/A			
5.7.7	Prospective touch voltage and touch current associated with external circuits		N/A			
5.7.7.1	Touch current from coaxial cables	CA CA CA CA	N/A			
5.7.7.2	Prospective touch voltage and touch current associated with paired conductor cables	A A A A A	N/A			
5.7.8	Summation of touch currents from external circuits	0,0,0,0	N/A			
CLA	a) Equipment connected to earthed external circuits, current (mA):	THE CTHE CTHE	N/A			
CAB	b) Equipment connected to unearthed external circuits, current (mA):	THE THE THE THE	N/A			
5.8	Backfeed safeguard in battery backed up supplie	es 🔈 🐼 🗞 🗞	N/A			
25	Mains terminal ES	(See appended table 5.8)	N/A			

No battery backed up supplies



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6	ELECTRICALLY- CAUSED FIRE		Р
6.2	Classification of PS and PIS		P
6.2.2	Power source circuit classifications	(See appended table 6.2.2)	P
6.2.3	Classification of potential ignition sources	S' S' S' S'	Р
6.2.3.1	Arcing PIS:	All parts in circuits inside enclosure is considered as Arcing PIS	P
6.2.3.2	Resistive PIS:	(See appended table 6.2.3.1) All parts in circuits and components inside enclosure considered as Resistive PIS (See appended table 6.2.3.2)	P
6.3	Safeguards against fire under normal operating a conditions	and abnormal operating	P
6.3.1	No ignition and attainable temperature value less than 90 % defined by ISO 871 or less than 300 °C for unknown materials	No ignition and no such temperature attained within the equipment. (See appended table B.1.5 and	⊕ P
C'	Combustible meterials sutside fire analyseurs	B.3)	N/A
6.4	Combustible materials outside fire enclosure		P
6.4.1	Safeguards against fire under single fault conditi Safeguard method	Method by control of fire spread applied. Fire enclosure provided.	P
6.4.2	Reduction of the likelihood of ignition under single fault conditions in PS1 circuits	CAR CAR CAR CAR CA	Р
6.4.3	Reduction of the likelihood of ignition under single fault conditions in PS2 and PS3 circuits	Sp. Sp. Sp. Sp.	P
6.4.3.1	Supplementary safeguards	4 4 4 4	N/A
6.4.3.2	Single Fault Conditions	(See appended table B.4)	N/A
.0	Special conditions for temperature limited by fuse	0 0 0 0	N/A
6.4.4	Control of fire spread in PS1 circuits		Р
6.4.5	Control of fire spread in PS2 circuits	P P P P	P
6.4.5.2	Supplementary safeguards		N/A
6.4.6	Control of fire spread in PS3 circuits	P P P P	♦ P
6.4.7	Separation of combustible materials from a PIS		Р
6.4.7.2	Separation by distance	A PAPAPA	N/A
6.4.7.3	Separation by a fire barrier	0, 0, 0, 0, 0	N/A
6.4.8	Fire enclosures and fire barriers	V-0 of Plastic enclosure used	♥P.





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6.4.8.2	Fire enclosure and fire barrier material properties	7 c7 c7 c7	Р
6.4.8.2.1	Requirements for a fire barrier	0.0.0.0	N/A
6.4.8.2.2	Requirements for a fire enclosure	7 6 6 6	Р
6.4.8.3	Constructional requirements for a fire enclosure and a fire barrier	The River River River	Р
6.4.8.3.1	Fire enclosure and fire barrier openings	4 4 4 4	N/A
6.4.8.3.2	Fire barrier dimensions	7 67 67 67	N/A
6.4.8.3.3	Top openings and properties	0.00.00	N/A
6	Openings dimensions (mm):	7 67 67 67 6	N/A
6.4.8.3.4	Bottom openings and properties	A A A A	N/A
67	Openings dimensions (mm):	7 67 67 67 6	N/A
7.49	Flammability tests for the bottom of a fire enclosure	(See Clause S.3)	N/A
6	Instructional Safeguard:	0 0 0 0	N/A
6.4.8.3.5	Side openings and properties	CO CO CO CO	N/A
0' 0	Openings dimensions (mm):	0,0,0,0	N/A
6.4.8.3.6	Integrity of a fire enclosure, condition met: a), b) or c):	La Cha Cha Cha	N/A
6.4.8.4	Separation of a PIS from a fire enclosure and a fire barrier distance (mm) or flammability rating:	THE LEW LEW LEW	N/A
6.4.9	Flammability of insulating liquid	0 0 0 0	N/A
6.5	Internal and external wiring	7 67 67 67	Р
6.5.1	General requirements	0 0 0 0	♦ P
6.5.2	Requirements for interconnection to building wiring	No such interconnection to building wiring.	N/A
6.5.3	Internal wiring size (mm²) for socket-outlets:	No such interconnection to building wiring.	N/A
6.6	Safeguards against fire due to the connection to	additional equipment	P

7	INJURY CAUSED BY HAZARDOUS SUBSTANCES	N/A
7.2	Reduction of exposure to hazardous substances	N/A
7.3	Ozone exposure	N/A
7.4	Use of personal safeguards or personal protective equipment (PPE)	N/A
5	Personal safeguards and instructions:	_
7.5	Use of instructional safeguards and instructions	N/A
67	Instructional safeguard (ISO 7010):	_
7.6	Batteries and their protection circuits	N/A

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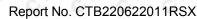


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8	MECHANICALLY-CAUSED INJURY		P
8.2	Mechanical energy source classifications		Р
8.3	Safeguards against mechanical energy sources		♦ P
8.4	Safeguards against parts with sharp edges and corners		Р
8.4.1	Safeguards	No sharp edges and corners in accessible area.	P
. 4	Instructional Safeguard	& & & & &	N/A
8.4.2	Sharp edges or corners	No sharp edges and corners in accessible area.	Р
8.5	Safeguards against moving parts	40 40 40 40	N/A
8.5.1	Fingers, jewellery, clothing, hair, etc., contact with MS2 or MS3 parts	A A A A	N/A
0,0	MS2 or MS3 part required to be accessible for the function of the equipment	\$ \$ \$ \$ \$ \$	N/A
c" c	Moving MS3 parts only accessible to skilled person		N/A
8.5.2	Instructional safeguard	A A A A	N/A
8.5.4	Special categories of equipment containing moving parts	4 4 4 4	N/A
8.5.4.1	General		N/A
8.5.4.2	Equipment containing work cells with MS3 parts	0 0 0 0	N/A
8.5.4.2.1	Protection of persons in the work cell		N/A
8.5.4.2.2	Access protection override	A A A A	N/A
8.5.4.2.2.1	Override system	. 0, 0, 0, 0	N/A
8.5.4.2.2.2	Visual indicator	CA CA CA CA	N/A
8.5.4.2.3	Emergency stop system		N/A
c ⁵ c	Maximum stopping distance from the point of activation (m)		N/A
C S C	Space between end point and nearest fixed mechanical part (mm)	THE CAR CAR CAR	N/A
8.5.4.2.4	Endurance requirements	4 4 4 4	N/A
C' C	Mechanical system subjected to 100 000 cycles of operation		N/A
0 0	- Mechanical function check and visual inspection	7 c7 c7 c7 c	N/A
9	- Cable assembly	0.0.0.0	N/A
8.5.4.3	Equipment having electromechanical device for destruction of media	2 0 0 0 0	N/A





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8.5.4.3.1	Equipment safeguards	5 65 65 65	N/A	
8.5.4.3.2	Instructional safeguards against moving parts:	A A A	N/A	
8.5.4.3.3	Disconnection from the supply		N/A	
8.5.4.3.4	Cut type and test force (N)	A P P P	N/A	
8.5.4.3.5	Compliance	0, 0, 0, 0,	N/A	
8.5.5	High pressure lamps	4 4 4 4 A	N/A	
0, 0	Explosion test	0 0 0 0	N/A	
8.5.5.3	Glass particles dimensions (mm)	4 4 4 4 4 4	N/A	
8.6	Stability of equipment		N/A	
8.6.1	General	4 4 4 4 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	N/A	
9 49	Instructional safeguard	40 40 40	N/A	
8.6.2	Static stability	J. C. C. C.	N/A	
8.6.2.2	Static stability test	.0 .0 .0	N/A	
8.6.2.3	Downward force test		N/A	
8.6.3	Relocation stability	A P P	N/A	
0 0	Wheels diameter (mm)	0, 0, 0, 0,		
1 P. W.	Tilt test	4 4 4 4 A	N/A	
8.6.4	Glass slide test	0 0 0	N/A	
8.6.5	Horizontal force test:	44 44 44 4	N/A	
8.7	Equipment mounted to wall, ceiling or other struc	cture	N/A	
8.7.1	Mount means type	4, 4, 4, 4,	N/A	
8.7.2	Test methods	40 40 40	N/A	
65	Test 1, additional downwards force (N)	J. C. C. C.	N/A	
N. P.	Test 2, number of attachment points and test force (N)	40 40 40 A	N/A	
7 6	Test 3 Nominal diameter (mm) and applied torque (Nm)	A 42 42 42	N/A	
8.8	Handles strength	0,0,0,0,	N/A	
8.8.1	General	No handles.	N/A	
8.8.2	Handle strength test		N/A	
40	Number of handles ::	20 20 20 2	y	
	Force applied (N)	A	A A	
8.9	Wheels or casters attachment requirements	4 4 4 A	N/A	
8.9.2	Pull test	No such devices	N/A	



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Clause	Requirement + Test	Result - Remark	Verdict
8.10	Carts, stands and similar carriers		N/A
8.10.1	General	No carts, stands and similar carriers used	N/A
8.10.2	Marking and instructions	5 5 5 5	N/A
8.10.3	Cart, stand or carrier loading test	2, 2, 2, 2,	N/A
9 49	Loading force applied (N)	4 4 4 4	N/A
8.10.4	Cart, stand or carrier impact test		N/A
8.10.5	Mechanical stability	0 0 0 0	N/A
0	Force applied (N)		()
8.10.6	Thermoplastic temperature stability	A P P P	N/A
8.11	Mounting means for slide-rail mounted equipment (SRME)		N/A
8.11.1	General	No such devices	N/A
8.11.2	Requirements for slide rails	0, 0, 0, 0, 0	N/A
4 4	Instructional Safeguard	VA VA VA VA	N/A
8.11.3	Mechanical strength test	0 0 0 0	N/A
8.11.3.1	Downward force test, force (N) applied	4 4 4 4 4 4 4 A	N/A
8.11.3.2	Lateral push force test		N/A
8.11.3.3	Integrity of slide rail end stops	5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	N/A
8.11.4	Compliance	4 4 4 4	N/A
8.12	Telescoping or rod antennas	J. C. C. C. C.	N/A
9 49	Button/ball diameter (mm)	40 40 40 40	_

9	THERMAL BURN INJURY		Р
9.2	Thermal energy source classifications		Р
9.3	Touch temperature limits		Р
9.3.1	Touch temperatures of accessible parts	(See appended table)	Р
9.3.2	Test method and compliance		Р
9.4	Safeguards against thermal energy sources		Р
9.5	Requirements for safeguards		N/A
9.5.1	Equipment safeguard		N/A
9.5.2	Instructional safeguard:		N/A
9.6	Requirements for wireless power transmitters		N/A
9.6.1	General	Not such equipment	N/A
9.6.2	Specification of the foreign objects		N/A

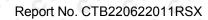


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PAP	IEC 62368-1	4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4	KP K
Clause	Requirement + Test	Result - Remark	Verdict
9.6.3	Test method and compliance:	(See appended table 9.6)	N/A

10	RADIATION		Р
10.2	Radiation energy source classification		P
10.2.1	General classification		Р
10	Lasers:	P P P P	
0	Lamps and lamp systems:	LEDs	_
C. B	Image projectors:	P P P P	
0	X-Ray:	0 0 0 0 0	
100	Personal music player:	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	_
10.3	Safeguards against laser radiation	3 	N/A
Ch	The standard(s) equipment containing laser(s) comply:	CF CF CF CF C	N/A
10.4	Safeguards against optical radiation from lamps LED types)	and lamp systems (including	P
10.4.1	General requirements	LED indicator are considered as RS1.	P
N. B	Instructional safeguard provided for accessible radiation level needs to exceed	AB AB AB AB	N/A
	Risk group marking and location		N/A
65	Information for safe operation and installation	5, 5, 5, 5, 5,	N/A
10.4.2	Requirements for enclosures	40 40 40 40	N/A
0	UV radiation exposure	(See Annex C)	N/A
10.4.3	Instructional safeguard	.0 .0 .0 .0	N/A
10.5	Safeguards against X-radiation		N/A
10.5.1	Requirements	P P P P	N/A
6	Instructional safeguard for skilled persons:		_
10.5.3	Maximum radiation (pA/kg):	(See appended tables B.3 & B.4)	_
10.6	Safeguards against acoustic energy sources	.0 .0 .0 .0	N/A
10.6.1	General		N/A
10.6.2	Classification	A A A A	N/A
C"	Acoustic output L _{Aeq,T} , dB(A)	6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6	N/A
4	Unweighted RMS output voltage (mV)	4 4 4 4	N/A
C'	Digital output signal (dBFS)	0 0 0 0 0	N/A
10.6.3	Requirements for dose-based systems	A A A A	N/A





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Clause	Requirement + Test	Result - Remark	Verdict
10.6.3.1	General requirements	P 67 67 67	N/A
10.6.3.2	Dose-based warning and automatic decrease	0.0.0	N/A
10.6.3.3	Exposure-based warning and requirements		N/A
9 6	30 s integrated exposure level (MEL30)	A P P P	N/A
C' (Warning for MEL ≥ 100 dB(A)		N/A
10.6.4	Measurement methods	A P P	N/A
10.6.5	Protection of persons	0, 0, 0, 0,	N/A
A P	Instructional safeguards:	CA CA CA	N/A
10.6.6	Requirements for listening devices (headphones, earphones, etc.)	\$ \$ \$ \$ \$	N/A
10.6.6.1	Corded listening devices with analogue input		N/A
4	Listening device input voltage (mV):	A A A	N/A
10.6.6.2	Corded listening devices with digital input	0 0 0 0	N/A
7 4	Max. acoustic output L _{Aeq,T} , dB(A)	CO CO CO	N/A
10.6.6.3	Cordless listening devices	0, 0, 0, 0,	N/A
V. D.	Max. acoustic output L _{Aeq,T} , dB(A)	CB CB CB C	N/A

В	NORMAL OPERATING CONDITION TESTS, ABNORMAL OPERATING CONDITION TESTS AND SINGLE FAULT CONDITION TESTS General		Р
B.1			PР
B.1.5	Temperature measurement conditions	(See appended table B.1.5)	Р
B.2	Normal operating conditions	TO TO TO TO	P
B.2.1	General requirements	(See Test Item Particulars and appended test tables)	Р
C 3	Audio Amplifiers and equipment with audio amplifiers	(See Annex E) No such device	N/A
B.2.3	Supply voltage and tolerances		N/A
B.2.5	Input test	: (See appended table B.2.5)	P
B.3	Simulated abnormal operating conditions	0 0 0 0	Р
B.3.1	General	See below.	P
B.3.2	Covering of ventilation openings	C, C, C, C, C	N/A
N. P.	Instructional safeguard	CO CO CO CO	N/A
B.3.3	DC mains polarity test	0,0,0,0	N/A
B.3.4	Setting of voltage selector	12 12 12 12 12	N/A
B.3.5	Maximum load at output terminals	0 0 0 0 0	P
B.3.6	Reverse battery polarity	CA CA CA CA	N/A





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4.4	IEC 62368-1	LA LA LA LA	4 4
Clause	Requirement + Test	Result - Remark	Verdic
B.3.7	Audio amplifier abnormal operating conditions		N/A
B.3.8	Safeguards functional during and after abnormal operating conditions:	(See appended table B.3)	P
B.4	Simulated single fault conditions		Р
B.4.1	General	N 63 63 63 6	Р
B.4.2	Temperature controlling device	0.0.0.0	N/A
B.4.3	Blocked motor test	2 6 6 6	N/A
B.4.4	Functional insulation	A A A A	ΦP
B.4.4.1	Short circuit of clearances for functional insulation		Р
B.4.4.2	Short circuit of creepage distances for functional insulation	THE LAB CLAS CLAS	Р
B.4.4.3	Short circuit of functional insulation on coated printed boards	CA CA CA CA	N/A
B.4.5	Short-circuit and interruption of electrodes in tubes and semiconductors	A A A A	Р
B.4.6	Short circuit or disconnection of passive components		P
B.4.7	Continuous operation of components		Р
B.4.8	Compliance during and after single fault conditions	(See appended table B.4)	Р
B.4.9	Battery charging and discharging under single fault conditions	(See Annex M)	N/A
С	UV RADIATION		N/A
C.1	Protection of materials in equipment from UV rac	diation	N/A
C.1.2	Requirements		N/A
C.1.3	Test method	S. 22. 22. 22.	N/A
C.2	UV light conditioning test	4 4 4 4	N/A
C.2.1	Test apparatus:	N 67 67 67	N/A
C.2.2	Mounting of test samples	0 0 0 0	N/A
C.2.3	Carbon-arc light-exposure test		N/A
C.2.4	Xenon-arc light-exposure test	P. P. P. P.	N/A
D	TEST GENERATORS		N/A
D.1 🔷	Impulse test generators	P2 P2 P2 P3	N/A
D.2	Antenna interface test generator	0, 0, 0, 0, 0	N/A
D.3	Electronic pulse generator	A A A A	N/A
E	TEST CONDITIONS FOR EQUIPMENT CONTAINI	NG AUDIO AMPLIFIERS	N/A
E.1	Electrical energy source classification for audio	signals	N/A



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12	IEC 62368-1	VA VA VA VA	N. P.
Clause	Requirement + Test	Result - Remark	Verdict
	Maximum non-clipped output power (W):	P CY CY CY C	_
. 4	Rated load impedance (Ω):	.0 .0 .0 .0	_
C'Y	Open-circuit output voltage (V):	5 05 05 05	_
9 19	Instructional safeguard:	See Clause F.5	
E.2	Audio amplifier normal operating conditions		Р
1 KB	Audio signal source type:	P P P P P	_
0	Audio output power (W):	0 0 0 0	
100	Audio output voltage (V):	C C C C C C	_
0	Rated load impedance (Ω):	0 0 0 0	
100	Requirements for temperature measurement	(See Table B.1.5)	Р
E.3	Audio amplifier abnormal operating conditions	(See Table B.3, B.4)	Р
F	EQUIPMENT MARKINGS, INSTRUCTIONS, AND I SAFEGUARDS	NSTRUCTIONAL	Р
F.1	General	5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	Р
CLA	Language:	English version provided. (Version in other language will be provided when submitted for national approval)	
F.2	Letter symbols and graphical symbols		Р
F.2.1	Letter symbols according to IEC60027-1	Letter symbols for quantities and units are complied with IEC 60027-1.	P
F.2.2	Graphic symbols according to IEC, ISO or manufacturer specific	Graphical symbols are complied with IEC 60417, ISO 3864-2, ISO 7000 or ISO 7010.	Р
F.3	Equipment markings		Р
F.3.1	Equipment marking locations	CA CA CA CA	Р
F.3.2	Equipment identification markings	See below.	Р
F.3.2.1	Manufacturer identification:	See copy of marking plate	Р
F.3.2.2	Model identification:	See copy of marking plate	Р
F.3.3	Equipment rating markings	See below	Р
F.3.3.1	Equipment with direct connection to mains	0 0 0 0	P
F.3.3.2	Equipment without direct connection to mains	5 65 65 6	N/A
F.3.3.3	Nature of the supply voltage:	See copy of marking plate	P
F.3.3.4	Rated voltage:	See copy of marking plate	Р
F.3.3.5	Rated frequency:	See copy of marking plate	⊗ P



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Clause	Requirement + Test	Result - Remark	Verdict
***	\$ \$\phi & \phi &	\$ \$\psi \psi \psi \psi \psi \psi \psi \psi	Verdie
F.3.3.6	Rated current or rated power:	See copy of marking plate	Р
F.3.3.7	Equipment with multiple supply connections	D D D D	N/A
F.3.4	Voltage setting device	No such device.	N/A
F.3.5	Terminals and operating devices	See copy of marking plate	P
F.3.5.1	Mains appliance outlet and socket-outlet markings	No such device.	N/A
F.3.5.2	Switch position identification marking::	No switch.	N/A
F.3.5.3	Replacement fuse identification and rating markings	No such device.	N/A
. 4	Instructional safeguards for neutral fuse:	A A A A	N/A
F.3.5.4	Replacement battery identification marking:	No such device.	N/A
F.3.5.5	Neutral conductor terminal	No permanently connected equipment	N/A
F.3.5.6	Terminal marking location	A A A A	Р
F.3.6	Equipment markings related to equipment classification	the Charles of the Charles	Р
F.3.6.1	Class I equipment	P P P P	N/A
F.3.6.1.1	Protective earthing conductor terminal:	0,0,0,0	N/A
F.3.6.1.2	Protective bonding conductor terminals:	CAN GA GA GA	N/A
F.3.6.2	Equipment class marking	See copy of marking plate	Р
F.3.6.3	Functional earthing terminal marking:	LA LA LA LA	N/A
F.3.7	Equipment IP rating marking:	IPX0.	N/A
F.3.8	External power supply output marking:	See copy of marking plate	P
F.3.9	Durability, legibility and permanence of marking	Marking is considered to be legible and easily discernible. See also the following details	P
F.3.10	Test for permanence of markings	The marking plate was subjected to the permanence of marking test. The marking plate was rubbed with cloth soaked with water for 15 s and then again for 15 s with the cloth soaked with petroleum spirit. After each test, there was no damage to the marking plate. The marking on the label did not fade. There was no curling of the marking plate and removed by hand.	P



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17/10	IEC 62368-1	LA LA LA LA	C. W.
Clause	Requirement + Test	Result - Remark	Verdic
27	a) Information prior to installation and initial use	Provided in user's manual.	Р
N. P.	b) Equipment for use in locations where children not likely to be present	ST ST ST ST	N/A
	c) Instructions for installation and interconnection	Provided in user's manual.	Р
C'S	d) Equipment intended for use only in restricted access area	5 65 65 65 6	N/A
42	e) Equipment intended to be fastened in place	LA LA LA LA	N/A
	f) Instructions for audio equipment terminals	4 4 4 4	N/A
17	g) Protective earthing used as a safeguard	CA CA CA CA	N/A
, K. P.	h) Protective conductor current exceeding ES2 limits	C	N/A
9 4	i) Graphic symbols used on equipment	Graphical symbols not used as an instructional safeguard.	N/A
C'Y	j) Permanently connected equipment not provided with all-pole mains switch		N/A
C.S.	k) Replaceable components or modules providing safeguard function	2 62 62 6	N/A
14	Equipment containing insulating liquid	CA CA CA CA	N/A
	m) Installation instructions for outdoor equipment	A A A A	N/A
F.5	Instructional safeguards	4 4 4 4	N/A
G	COMPONENTS		P
G.1	Switches	J. C. C. C. C.	N/A
G.1.1	General	No switch used.	N/A
G.1.2	Ratings, endurance, spacing, maximum load	7 67 67 6	N/A
G.1.3	Test method and compliance	0 0 0 0	N/A
G.2	Relays		N/A
G.2.1	Requirements	No relays used.	N/A
G.2.2	Overload test		N/A
G.2.3	Relay controlling connectors supplying power to other equipment	The Liberthe Cipe	N/A
G.2.4	Test method and compliance	0.0.0.0	N/A
G.3	Protective devices		P
G.3.1	Thermal cut-offs	No thermal cut-off provided within the equipment.	N/A
N. P.	Thermal cut-outs separately approved according to IEC 60730 with conditions indicated in a) & b)	A A A A	N/A
0	Thermal cut-outs tested as part of the equipment as indicated in c)	\$ \$ \$ \$	N/A



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Clause	Requirement + Test	Result - Remark	Verdic
G.3.1.2	Test method and compliance		N/A
G.3.2	Thermal links	No thermal links used.	N/A
G.3.2.1	a) Thermal links tested separately according to IEC 60691 with specifics	TOTAL COLOR	N/A
150	b) Thermal links tested as part of the equipment	4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4	N/A
G.3.2.2	Test method and compliance	4 4 4 4	N/A
G.3.3	PTC thermistors	No PTC thermistors used.	N/A
G.3.4	Overcurrent protection devices	0 0 0 0	♦ P
G.3.5	Safeguards components not mentioned in G.3.1 to G.3.4		N/A
G.3.5.1	Non-resettable devices suitably rated and marking provided	C C C C	N/A
G.3.5.2	Single faults conditions:	24 24 24 24	N/A
G.4	Connectors		P
G.4.1	Spacings	CA CA CA CA	N/A
G.4.2	Mains connector configuration:		N/A
G.4.3	Plug is shaped that insertion into mains socket- outlets or appliance coupler is unlikely	S C C C C C	Р
G.5	Wound components	LA LA LA LA	P
G.5.1	Wire insulation in wound components		P
G.5.1.2	Protection against mechanical stress	LA LA LA LA	Р
G.5.2	Endurance test	A A A A	N/A
G.5.2.1	General test requirements	CA CA CA CA	N/A
G.5.2.2	Heat run test	D D D D	N/A
657	Test time (days per cycle)	8 . C. C	. · ·
40	Test temperature (°C):	4 4 4 4	_
G.5.2.3	Wound components supplied from the mains	1 67 67 67 6	N/A
G.5.2.4	No insulation breakdown	0 0 0 0	N/A
G.5.3	Transformers	7 67 67 67 6	P.
G.5.3.1	Compliance method:	P. P. P. P.	♦ P
0 0	Position:		P
(P)	Method of protection:	P P P P	♥ P
G.5.3.2	Insulation	0 0 0	Р
7 P	Protection from displacement of windings:	P P P P	_
G.5.3.3	Transformer overload tests	0 0 0	Р
G.5.3.3.1	Test conditions	ウェウェウ マ	Р



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.07	IEC 62368-1				
Clause	Requirement + Test	Result - Remark	Verdict		
G.5.3.3.2	Winding temperatures	C) C) C) C)	P		
G.5.3.3.3	Winding temperatures - alternative test method	P P P P	N/A		
G.5.3.4	Transformers using FIW	C C C C	N/A		
G.5.3.4.1	General	A A A	N/A		
6 6	FIW wire nominal diameter:	c, c, c, c,	G -		
G.5.3.4.2	Transformers with basic insulation only	P P P P	N/A		
G.5.3.4.3	Transformers with double insulation or reinforced insulation:		N/A		
G.5.3.4.4	Transformers with FIW wound on metal or ferrite core		N/A		
G.5.3.4.5	Thermal cycling test and compliance	2, 2, 2, 2	N/A		
G.5.3.4.6	Partial discharge test	. 40 . 40 . 40 . A	N/A		
G.5.3.4.7	Routine test	ch ch ch ch	N/A		
G.5.4	Motors	No motor used.	N/A		
G.5.4.1	General requirements	C C C C	N/A		
G.5.4.2	Motor overload test conditions	A P P P	N/A		
G.5.4.3	Running overload test	c' c' c' c'	N/A		
G.5.4.4.2	Locked-rotor overload test	P P P P	N/A		
0 0	Test duration (days):				
G.5.4.5	Running overload test for DC motors	C P C P C	N/A		
G.5.4.5.2	Tested in the unit	0,0,0,0	N/A		
G.5.4.5.3	Alternative method	20 20 20 C	N/A		
G.5.4.6	Locked-rotor overload test for DC motors		N/A		
G.5.4.6.2	Tested in the unit	CA VA VA	N/A		
	Maximum Temperature:		N/A		
G.5.4.6.3	Alternative method	5 5 5 5 5 5 S	N/A		
G.5.4.7	Motors with capacitors	4 4 4	N/A		
G.5.4.8	Three-phase motors	S S S S	N/A		
G.5.4.9	Series motors	0 0 0	N/A		
6	Operating voltage:	chi chi chi ch			
G.6	Wire Insulation	D D D	9 .9 P		
G.6.1	General		P P		
G.6.2	Enamelled winding wire insulation	0 0 0	N/A		
G.7	Mains supply cords	C' C' C' C'	N/A		
G.7.1	General requirements	0 0 0	N/A		



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Clause	Requirement + Test	Result - Remark	Verdict
1	Туре		_
G.7.2	Cross sectional area (mm² or AWG)	40 40 40 40	N/A
G.7.3	Cord anchorages and strain relief for non- detachable power supply cords		N/A
G.7.3.2	Cord strain relief		N/A
G.7.3.2.1	Requirements	4 4 4 4	N/A
05 0	Strain relief test force (N):	1 67 67 67 6	N/A
G.7.3.2.2	Strain relief mechanism failure	0 0 0 0	N/A
G.7.3.2.3	Cord sheath or jacket position, distance (mm):	2 62 62 63	N/A
G.7.3.2.4	Strain relief and cord anchorage material	0 0 0 0	N/A
G.7.4	Cord Entry		N/A
G.7.5	Non-detachable cord bend protection	Not such equipment.	N/A
G.7.5.1	Requirements	, 0, 0, 0, 0	N/A
G.7.5.2	Test method and compliance	P P P P	N/A
,	Overall diameter or minor overall dimension, <i>D</i> (mm)	\$ \$ \$ \$ \$ \$	_
0,0	Radius of curvature after test (mm):		_
G.7.6	Supply wiring space	0 0 0 0	N/A
G.7.6.1	General requirements	. 0, 0, 0, 0	N/A
G.7.6.2	Stranded wire	CA CA CA CA	N/A
G.7.6.2.1	Requirements	0,0,0,0	N/A
G.7.6.2.2	Test with 8 mm strand	CA CA CA CA	N/A
G.8	Varistors		N/A
G.8.1	General requirements	CA CA CA CA	N/A
G.8.2	Safeguards against fire		N/A
G.8.2.1	General		N/A
G.8.2.2	Varistor overload test	4 4 4 4	N/A
G.8.2.3	Temporary overvoltage test	5' 5' 5' 5' 5' 6	N/A
G.9	Integrated circuit (IC) current limiters	.0 .0 .0 .0	N/A
G.9.1	Requirements	No IC current limiter provided within the equipment.	N/A
55	IC limiter output current (max. 5A):	SY SY SY SY	_
	Manufacturers' defined drift:	0 0 0	_
G.9.2	Test Program	V 6 V 6 V 6 V 6	N/A
G.9.3	Compliance		N/A

Shenzhen CTB Testing Technology Co., Ltd.
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N. P. A.	IEC 62368-1	Charle Charle	4 4
Clause	Requirement + Test	Result - Remark	Verdict
G.10	Resistors	A CA CA CA	N/A
G.10.1	General	No such device.	N/A
G.10.2	Conditioning	7 67 67 67 6	N/A
G.10.3	Resistor test	P P P P	N/A
G.10.4	Voltage surge test		N/A
G.10.5	Impulse test	P P P P	N/A
G.10.6	Overload test	, 0, 0, 0, 0	N/A
G.11	Capacitors and RC units	A A A A	₽ P
G.11.1	General requirements	0,0,0,0	Р
G.11.2	Conditioning of capacitors and RC units	CA CA CA CA	Р
G.11.3	Rules for selecting capacitors	0.0.0.0	Р
G.12	Optocouplers	VA VA VA VA	N/A
0.0	Optocouplers comply with IEC 60747-5-5 with specifics	No Optocouplers within the equipment.	N/A
0' 6	Type test voltage V _{ini,a} :	0,0,0,0	_
7 79	Routine test voltage, V _{ini, b} :	C	d —
G.13	Printed boards	0,0,0,0	Р
G.13.1	General requirements	40 40 40 40	Р
G.13.2	Uncoated printed boards	A A A A	Р
G.13.3	Coated printed boards	CA CA CA CA	N/A
G.13.4	Insulation between conductors on the same inner surface	CO KO KO KO	N/A
G.13.5	Insulation between conductors on different surfaces	0.0.0.0	N/A
44	Distance through insulation:	CA VA VA VA	N/A
0	Number of insulation layers (pcs):	A A A A	_
G.13.6	Tests on coated printed boards	CA CA CA CA	N/A
G.13.6.1	Sample preparation and preliminary inspection	A A A A	N/A
G.13.6.2	Test method and compliance	C. C. C. C.	N/A
G.14	Coating on components terminals	41 41 41 41	N/A
G.14.1	Requirements:	(See Clause G.13)	N/A
G.15	Pressurized liquid filled components	A A A A	N/A
G.15.1	Requirements	No such device.	N/A
G.15.2	Test methods and compliance	0 0 0 0	N/A
G.15.2.1	Hydrostatic pressure test	000000000000000000000000000000000000000	N/A
G.15.2.2	Creep resistance test	0 0 0 0	N/A

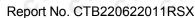
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Clause	Requirement + Test	Result - Remark	Verdic
-	\$ \$\tau \tau \tau \tau \tau \tau \tau \tau	result - Neman	*
G.15.2.3	Tubing and fittings compatibility test		N/A
G.15.2.4	Vibration test	P P P P	N/A
G.15.2.5	Thermal cycling test		N/A
G.15.2.6	Force test	P P P P	N/A
G.15.3	Compliance	0,0,0,0,	N/A
G.16	IC including capacitor discharge function (ICX)	CO CO CO	N/A
G.16.1	Condition for fault tested is not required	No such device.	N/A
N. F	ICX with associated circuitry tested in equipment	KO KO KO K	N/A
0, 0	ICX tested separately	0,0,0,0,	N/A
G.16.2	Tests	1 4 4 4 4 4 4 4	N/A
24	Smallest capacitance and smallest resistance specified by ICX manufacturer for impulse test:	4 4 4 6 A	<u>-</u> ا
0,40	Mains voltage that impulses to be superimposed on		& C =
0	Largest capacitance and smallest resistance for ICX tested by itself for 10000 cycles test:		_ c =
G.16.3	Capacitor discharge test:	2 2 2 2 2 C	N/A
Н	CRITERIA FOR TELEPHONE RINGING SIGNALS		N/A
H.1	General	2. 2. 2. 2	N/A
H.2	Method A	40 40 40	N/A
H.3	Method B	1 67 67 67	N/A
H.3.1	Ringing signal	0 0 0	N/A
H.3.1.1	Frequency (Hz):	2 62 62	<u> </u>
H.3.1.2	Voltage (V):	P P P	ф <u> </u>
H.3.1.3	Cadence; time (s) and voltage (V):		6 _
H.3.1.4	Single fault current (mA)::	A P P	9 _
H.3.2	Tripping device and monitoring voltage	6 6 6	N/A
H.3.2.1	Conditions for use of a tripping device or a monitoring voltage	TO CAD CAD CA	N/A
H.3.2.2	Tripping device	P P P	N/A
H.3.2.3	Monitoring voltage (V):	2000	N/A
J	INSULATED WINDING WIRES FOR USE WITHOUT INSULATION	INTERLEAVED	P
J.1 🔷	General	.0 .0 .0 .	♦ ♦ P
C 6	Winding wire insulation:	1 67 67 6	





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T. W	IEC 62368-1	KY KY KY KY	4 A
Clause	Requirement + Test	Result - Remark	Verdict
CA	Solid square and rectangular (flatwise bending) winding wire, cross-sectional area (mm²):		N/A
J.2/J.3	Tests and Manufacturing	(See separate test report)	5°-5
K	SAFETY INTERLOCKS		N/A
K.1	General requirements	2, 2, 2, 2, 2, 1	N/A
. 45	Instructional safeguard:	4 4 4 4	N/A
K.2	Components of safety interlock safeguard mech	anism	N/A
K.3	Inadvertent change of operating mode	0.0.0.0	N/A
K.4	Interlock safeguard override		N/A
K.5	Fail-safe	P P P P	N/A
K.5.1	Under single fault condition		N/A
K.6	Mechanically operated safety interlocks	P P P P	N/A
K.6.1	Endurance requirement	0, 0, 0, 0, 0	N/A
K.6.2	Test method and compliance:	P P P P	N/A
K.7	Interlock circuit isolation	2, 0, 0, 0, 0	N/A
K.7.1	Separation distance for contact gaps & interlock circuit elements	car car car car	N/A
C. C. C.	In circuit connected to mains, separation distance for contact gaps (mm):	The Land Land	N/A
TH	In circuit isolated from mains, separation distance for contact gaps (mm):	CO CO CO CO	N/A
7.4	Electric strength test before and after the test of K.7.2:	4 4 4 4	N/A
K.7.2	Overload test, Current (A):	0, 0, 0, 0, 0	N/A
K.7.3	Endurance test	4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4	N/A
K.7.4	Electric strength test	0,000	N/A
L	DISCONNECT DEVICES		Р
L.1	General requirements		N/A
L.2	Permanently connected equipment	CA CA CA CA	N/A
L.3	Parts that remain energized	A A A A	N/A
L.4	Single-phase equipment	S. 22 . 24 . 24 .	N/A
L.5	Three-phase equipment	40 40 40 40	N/A
L.6	Switches as disconnect devices	5 65 65 65 C	N/A
L.7 🔥	Plugs as disconnect devices	0 0 0 0	⊘ P
L.8	Multiple power sources		N/A
40	Instructional safeguard:	40 40 40 40	N/A



M.4.4.6

M.5

M.5.1

M.5.2

M.6.1

M.6.2

M.6

Compliance

Requirement

Compliance

Test method and compliance

External and internal faults

Safeguards against short-circuits

N/A

N/A

N/A

N/A

N/A

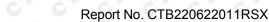
N/A

N/A

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4.10	IEC 62368-1	LA LA LA LA	C 19
Clause	Requirement + Test	Result - Remark	Verdict
M	EQUIPMENT CONTAINING BATTERIES AND THE	EIR PROTECTION CIRCUITS	N/A
M.1	General requirements	.0 .0 .0 .0	N/A
M.2	Safety of batteries and their cells	5 65 65 65	N/A
M.2.1	Batteries and their cells comply with relevant IEC standards:	No battery used.	N/A
М.3	Protection circuits for batteries provided within the equipment	SH SH SH SH	N/A
M.3.1	Requirements	A A A A	N/A
M.3.2	Test method	CA CA CA CA	N/A
0 430	Overcharging of a rechargeable battery	D D D D	N/A
15	Excessive discharging	5 55 55 55 55 55 55 55 55 55 55 55 55 5	N/A
4.40	Unintentional charging of a non-rechargeable battery	A A A A A	N/A
0	Reverse charging of a rechargeable battery		N/A
M.3.3	Compliance	(See appended table M.3)	N/A
M.4	Additional safeguards for equipment containing battery	a portable secondary lithium	N/A
M.4.1	General	0,0,0,0	N/A
M.4.2	Charging safeguards	CA CA CA CA	N/A
M.4.2.1	Requirements		N/A
M.4.2.2	Compliance:	(See appended table M.4.2)	N/A
M.4.3	Fire enclosure:	A A A A	N/A
M.4.4	Drop test of equipment containing a secondary lithium battery		N/A
M.4.4.2	Preparation and procedure for the drop test	CB CB CB CB	N/A
M.4.4.3	Drop, Voltage on reference and dropped batteries (V); voltage difference during 24 h period (%)::	4 4 4 4	N/A
M.4.4.4	Check of the charge/discharge function	7 67 67 67 6	N/A
M.4.4.5	Charge / discharge cycle test	P P P P	N/A
. A 7	AT AT AT AT AT AT AT		V

Risk of burn due to short-circuit during carrying

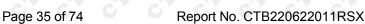
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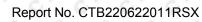
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Clause	Requirement + Test Result - Remark	Verdict
*		Verdici
M.7	Risk of explosion from lead acid and NiCd batteries	N/A
M.7.1	Ventilation preventing explosive gas concentration	N/A
C, A	Calculated hydrogen generation rate:	N/A
M.7.2	Test method and compliance	N/A
0	Minimum air flow rate, Q (m³/h):	N/A
M.7.3	Ventilation tests	N/A
M.7.3.1	General	N/A
M.7.3.2	Ventilation test – alternative 1	N/A
0 . (Hydrogen gas concentration (%):	N/A
M.7.3.3	Ventilation test – alternative 2	N/A
0 1	Obtained hydrogen generation rate:	N/A
M.7.3.4	Ventilation test – alternative 3	N/A
	Hydrogen gas concentration (%):	N/A
M.7.4	Marking:	N/A
M.8	Protection against internal ignition from external spark sources of batteries with aqueous electrolyte	N/A
M.8.1	General	N/A
M.8.2	Test method	N/A
M.8.2.1	General	N/A
M.8.2.2	Estimation of hypothetical volume V _Z (m³/s):	4 —
M.8.2.3	Correction factors:	_
M.8.2.4	Calculation of distance d (mm):	<i></i>
M.9	Preventing electrolyte spillage	N/A
M.9.1	Protection from electrolyte spillage	N/A
M.9.2	Tray for preventing electrolyte spillage	N/A
M.10	Instructions to prevent reasonably foreseeable misuse	N/A
25	Instructional safeguard:	N/A
N	ELECTROCHEMICAL POTENTIALS	N/A
63	Material(s) used:	§ _
0	MEASUREMENT OF CREEPAGE DISTANCES AND CLEARANCES	- ⊘ P
c'	Value of <i>X</i> (mm):	
P	SAFEGUARDS AGAINST CONDUCTIVE OBJECTS	. ∜ P
P.1	General C C C C C	Р
P.2	Safeguards against entry or consequences of entry of a foreign object	P





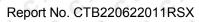
5	IEC 62368-1	4 4 4 A	5, 4
Clause	Requirement + Test	Result - Remark	Verdic
P.2.1	General	7 67 67 67 C	Р
P.2.2	Safeguards against entry of a foreign object	No openings	ΦP
6	Location and Dimensions (mm):		ў —
P.2.3	Safeguards against the consequences of entry of a foreign object	ER CLE CLE CLE	N/A
P.2.3.1	Safeguard requirements	0.0.0.0	N/A
C. C.	The ES3 and PS3 keep-out volume in Figure P.3 not applicable to transportable equipment		N/A
C.F.	Transportable equipment with metalized plastic parts:		N/A
P.2.3.2	Consequence of entry test:	CA CA CA CA	N/A
P.3	Safeguards against spillage of internal liquids	0.0.0.0	N/A
P.3.1	General	12 12 12 12	N/A
P.3.2	Determination of spillage consequences		N/A
P.3.3	Spillage safeguards	CA CA CA CA	N/A
P.3.4	Compliance		N/A
P.4	Metallized coatings and adhesives securing part	s	N/A
P.4.1	General	4 4 4 4	N/A
P.4.2	Tests	S. C. C. C. C.	N/A
0	Conditioning, T _C (°C):	0.0.0.0	_
0	Duration (weeks):		<i>5</i> —
Q	CIRCUITS INTENDED FOR INTERCONNECTION	WITH BUILDING WIRING	. ◆ P
Q.1	Limited power sources		Р
Q.1.1	Requirements	P P P P	P
6	a) Inherently limited output	0, 0, 0, 0, 0	N/A
4	b) Impedance limited output	CO CO CO CO	N/A
0	c) Regulating network limited output	0,0,0,0	P
17.70	d) Overcurrent protective device limited output	1 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4	N/A
	e) IC current limiter complying with G.9		N/A
Q.1.2	Test method and compliance:	(See appended table Q.1)	Р
, P	Current rating of overcurrent protective device (A)	CP KP KP KP	N/A
Q.2	Test for external circuits – paired conductor cable		N/A
0	Maximum output current (A):	2 6 6 6	N/A
. 45	Current limiting method:	& & & & &	





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Clause	Requirement + Test Result - Remark	Verdict				
-						
R	LIMITED SHORT CIRCUIT TEST	N/A				
R.1	General	N/A				
R.2	Test setup	N/A				
7 A 80	Overcurrent protective device for test:	~ V				
R.3	Test method	N/A				
7 60	Cord/cable used for test:	7				
R.4	Compliance	N/A				
S	TESTS FOR RESISTANCE TO HEAT AND FIRE	N/A				
S.1	Flammability test for fire enclosures and fire barrier materials of equipment where the steady state power does not exceed 4 000 W					
	Samples, material:	5° 6 _				
A Lab	Wall thickness (mm):	7 - P				
0	Conditioning (°C):	- C _				
CLA	Test flame according to IEC 60695-11-5 with conditions as set out	N/A				
O CO	- Material not consumed completely	N/A				
0	- Material extinguishes within 30s	N/A				
N. B.	- No burning of layer or wrapping tissue	N/A				
S.2	Flammability test for fire enclosure and fire barrier integrity	N/A				
4 10	Samples, material:	4 -				
0	Wall thickness (mm):					
4	Conditioning (°C):	15 × 15 -				
S.3	Flammability test for the bottom of a fire enclosure	N/A				
S.3.1	Mounting of samples	N/A				
S.3.2	Test method and compliance	N/A				
6	Mounting of samples:	- 15 P				
0.0	Wall thickness (mm):	.0 -				
S.4	Flammability classification of materials	N/A				
S.5	Flammability test for fire enclosure materials of equipment with a steady state power exceeding 4 000 W	N/A				
" A P	Samples, material:	5 - I				
, 45-	Wall thickness (mm):					
4	Conditioning (°C):	5 A _				





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Clause	Requirement + Test	Result - Remark	Verdict			
Т	MECHANICAL STRENGTH TESTS		Р			
T.1	General	0.00.00	◆ P			
T.2	Steady force test, 10 N:	(See appended table T.2)	P			
T.3	Steady force test, 30 N:	(See appended table T.3)	N/A			
T.4	Steady force test, 100 N:	(See appended table T.4)	P			
T.5	Steady force test, 250 N:	(See appended table T.5)	N/A			
T.6	Enclosure impact test	(See appended table T.6)	N/A			
N. B	Fall test	CA CA CA CA	N/A			
0	Swing test		N/A			
T.7	Drop test:	(See appended table T.7)	P			
T.8	Stress relief test:	(See appended table T.8)	Р			
T.9	Glass Impact Test:	(See appended table T.9)	N/A			
T.10	Glass fragmentation test					
C. Y	Number of particles counted:	7 67 67 67	N/A			
T.11	Test for telescoping or rod antennas					
C	Torque value (Nm):		N/A			
U	MECHANICAL STRENGTH OF CATHODE RAY TU PROTECTION AGAINST THE EFFECTS OF IMPLO		N/A			
U.1 🔷	General	P. P. P. P.	N/A			
C.	Instructional safeguard :		N/A			
U.2	Test method and compliance for non-intrinsically	protected CRTs	N/A			
U.3	Protective screen	0,0,0,0	N/A			
V	DETERMINATION OF ACCESSIBLE PARTS		P			
V.1	Accessible parts of equipment		Р			
V.1.1	General	CA CA CA CA	Р			
V.1.2	Surfaces and openings tested with jointed test probes	A A A A A	N/A			
V.1.3	Openings tested with straight unjointed test probes	0,0,0,0	P			
V.1.4	Plugs, jacks, connectors tested with blunt probe	CB CB CB CB	P			
V.1.5	Slot openings tested with wedge probe	0.0.0.0	N/A			
V.1.6	Terminals tested with rigid test wire	2 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4	Р			
V.2	Accessible part criterion		P			



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	K
V	

Clause	Requirement + Test	Result - Remark	Verdict
X	ALTERNATIVE METHOD FOR DETERMINING CLE IN CIRCUITS CONNECTED TO AN AC MAINS NOT (300 V RMS)		N/A
0' (Clearance	(See appended table X)	N/A
Υ	CONSTRUCTION REQUIREMENTS FOR OUTDOO	R ENCLOSURES	N/A
Y.1	General		N/A
Y.2	Resistance to UV radiation	10 10 10 10 10	N/A
Y.3	Resistance to corrosion		N/A
Y.3	Resistance to corrosion	CA CA CA CA	N/A
Y.3.1	Metallic parts of outdoor enclosures are resistant to effects of water-borne contaminants by:	A 14 14 14 1	N/A
Y.3.2	Test apparatus	0,0,0	N/A
Y.3.3	Water – saturated sulphur dioxide atmosphere	CA CA CA CA	N/A
Y.3.4	Test procedure	0 0 0 0	N/A
Y.3.5	Compliance	CA CA CA CA	N/A
Y.4	Gaskets	A A A A	N/A
Y.4.1	General	CA CLACLA CLACK	N/A
Y.4.2	Gasket tests	5 5 5 5	N/A
Y.4.3	Tensile strength and elongation tests	2, 22, 22, 22, 3	N/A
. 40	Alternative test methods	4 4 4 4	N/A
Y.4.4	Compression test	7 67 67 67 6	N/A
Y.4.5	Oil resistance	0 0 0 0	N/A
Y.4.6	Securing means	(See Annex P.4)	N/A
Y.5	Protection of equipment within an outdoor enclos	ure & &	N/A
Y.5.1	General	0 0 0 0	N/A
Y.5.2	Protection from moisture	A 4 4 4	N/A
0'	Relevant tests of IEC 60529 or Y.5.3:	, c, c, c, c	N/A
Y.5.3	Water spray test	C 4 C 4 C 4 C 4	N/A
Y.5.4	Protection from plants and vermin	0,0,0,0	N/A
Y.5.5	Protection from excessive dust	VA VA VA VA	N/A
Y.5.5.1	General		N/A
Y.5.5.2	IP5X equipment	CA CA CA CA	N/A
Y.5.5.3	IP6X equipment		N/A
Y.6	Mechanical strength of enclosures	CA CA CA CA	N/A
Y.6.1	General		N/A



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1 1 1 P	CA CA CA CAE	C 62368-1	A LA L
Clause	Requirement + Test	Result - Remark	Verdict
Y.6.2	Impact test	: (See Table T.6)	N/A



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IEC 62368-1							
Clause	Requirement + Test	0.0.0	Result - Remark	Verdict			

5.2	TABLE: Classification of electrical energy sources							
Supply	Location (e.g.	Test conditions		I	Parameters		ES	
Voltage	circuit designation)		U (V)	I (mA)	Type ¹⁾	Additional Info ²⁾	- Class	
5Vdc	Input	Normal:	5Vdc	5 0	SS	DC	ES1	
C'TY C	C. C. C. C. C.	Abnormal: (See B.3 & B.4)	5Vdc	- 0.2	SS	DC	ES1	

Supplementary information:

- 1) Type: Steady state (SS), Capacitance (CP), Single pulse (SP), Repetitive pulses (RP), etc.
- 2) Additional Info: Frequency, Pulse duration, Pulse off time, Capacitance value, etc.

5.4.1.8	TABLE: Working volta	N/A			
Location		RMS voltage (V)	Peak voltage (V)	Frequency (Hz)	Comments
0	0, 0, 0, 0	0 0	0 0	0 0	0 0 0
0 50	4 4 4 A 4 A	A CA	9 50 5	9 59 5	0 40 40 A
Suppleme	ntary information:				
N. C. A.	A A A A	4	4 4	4 4	4 4 4

5.4.1.10.2	.10.2 TABLE: Vicat softening temperature of thermoplastics							45	N/A			
Method	Vethod						: ISO 306 / B50					
Object/ Par	rt No./Materia	al	Man	ufacture	er/trader	nark	Thic	kness (r	mm)	Tso	ftening	(°C)
8 .	.0 .0	. 4	- 4	> .<	, ,4	2	. 4	5 - A	5 .4	, 4	b - 4	b .
6	ري -ري	3	5	C.)-	- 63	6	6	C.	67	6	6	6
Supplemen	ntary informat	ion:										
67 6	C C	67	C	C'Y	CY	C	67	67	C	C, A	Cy	67

5.4.1.10.3 TABLE: Ball pressure test of thermoplastics								
Allowed impression dian	m P	_						
Object/Part No./Material	Manufacturer/trademark	Thickness (r	nm)	Test temperature (°C)	Impression diameter (n			
-0'0'0'	0'-0' 0' 0'	0 -0	7	c' E' c	0	7 67		
P	9 4 4 A	P- 2	B	P P	B	- P		
Supplementary informati	on:							
0 0 0 0	A P A A	0 0	9	9 9	. 49	4		

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IEC 62368-1							
Clause	Requirement + Test	0.0.0	Result - Remark	Verdict			

5.4.2, 5.4.3	TABLE: N	/linimum Cl	earances	/Creepag	e distance				N/A
Clearance (c creepage dis (cr) at/of/betv	tance	U _p (V)	U _{rms} (V)	Freq 1) (Hz)	Required cl (mm)	cl (mm)	E.S. ²⁾ (V)	Required cr (mm)	cr (mm)
Basic/supple	mentary:	30 430	A.	A .	h	200	A A	. 4	S 4
65	2 62	5	4 6	65	64.0	2, 2	5	5	5 65
8 · 40	4	9	40	0 4	5 45	45	80 4	9 49	40 4
Reinforced in	sulation:	000	5 0		C C	5 5	C.S.	c C	7 6
8 .0	0	4. 6	. 40	0 4	9 .0	0	0 .4	. 4	.0
	7 67	0		0	c c	7 6	C	0 0	2
Cumplemente	m , informa	tion.	_			_	_		

Supplementary information:

- 1) Only for frequency above 30 kHz
- 2) Complete Electric Strength voltage (E.S. (V) when 5.4.2.4 applied)

BI: Basic insulation, SI: supplementary insulation, RI: Reinforced insulation.

5.4.4.2	TABLE: Minimun	N/A				
Distance through insulation (DTI) at/of		Peak voltage (V) Insulation		Required DTI (mm)	Measured DTI (mm)	
0	0 0 0	0 0 0	0 0 0	0 0	0 0	
D 10	LA LA L	40 40 40	40 40 4	45.4	1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1	
Suppleme	ntary information:					
N. W. A.	4, 4, 4	LA LA LA	CA CA C	Y KY K	V 4 4	

5.4.4.9 TABLE: Solid insulation at frequencies >30 kHz							
Insulation material	E _P Frequency (kHz)		K R	Thickness d (mm)	Insulation	V _{PW} (Vpk)	
_0 0 0 0	20		0 _ 0	0_ 0	, <u>.</u>	0_0	
Supplementary information:							
		y . U .	0 0			0 0	

5.4.9	TABLE: Electric strength tests	4 4 4	40 40 4	80 .	N/A
Test voltag	e applied between:	Voltage shape (Surge, Impulse, AC, DC, etc.)	Test voltage (V)		kdown s / No

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		1 age 12 01 1	repetrite: 0122	
		IEC 62368-1		
Clause	Requirement + Test	0 0 0	Result - Remark	Verdict
2 2 4	44 44 44 4A	4 4 4 4 4 W	24 24 24 24	1 1 N
Basic/sup	olementary			
N. P. W.	4 4 4 4 4 4 A	LA LA LA	Charles Charles	77 7
Reinforce	d:			0 0
6.5	The Carlot of the	CAY CAY	CAY CAY CAY CA	65 65
b 45	40 40 40 40	40 40 40	40 40 40 4	9 9
Suppleme	ntary information:			
6.4	.0 .0 .0 .0	.0 .0 .0	.0 .0 .0 .9	. 4

5.5.2.2	TABLE:	Stored dischar	rge c	n capa	citors	N. P.					6	N/A
Location		Supply voltage	(V)		ting ar	nd fault n ¹⁾	Swit posit		Measu voltag (Vpk	ge	ES	Class
5 0	45	0 6 /	6	45	700	40	45	40	45	41	_	5
Suppleme	ntary inform	mation:										
10 10		d for testing:	9	A.	P	A. B	B	A	P	4		9
[] ICX:	ing resistor	rating:										

1) Normal operating condition (e.g., normal operation, or open fuse), SC= short circuit, OC= open circuit

5.6.6	TABL	E: Re	sistan	ance of protective conductors and terminations								4	B . V.	N/A
Location		Test current (A)		Г	Duration (min)		Voltage drop (V)		р	Resistance (Ω)				
-0"	0' 6	,	0	0	0'-	6	0,	0	C	0	- 6	5	6'-	- 0'
Supplemen	ntary info	rmati	on:											
0' (0' (7	0	C'	C.	0	C.	0	C	. 0	. 6	5	0	0

5.7.4	TABLE	E: Unearthed accessible parts							
Location		Operating and	Supply	F		ES			
		fault conditions	Voltage (V)	Voltage (V _{rms} or V _{pk})	Current (A _{rms} or A _{pk})	Freq. (Hz)	class		
0, 0	, C	0,0	0, 0,	0, 0,	0, 0,	0, 0	. 0		
	P	C 4 7 6 7	1 A 1 A	A B CB	4 4 A	NB A	PA		
	C	0 0	0.0	0 0	0,0	0, 0	0		

Supplementary information:

Abbreviation: SC= short circuit; OC= open circuit

See table 5.2 for details.

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D CD	LA LA LA LA	IEC 62368-1	B KB K
Clause	Requirement + Test	Result - Remark	Verdict

5.7.5	TABLE: Earthed access	sible conductive part			N/A
Supply vo	tage (V):	0 0 0 0	, 0 0	0.0	_
Phase(s)	<u> </u>	[] Single Phase; [] Three	Phase: [] Delta	[] Wye	
Power Dis	tribution System:	[] TN []TT []IT	A A	A A	
Location		Fault Condition No in IEC 60990 clause 6.2.2	Touch current (mA)	Comme	ent
2 50	KB KB KB K	V. D. V. D. V. D.	CA TA	TO A TO	C. As
Suppleme	ntary Information:				

5.8	TABLE: Backfeed safeguard in battery backed up supplies							
Location		Supply voltage (V)	Operating and fault condition	Time (s)	Open-circuit voltage (V)	Touch current (A)	ES Class	
-c" c	7 67	- 6	7° 67 67	6 - 6	6 <u>2</u> 6	9	ري ري	
Supplemen	tary inforr	nation:						
Abbreviation	n: SC= sh	ort circuit, O	C= open circuit	C, C,	0,0	C	c' c'	

6.2.2 T.	ABLE: Power source	circuit classificat	tions			P
Location	Operating and fault condition	Voltage (V)	Current (A)	Max. Power ¹⁾ (W)	Time (S)	PS class
Input circuit	Normal	5VDC	c" - c"	C ² C	5	PS3 (declared)
N. A. Y.	Normal	A VA VA	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	b Ja	V. D V. D.	40 4
\$ C _ C	Single fault: see table B.4 for details	\$ \$\$ \$\$	~ P	\$ _ \$	\$ \$ P	~ [©] ~

Supplementary information:

Abbreviation: SC= short circuit; OC= open circuit

1) Measured after 3 s for PS1 and measured after 5 s for PS2 and PS3.

6.2.3.1	TAB	LE: Det	ermin	ation of	Arcing	PIS	0,	0	0	0	C'	0	N/	Α
Location				Open cir after 3	cuit volta 3 s (Vpk)		Measure curren		Calc	ulated v	/alue		cing F 'es / N	
0 0	4	4	4	.0	4	×4	b P	4	P	- \$. 19	- 4	4	24
Suppleme	ntary in	formatio	n:											
0 0	4	4	4	4	4		9 9	4	4	P	4		.0	24

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D CD	LO LO LO LO L	IEC 62368-1	TO A TO A
Clause	Requirement + Test	Result - Remark	Verdict

6.2.3.2 T	ABLE: Determination of resistive PIS	VA VA VA VA	P
Location	Operating and fault condition	Dissipate power (W)	Arcing PIS? Yes / No
All internal circuits/compo	onents		Yes (declared)
Supplementar	y information:		
Abbreviation:	SC= short circuit; OC= open circuit	0.0.0.0	.0

8.5.5	TABLE: High pi	ressure lamp			N/A						
Lamp manu	ıfacturer	Lamp type	Explosion method	Longest axis of glass particle (mm)	Particle found beyond 1 m Yes / No						
	A A	4 0 0	0 0 0		b						
Supplemen	Supplementary information:										
h	40 A0	0 0 0	0, 0, 0,	D D	0. 0.						

9.6 TAB	LE: Tempera	ture meas	urements	for wireles	ss power t	ransmitter	s	N/A
Supply voltage (V)				6	c c	1 62	6	_
Max. transmit pov	ver of transm	itter (W)	:	0 0	4	P P	7.0	_
				eiver and contact		ver and at of 2 mm		iver and at e of 5 mm
Foreign objects	Object (°C)	Ambient (°C)	Object (°C)	Ambient (°C)	Object (°C)	Ambient (°C)	Object (°C)	Ambient (°C)
- 4 4 4 Y	AY AY	4-V	5 Y 5	- A	W. T.	-47	A-V	6 Y 6
Supplementary in	formation:							



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P CP	AB AB AB AB	IEC 62368-1	CA CA CA CA	18 K
Clause	Requirement + Test	0.0.0	Result - Remark	Verdict

5.4.1.4,	TABLE: Tempe	rature me	asurem	ents				Р
9.3, B.1.5, B.2.6								
Supply volta	age (V)	4.2V DC (Battery dischargi ng)	\$ C \$ \$	5V DC	\$ \$ \$ \$	_		
Ambient ter	mperature during	test T _{amb} (°	C) :	25.0	G.	25.0	G.	_
Maximum n	neasured temper	ature <i>T</i> of p	art/at:		<i>T</i> (°	°C)		Allowed T _{max} (°C)
At room am	bient temperatur	e shift to Tr	na:	25.0	P - P	25.0	P P	, +
PCB near input port				37.2	G-7	44.1	G.	130
PCB near U1			60.6	P - P	67.3	P P	130	
PCB near Q1			54.5	<u>C-</u>	57.2	C.	130	
PCB near D	01	PAP	4	50.7	P TP	51.3	P - P	130
Battery		0.	0	32.0	<u>G</u> .	33.2	G.	45
Internal wire	e V	D CD	4.10	37.3	A TA	42.6	4 -4	80
Enclosure i	nside top	4 0	0	36.6	<u> </u>	39.0	<u> </u>	120
Enclosure i	nside bottom	A CA	11/2	36.3	A TA	38.8	4	120
Enclosure o	outside top	A A	0	27.5	<u></u>	30.0	<u></u>	48
Enclosure o	outside bottom	, 55 V	1	27.3	- A	29.8	Y 24	48
Key	40 40	40 40	do o	27.1	40 - 40	27.3	o - o	48
Temperatur	re T of winding:	t ₁ (°C)	R ₁ (Ω	2) t ₂ (°C)	$R_2(\Omega)$	T (°C)	Allowed T _{max} (°C)	Insulation class
- 57	4 4 A	- CA	SY	- A		47- 4	4	4 - A
Supplemen	tary information:							

B.2.5	Ţ	ABLE: Inp	ut test	4.4	TO THE	B VB	40	P				
U (V)	Hz	I (A)	I rated (A)	P (W)	P rated (W)	Fuse No	I fuse (A)	Condition/status				
5	DC	0.097	1.1	0.485	C. C.	Sch	c√5 ²² c′	Normal condition				
Supple	Supplementary information:											
0	0	0	0 0	0 0	0.0	0	0,0	0.0				

B.3, B.4	TABLE: Abnormal operating and fault condition tests	P
,	in in the state of	

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D 60	LA LA LA LA	IEC 62368-1	CB CB C
Clause	Requirement + Test	Result - Remark	Verdict

Ambient temper	ature T _{amb} (°C)				: 25°C if n	ot specified —
Power source fo	or EUT: Manufact	urer, mode	el/type, ou	tputrating	: 57 25	Y 5 Y 5 Y
Component No.	Condition	Supply voltage (V)	Test time	Fuse no.	Fuse current (A)	Observation
Battery	Overcharging	5VDC	7hr	\$ CK\$	0.097	EUT normal working. no hazards, Measured maximum temperature: Battery: 33.3°C; Enclosure outside top: 30.1°C; Enclosure outside bottom: 30.0°C; Key: 27.4°C; Ambient: 25.0°C
Battery	Over discharging	4.2VDC	7hr	0 CT P	0.061	EUT normal working. no hazards, Measured maximum temperature: Battery: 32.1°C; Enclosure outside top: 27.6°C; Enclosure outside bottom: 27.4°C; Key: 27.2°C; Ambient: 25.0°C
U1 Pin (1-4)	SC	5VDC	30min	C. C	0.026	Unit shut down immediately, recoverable, no damage, no hazard.
U1 Pin (8-4)	SC	5VDC	30min	C. C. C.	0.026	Unit shut down immediately, recoverable, no damage, no hazard.
U1 Pin (1-8)	SC	5VDC	30min	C. F. D	0.026	Unit shut down immediately, recoverable, no damage, no hazard.
R1	SC	5VDC	30min	CT.B	0.026	Unit shut down immediately, recoverable, no damage, no hazard.
Q1 Pin (G-S)	SC	5VDC	30min	C. C. C. C.	0.026	Unit shut down immediately, recoverable, no damage, no hazard.
Q1 Pin (G-D)	SC	5VDC	30min	C. C	0.026	Unit shut down immediately, recoverable, no damage, no hazard.
Q1 Pin (D-S)	SC	5VDC	30min	V	0.026	Unit shut down immediately,

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D 60	CA CA CA CA CA	IEC 62368-1	1 6 P
Clause	Requirement + Test	Result - Remark	Verdict

4 4 4	8 .0	0	9 4	. 40	recoverable, no damage, no hazard.
SC	5VDC	30min	\$ C	0.026	Unit shut down immediately, recoverable, no damage, no hazard.
SC	5VDC	30min	4 .4	0.026	Unit shut down immediately, recoverable, no damage, no hazard.
ary information:	Y AV		Y AN		Ilazaiu.
	SC	SC 5VDC	SC 5VDC 30min	SC 5VDC 30min	SC 5VDC 30min 0.026

M.3	TABLE: Pr	otection circu	tection circuits for batteries provided within the equipment							
Is it possib	le to install the	battery in a re	verse polarity p	osition?:	C C	No O	¢ _			
				Chargi	ng					
Equipment Specification		Voltage (V)				Current (A)				
			4.2	40 4	A 4.0	0.23	1 N			
		Battery specification								
		Non-recharge	eable batteries	Rechargeable batteries						
		Discharging	Unintentional	Charging		Discharging	Reverse			
Manufa	Manufacturer/type current		charging current (A)	Voltage (V)	Current (A)	current (A)	charging current (A)			
501530	A 4	· · · · · · · · · · · · · · · · · · ·	A- A	4.2	0.058	0.061	· +			
Note: The t	tests of M.3.2 a	re applicable o	nly when above	e appropriate o	lata is not ava	ailable.				
Specified b	pattery tempera	ture (°C)		:	4, 6	45				

Component Fault Charge/ Test Temp. Current Voltage Observation condition discharge mode time No. (°C) (A) (V) U1 pin 1-4 SC 7 h 33.3 0.488 4.2 Charge No hazards U1 pin 1-8 SC 7 h 4.2 discharge 32.1 0.491 No hazards

Supplementary information:

Abbreviation: SC= short circuit; OC= open circuit NL= no chemical leakage; NS= no spillage of liquid; NE= no explosion; NF= no emission of flame or expulsion of molten metal.

M.4.2	TABLE: Charging safeguards for equipment containing a secondary lithium	P
A .	battery	

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No cracking. All

safeguards remain effective No cracking. All

safeguards

remain effective

D CD	AB AB AB AB	IEC 62368-1	AP AP A
Clause	Requirement + Test	Result - Remark	Verdict

Maximum specified charging voltage (V)	4.2	_
Maximum specified charging current (A)	0.23	_
Highest specified charging temperature (°C):	45	
Lowest specified charging temperature (°C)	0	

Battery	Operating		Measurement		Observation
manufacturer/type	and fault condition	Charging voltage (V)	Charging current (A)	Temp. (°C)	
501530	SC	4.2	0.001	>45	Stop charging, No hazards
501530	SC	4.2	0.001	<0	Stop charging, No hazards

Supplementary information:

Abbreviation: SC= short circuit; OC= open circuit; MSCV= maximum specified charging voltage; MSCC= maximum specified charging current; HSCT= highest specified charging temperature; LSCT= lowest specified charging temperature

Q.1	TABLE: Circuits inter	nded for inte	rconnection	with build	ding wiring	(LPS)	Р
Output	Condition	11 (\(\Lambda \)	Time (a)	I _{sc}	(A)	S (VA)
Circuit	Condition	U _{oc} (V)	Time (s)	Meas.	Limit	Meas.	Limit
Battery	Normal	4.2	60	3.32	8	13.164	100
Battery	Single fault: see table B.4 for details	4.2	60	5.11	8	20.382	100
Supplemen	ntary Information:						
*stand for o	output shutdown.	P. P.	4 A	P 49	A 6	9 4	A 40 A

T.2, T.3, T.4, T.5	ΓABLE: Ste	eady force test	CTO CT	CT B	SP S	P CTP	S P
Location/Part		Material	Thickness (mm)	Probe	Force (N)	Test Duration (s)	Observation
Internal components	D CAD	Charles Charles	50-55	C C C	10	5	No damage, No hazard
Top enclosure	C S C	Plastic	1)	CF C	100	5	No cracking. All safeguards remain effective

100

100

1)

1)

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Plastic

Plastic

Shenzhen, Guangdong, China

Side enclosure

Bottom enclosure

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P CP	AB AB AB AB	IEC 62368-1	CP CP C
Clause	Requirement + Test	Result - Remark	Verdict

Supplementary information: 1) See table 4.1.2

T.6, T.9	TABLE: Imp	act test	V . V.	4, 4	N/A
Location/P	art	Material	Thickness (mm)	Height (mm)	Observation
0 (0 0	0 0 0 0
4 4	40 40	40 40 40	A VA	40 4	40 40 40
			A A	A A	
Suppleme	ntary information	n:			
1) See tab	le 4.1.2	A A A	A A	A A	h A A A

T.7 TABLE: Drop	o test			, ⊗ ⊗ ⊗P
Location/Part	Material	Thickness (mm)	Height (mm)	Observation
Top enclosure	Plastic	1)	1000	No damage, no hazard.
Side enclosure	Plastic	1)	1000	No damage, no hazard.
Bottom enclosure	Plastic	1)	1000	No damage, no hazard.
Supplementary information	1:			
1) See table 4.1.2	· 4. 4. 4. 4. 4. 4. 4. 4. 4. 4. 4. 4. 4.		2. 2.	2, 2, 2,

T.8 TABLE:	Stress relief t	est			o Po
Location/Part	Material	Thickness (mm)	Oven Temperature (°C)	Duration (h)	Observation
Plastic enclosure	Plastic	See table 4.1.2	70	7 7	No hazards
Supplementary inform	nation:				

X	TABL	E: Alte	rnativ	ve meth	od for	determin	ing m	inimum	cleara	nces d	istance	s	N/A
Clearanc between:		ed		Peak of	working (V)	g voltage		Requir (mn				sured c	I
6'7	67 (57 (0,0	C	C-2	C	C'Y	67-	C	C	CY	-67	C
Suppleme	entary info	ormation	า:										
C T	6' (57 (0	C'	C	C'	0	C'	C	C	C.	C'	0

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D CD	AB AB AB AB	IEC 62368-1	AP AP A
Clause	Requirement + Test	Result - Remark	Verdict

Mark(s) of conformity¹ Min.1.5mm thickness, V-0, 120°C UL 796, UL94 UL UL UL UL UL UL UL UL UL U
thickness, V-0, 120°C
V-0 130°C UI 796 UI 94 UI
eable V-0, 130°C UL 796, UL94 UL
3.7Vdc 230mAh IEC 62133-2 Approved
eable 80°C, VW-1, UL 758 UL min. 22AWG, min.300V
е

¹⁾ Provided evidence ensures the agreed level of compliance. See OD-CB2039.



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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION				
Clause	Requirement + Test	Result - Remark	Verdict	

P P	76 76 76 VE	C62368_1E - ATTACHMENT		
Clause	Requirement + Test	C C C Re	esult - Remark	Verdict
(Audi		ACHMENT TO TEST REPOR IEC 62368-1 DIFFERENCES AND NATION unication technology equipme	NAL DIFFERENCES	ments)
Difference	s according to E	N IEC 62368-1:2020+A11:20	20	A 19
Attachme	nt Form No E	U_GD_IEC62368_1E	0,0,0,0	40
Attachme	nt Originator:	L(Demko)		
Master Att	achment 2	021-02-04		
	© 2021 IEC System for Confi eneva, Switzerland. All right		ntion of Electrical Equipm	ent
	CENELEC COMMON MO	DIFICATIONS (EN)		60 - 4
\$ CF \$	IEC 62368-1:2020+A11:2 those in the paragraph be	Its that are shaded light grey a D20. All other clause numbers low, refers to IEC 62368-1:20 es, tables, figures and annexe 8 are prefixed "Z".	s in that column, except for 118.	
4 CT	Add the following annexes Annex ZA (normative) with their co	: Normative references to in prresponding European publica		
	Annex ZB (normative) Annex ZC (informative)	Special national conditions A-deviations		
0 0	Annex ZD (informative) cords	IEC and CENELEC code of	designations for flexible	3 4
1	Modification to Clause 3			
3.3.19	Sound exposure Replace 3.3.19 of IEC 62.	368-1 with the following defini	tions:	N/A

3.3.19.1	momentary exposure level, MEL	Ch Ch Ch Ch Ch	N/A
4 CLA	metric for estimating 1 s sound exposure level from the HD 483-1 S2 test signal applied to both channels, based on EN 50332-1:2013, 4.2.	it city city city	
o o	Note 1 to entry: MEL is measured as A-weighted levels in dB.	A P P P	
C'	Note 2 to entry: See B.3 of EN 50332-3:2017 for additional information.	0'0'0'0	

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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION				
Clause	Requirement + Test	Result - Remark	Verdict	

3.3.19.3	sound exposure, E	N/A
	A-weighted sound pressure (<i>p</i>) squared and integrated over a stated period of time, <i>T</i>	CT TO
	Note 1 to entry: The SI unit is Pa^2 s.	CT (8) CT
	$E = \int_{0}^{\infty} p(t)^{2} dt$	cr to cr
3.3.19.4	sound exposure level, SEL	N/A
	logarithmic measure of sound exposure relative to a reference value, E_0 , typically the 1 kHz threshold of hearing in humans.	ci ^{sto} ci ^s
	Note 1 to entry: SEL is measured as A-weighted levels in dB.	1 to 15
	$SEL = 10 \lg \left(\frac{E}{E_0}\right) dB$	cf. 80 cf
	Note 2 to entry: See B.4 of EN 50332-3:2017 for additional information.	ch of
3.3.19.5	digital signal level relative to full scale, dBFS	N/A
	levels reported in dBFS are always r.m.s. Full scale level, 0 dBFS, is the level of a dc-free 997-Hz sine wave whose undithered positive peak value is positive digital full scale, leaving the code corresponding to negative digital full scale unused	
	Note 1 to entry: It is invalid to use dBFS for non-r.m.s. levels. Because the definition of full scale is based on a sine wave, the level of signals with a crest factor lower than that of a sine wave may exceed 0 dBFS. In particular, square wave signals may reach +3.01 dBFS.	ch to ch
2	Modification to Clause 10	
10.6	Safeguards against acoustic energy sources Replace 10.6 of IEC 62368-1 with the following:	N/A
10.6.1.1	Introduction	N/A
	Safeguard requirements for protection against long- term exposure to excessive sound pressure levels from personal music players closely coupled to the ear are specified below. Requirements for earphones and headphones intended for use with personal music players are also covered. A personal music player is a portable equipment intended for use by an ordinary person, that:	

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Clause	Requirement + Test	Result - Remark	Verdic
		AV AV AV A	9 .9
-0	– is designed to allow the user to listen to audio or		6
		4 4	
	audiovisual content / material; and	2 2 2 2 2 E	V V
	- uses a listening device, such as headphones or		67 6
	earphones that can be worn in or on or		
	around the ears; and	B B B	9
	 has a player that can be body worn (of a size 	J. J. J. J.	200
	suitable to be carried in a clothing pocket) and		0
	is intended for the user to walk around with while in	49 49 49 4	30 40
	continuous use (for example, on a street,		
	in a subway, at an airport, etc.).	0 0 0	0 0
	in a subway, at an anport, etc.).	Do Do Do .	On 40n
	EXAMPLES Portable CD players, MP3 audio players, mobile	KY KY KY K	Y AY
	phones with MP3 type features, PDAs or similar equipment.		CCC
	A A A A A A A	A A A	0- 0-
	Personal music players shall comply with the	CA CA CA C	A 4.A
	requirements of either 10.6.2 or 10.6.3.		ci' c
	NOTE 1 Protection against acoustic energy sources from telecom	4 4 4 A	9 ,49
	applications is referenced to ITU-T P.360.		67 6
	NOTE 2 It is the intention of the Committee to allow the		0
	NOTE 2 It is the intention of the Committee to allow the alternative methods for now, but to only use the dose	0 0 0	8 8
	measurement method as given in 10.6.5 in future. Therefore,	J. J. J. J.	
	manufacturers are encouraged to implement 10.6.5 as soon as		0
	possible.	40 40 40 A	8 49
		V. V. V. V	·
	Listening devices sold separately shall comply with		0 0
	the requirements of 10.6.6.	Do Do Do /	0. 0.
	These requirements are valid for music or video	KY KY KY K	A WA
	mode only.		CCC
	The requirements do not apply to:	A A A	2
	professional equipment;	LA LA LA L	A 12
	professional equipment,		67 6
	NOTE 3 Professional equipment is equipment sold through		
	special sales channels. All products sold through	A P P P	9 , 9
	normal electronics stores are considered not to be professional		- C
	equipment.		0
		0 0 0	3
	 hearing aid equipment and other devices for 		
	assistive listening;		
	- the following type of analogue personal music	45 45 45 4	25 425
	players:	KY KY KY K	4.7
	long distance radio receiver (for example, a		CIC
	multiband radio receiver or world band radio	Do Do Do 1	On Do
		KA KA KA K	V 4 V
	receiver, an AM radio receiver), and		CCC
	cassette player/recorder;	A A A	O- O-
	NOTE 4 This exemption has been allowed because this	YA YA YA Y	A 4 A
	technology is falling out of use and it is expected that		ci' c
	within a few years it will no longer exist. This exemption will not		
	be extended to other technologies.	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	10
		C C C C	67 6
	a player while connected to an external amplifier		
	that does not allow the user to walk around	0 0 0	8
	while in use.	1. 2. 2. 2	- M
			0
	For equipment that is clearly designed or intended	On On On I	Charles Alberta



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Clause	Requirement + Test	Result - Remark	Verdic
Olause	requirement i rest	Tresuit - Tremain	Verdic
5		4, 4, 4, 4	25. 75
	primarily for use by children, the limits of the		0 0
	relevant toy standards may apply.	4 4 4 A	9
			6 6
	The relevant requirements are given in	4 4 4	
	EN 71-1:2011, 4.20 and the related tests methods	Ca Ca Ca C	P (30)
10010	and measurement distances apply. Non-ionizing radiation from radio frequencies in	0'0'0'	0 .0
10.6.1.2	the range 0 to 300 GHz	40 40 40 4	N/A
		4 4 4	
	The amount of non-ionizing radiation is regulated by		0
	European Council Recommendation 1999/519/EC	9 9 9 5	9
	of 12 July 1999 on the limitation of exposure of the	the the the t	al al
	general public to electromagnetic fields (0 Hz to 300		
	GHz).	EN EN EN E	D 4.30 4
	For intentional radiators, ICNIRP guidelines should		C C
	be taken into account for Limiting Exposure to Time-	00 00 00 6	Do 400
	Varying Electric, Magnetic, and Electromagnetic	CA CA CA	V 4 V 4
	Fields (up to 300 GHz). For hand-held and body mounted devices, attention is drawn to EN 50360		0
	and EN 50566.	0 0 0	9
10.6.2	Classification of devices without the capacity to	estimate sound dose	N/A
10.6.2.1	General	(A) (A) (A) (A)	N/A
10.0.2.1	General	4, 4, 4, 4,	IN/A
	9 0 0 0 0 0 0		0
	This standard is transitioning from short-term based	A P P P	9
	(30 s) requirements to long-term based (40 hour) requirements. These clauses remain in effect only		c' c'
	for devices that do not comply with sound dose		h
	estimation as stipulated in EN 50332-3.	VA VA VA V	h Wah 4
	obtilitation as supulated in EIV 55552 5.		0 0
	For classifying the acoustic output $L_{Aeq,T}$,	A A A A	8
	measurements are based on the A-weighted	4, 4, 4, 4	
	equivalent sound pressure level over a 30 s period.		
		19 19 19 1°	9 9
	For music where the average sound pressure (long		6 6
	term $LAeq, T$) measured over the duration of the song is lower than the average produced by the	A	30 (30
	programme simulation noise, measurements may	Ch Ch Ch C	N 4 4
	be done over the duration of the complete song. In		CCC
	this case, <i>T</i> becomes the duration of the song.	A A A A	9 9
	1 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	7 67 67	6 6
	NOTE Classical music, acoustic music and broadcast typically has an average sound pressure (long term $LAeq, \tau$) which is much	An An An A	Sa Sa
	lower than the average programme simulation noise. Therefore, if	YA YA YA Y	A 4 A
	the player is capable to analyse the content and compare it with		CC
	the programme simulation noise, the warning does not need to be given as long as the average sound pressure of the song does	0 0 0 4	8
	not exceed the required limit.	4 4 4 4	4
	For example, if the player is set with the programme simulation	0 0 0	0
	noise to 85 dB, but the average music level of the song is only 65 dB, there is no need to give a warning or ask an	A 4 4 4	0
	acknowledgement as long as the average sound level of the song	J 63 63 64	69 6
	is not above the basic limit of 85 dB. RS1 limits (to be superseded, see 10.6.3.2)	4 4 4	
0.6.2.2	LUNE treate the be erreaseded as 40 C 2 2		N/A

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Oliver Dentity Test			616
Clause	Requirement + Test	Result - Remark	Verdic
CHP CHP CHP	RS1 is a class 1 acoustic energy source that does not exceed the following: — for equipment provided as a package (player with its listening device), and with a proprietary connector between the player and its listening device, or where the combination of player and listening device is known by other means such as setting or automatic detection, the <i>L</i> Aeq, <i>T</i> acoustic output shall be ≤ 85 dB when playing the fixed "programme simulation noise" described in EN 50332-1. — for equipment provided with a standardized connector (for example, a 3,5 phone jack) that allows connection to a listening device for general use, the unweighted r.m.s. output voltage shall be ≤ 27 mV (analogue interface) or -25 dBFS (digital interface) when playing the fixed "programme simulation noise" described in EN 50332-1. — The RS1 limits will be updated for all devices as	AB CAB CAB CAB	
0.6.2.3	per 10.6.3.2. RS2 limits (to be superseded, see 10.6.3.3)	7 67 67 67	N/A
	RS2 is a class 2 acoustic energy source that does not exceed the following: — for equipment provided as a package (player with its listening device), and with a proprietary connector between the player and its listening device, or when the combination of player and listening device is known by other means such as setting or automatic 130 detection, the <i>L</i> Aeq, <i>T</i> acoustic output shall be ≤ 100 dB(A) when playing the fixed "programme simulation noise" as described in EN 50332-1. — for equipment provided with a standardized connector (for example, a 3,5 phone jack) that allows connection to a listening device for general use, the unweighted r.m.s. output voltage shall be ≤ 150 mV (analogue interface) or -10 dBFS (digital interface) when playing the fixed "programme simulation noise" as described in EN 50332-1.	TH CIP CIP CI	
10.6.2.4	RS3 limits RS3 is a class 3 acoustic energy source that exceeds RS2 limits.	A CA CA CA	N/A
0.6.3	Classification of devices (new)	V V V V	N/A
0.6.3.1	General Previous limits (10.6.2) created abundant false negative and false positive PMP sound level	KR CKR CKR CK	N/A

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Clause	Requirement + Test	Result - Remark	Verdict	

	Commission Decision of 23 June 2009, are given	0 0 0
10.6.3.2	below. RS1 limits (new)	NI/A
10.0.5.2	(NOT MINES (NOW)	N/A
	RS1 is a class 1 acoustic energy source that does	0 0
	not exceed the following:	20 20 20
	- for equipment provided as a package (player with	
	its listening device), and with a proprietary	
	connector between the player and its listening	
	device, or where the combination of player and	
	listening device is known by other means such as	
	setting or automatic detection, the L Aeq, T acoustic	67 67 6
	output shall be ≤ 80 dB when playing the fixed	4
	"programme simulation noise" described in EN	
	50332-1.	6 6 6
	- for equipment provided with a standardized	
	connector (for example, a 3,5 phone jack) that	
	allows connection to a listening device for general	0 0 0
	use, the unweighted r.m.s. output voltage shall be ≤	. Di Di
	15 mV (analogue interface) or -30 dBFS (digital	AY AY A
	interface) when playing the fixed "programme simulation noise" described in EN 50332-1.	C C C
10.6.3.3	RS2 limits (new)	9 9
10.6.3.3	N32 mints (new)	N/A
	RS2 is a class 2 acoustic energy source that does	0 0
	not exceed the following:	0 0
	for equipment provided as a package (player with	20 20 X
	its listening device), and with a proprietary	0 0
	connector between the player and its listening	
	device, or where the combination of player and	
	listening device is known by other means such as	
	setting or automatic detection, the weekly sound	
	exposure level, as described in EN 50332-3, shall	
	be ≤ 80 dB when playing the fixed "programme	
	simulation noise" described in EN 50332-1.	
	for equipment provided with a standardized	6 6 6
	connector (for example, a 3,5 phone jack) that	
	allows connection to a listening device for general	
	use, the unweighted r.m.s. output level, integrated	C'C'C
	over one week, as described in EN50332-3, shall be	0 Oc
	≤ 15 mV (analogue interface) or -30 dBFS (digital	
	interface) when playing the fixed "programme	0 0 0
4 4	simulation noise" described in EN 50332-1.	- 4 4
10.6.4	Requirements for maximum sound exposure	N/A
10.6.4.1	Measurement methods	N/A
	AT AT AT AT AT AT AT	CA VA V
	All volume controls shall be turned to maximum	0 0 0
	during tests.	A A
	TA VA VA VA VA VA VA VA VA VA	
	Measurements shall be made in accordance with	0'0'0
40.0.4.5	EN 50332-1 or EN 50332-2 as applicable.	400
10.6.4.2	Protection of persons	N/A

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Clause	Requirement + Test	Result - Remark	Verdict

Except as given below, protection requirements for parts accessible to ordinary persons, instructed persons and skilled persons are given in 4.3.

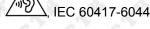
NOTE 1 Volume control is not considered a safeguard.

Between RS2 and an **ordinary person**, the **basic safeguard** may be replaced by an **instructional safeguard** in accordance with Clause F.5, except that the **instructional safeguard** shall be placed on the equipment, or on the packaging, or in the instruction manual.

Alternatively, the **instructional safeguard** may be given through the equipment display during use.

The elements of the **instructional safeguard** shall be as follows:

– element 1a: the symbol \angle (2011-01)



- element 2: "High sound pressure" or equivalent wording
- element 3: "Hearing damage risk" or equivalent wording
- element 4: "Do not listen at high volume levels for long periods." or equivalent wording

An **equipment safeguard** shall prevent exposure of an **ordinary person** to an RS2 source without intentional physical action from the **ordinary person** and shall automatically return to an output level not exceeding what is specified for an RS1 source when the power is switched off.

The equipment shall provide a means to actively inform the user of the increased sound level when the equipment is operated with an output exceeding RS1. Any means used shall be acknowledged by the user before activating a mode of operation which allows for an output exceeding RS1. The acknowledgement does not need to be repeated more than once every 20 h of cumulative listening time.

NOTE 2 Examples of means include visual or audible signals. Action from the user is always needed.

NOTE 3 The 20 h listening time is the accumulative listening time, independent of how often and how long the personal music player has been switched off.

A **skilled person** shall not be unintentionally exposed to RS3.

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Clause	Requirement + Test	Result - Remark	Verdict	

10.6.5	Requirements for dose-based systems	N/A
10.6.5.1	Personal music players shall give the warnings as provided below when tested according to EN 50332-3, using the limits from this clause. The manufacturer may offer optional settings to allow the users to modify when and how they wish to receive the notifications and warnings to promote a better user experience without defeating the	N/A
	a better user experience without defeating the safeguards. This allows the users to be informed in a method that best meets their physical capabilities and device usage needs. If such optional settings are offered, an administrator (for example, parental restrictions, business/educational administrators, etc.) shall be able to lock any optional settings into a specific configuration.	
	The personal music player shall be supplied with easy to understand explanation to the user of the dose management system, the risks involved, and how to use the system safely. The user shall be made aware that other sources may significantly contribute to their sound exposure, for example work, transportation, concerts, clubs, cinema, car races, etc.	CLA CLA CL
10.6.5.2	Dose-based warning and requirements When a dose of 100 % <i>CSD</i> is reached, and at least at every 100 % further increase of <i>CSD</i> , the device shall warn the user and require an acknowledgement. In case the user does not acknowledge, the output level shall automatically decrease to compliance with class RS1.	N/A
B 05 B	The warning shall at least clearly indicate that listening above 100 % <i>CSD</i> leads to the risk of hearing damage or loss.	cro cro cr
10.6.5.3	With only dose-based requirements, cause and effect could be far separated in time, defying the purpose of educating users about safe listening practice. In addition to dose-based requirements, a PMP shall therefore also put a limit to the short-term sound level a user can listen at.	N/A
o ch	The exposure-based limiter (EL) shall automatically reduce the sound level not to exceed 100 dB(A) or 150 mV integrated over the past 180 s, based on methodology defined in EN 50332-3.	Cra Cr

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Clause	Requirement + Test	Result - Remark	Verdic
Clause	requirement i rest	result - Remark	Verdic
3	The EL settling time (time from starting level		6
		A A A	
	reduction to reaching target output) shall be 10 s or	CA CA CA C	9 79 7
	faster.		ci' c
	Test of El fractionality is sanduated according to	2 2 2	
	Test of EL functionality is conducted according to	CA CA CA C	P 4 P .
	EN 50332-3, using the limits from this clause. For		C C
	equipment provided as a package (player with its		
	listening device), the level integrated over 180 s	THE THE THE	D 10
	shall be 100 dB or lower. For equipment provided	A CA CA CA	67 6
	with a standardized connector, the unweighted level		
	integrated over 180 s shall be no more than 150 mV	9 9 9 A	9 9
	for an analogue interface and no more than -10	2 22 22	~ P
	dBFS for a digital interface.		0
		0 0 0	8
	NOTE In case the source is known not to be music (or test	J. 24 24 24	40
	signal), the EL may be disabled.		0 0
10.6.6	Requirements for listening devices (headphones,	earphones, etc.)	N/A
0.6.6.1	Corded listening devices with analogue input	0'0'0'	N/A
	W 04 By 04 By 04 04 04 04 04 04 04 04 04 04 04 04 04	A A A	3
	With 94 dB LAeq acoustic pressure output of the		
	listening device, and with the volume and sound		
	settings in the listening device (for example, built-in	40 40 40 4	20 420
	volume level control, additional sound features like	C. C. C. C.	4
	equalization, etc.) set to the combination of positions	0 0 0	CC
	that maximize the measured acoustic output, the	Q1 Q1 Q1 4	20 420
	input voltage of the listening device when playing the	K, K, K, K	4
	fixed "programme simulation noise" as described in		CC
	EN 50332-1 shall be ≥ 75 mV.	Do Do Do 4	30 430
	C, C, C, C, C, C, C,	KY KY KY K	Y 4 Y
	NOTE The values of 94 dB and 75 mV correspond with 85 dB and	0,0,0,0,	0 0
10.6.6.2	27 mV or 100 dB and 150 mV. Corded listening devices with digital input	\$ \$ \$ \$ \$	N/A
67			IN/A
	With any playing device playing the fixed		
	"programme simulation noise" described in EN	9 9 9 S	9 9
	50332-1, and with the volume and sound settings in		- AT A
	the listening device (for example, built-in volume		
	level control, additional sound features like	9 9 9 1	9
	equalization, etc.) set to the combination of positions		- CY - Z
	that maximize the measured acoustic output, the		
	LAeq, T acoustic output of the listening device shall be	O O O	9 9
	≤ 100 dB with an input signal of -10 dBFS.	1 67 67 67	CT C
0.6.6.3	Cordless listening devices	A A A	N/A
	KA KA KA KA KA KA KA	KA YA YA Y	V V "
	In cordless mode,	0 0 0	0 0
	 with any playing and transmitting device playing 	40 40 40 4	20 400
	the fixed programme simulation noise described in	KY KY KY K	4
	EN 50332-1; and		CC
	 respecting the cordless transmission standards, 	Do Do Do A	3n 43n
	where an air interface standard exists that specifies	KY KY KY K	V AV
			0 0
	the equivalent acoustic level; and – with volume and sound settings in the receiving		CCC

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ause	Re	equirement +	Test		0 0	Result - Rema	ark	Verdid
42	~	S 6	V 4 V 4	V. A. V.	D CD	VB VB	V. A. V. D.	1 A
C.T.B	to me pro ou	the combinate asured acoustication of the contraction of the list	nd features like tion of position ustic output for nulation noise stening device of -10 dBFS.	ns that maxing the above the $L_{Aeq,T}$	mize the mentioned acoustic	Ch Ch	cracra	
.6.6.4	Me	easurements	method shall be made	e in accorda	ance with EN	SP SP	CLB CLB	N/A
		332-2 as app		1				
		pa - pa	o the whole o	pa 1 pa 1			-,	
	De		country" notes	s in the refe	rence docum	ent according	to the following	- <u></u>
	5	0.2.1	Note 1 and 2	1	Note 4 and 5	3.3.8.1	Note 2	.5
								450
	5	3.3.8.3	Note 1	4.1.15	Note	4.7.3	Note 1 and 2	. S. Y.
	K	5.2.2.2	Note	5.4.2.3.2.2 Table 12	Note c	5.4.2.3.2.4	Note 1 and 3	30
	0	5.4.2.3.2.4	Note 2	5.4.2.5	Note 2	5.4.5.1	Note	2 0
	c S	Table 13						5 6
	e.	5.4.10.2.1	Note	5.4.10.2.2	Note	5.4.10.2.3	Note	4
	G Y	5.5.2.1	Note	5.5.6	Note	5.6.4.2.1	Note 2 and 3 and 4	0
	G Y	5.6.8	Note 2	5.7.6	Note	5.7.7.1	Note 1 and Note 2	
	d'	8.5.4.2.3	Note	10.2.1 Table 39	Note 3 and 4 and 5	10.5.3	Note 2	
	9	10.6.1	Note 3	F.3.3.6	Note 3	Y.4.1	Note	2 0
	5	Y.4.5	Note					A V
								40
A Y	Me	odification to	o Clause 1	2 7 2	Y AY	RY RY	AY AY	A 4
Æ9a		id the followi		- Do	On On	100 Do	400 A00	Sec.
	NO		of certain substa			Ly CLY		5 0

E		
อ	Modification to 4.Z1	
	mounication to tie	9



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Clause	Requirement + Test	Result - Remark	Verdict		

4.Z1	Add the following new subclause after 4.9:	0, 0	0	0	Р
	To protect against evacative surrent short sireuite			P	
	To protect against excessive current, short-circuits and earth faults in circuits connected to an a.c.			0	
	mains, protective devices shall be included either			6	
	as integral parts of the equipment or as parts of the				
	building installation, subject to the following, a), b)				
	and c):			8 4	
	a) except as detailed in b) and c), protective			0	
	devices necessary to comply with the requirements of B.3.1 and B.4 shall be included as parts of the			Go.	
	equipment;			4	
	b) for components in series with the mains input to			0	
	the equipment such as the supply cord, appliance			9	
	coupler, r.f.i. filter and switch, short-circuit and			· 6	
	earth fault protection may be provided by			00	
	protective devices in the building installation;			Y 4	
	c) it is permitted for pluggable equipment type B or permanently connected equipment, to rely on			0	
	dedicated overcurrent and short-circuit protection			0	
	in the building installation, provided that the means			- 63	
	of protection, e.g. fuses or circuit breakers, is fully			~	
	specified in the installation instructions.			7 4	
	If reliance is placed an pretention in the building			0	
	If reliance is placed on protection in the building installation, the installation instructions shall so			0	
	state, except that for pluggable equipment type				
	A the building installation shall be regarded as			_	
	providing protection in accordance with the rating			10	
C C	of the wall socket outlet.	c' c	0	0	0
6	Modification to 5.4.2.3.2.4				
5.4.2.3.2.4	Add the following to the end of this subclause:	c c	7	· c	N/A
				Zh	
	The requirement for interconnection with external			Y A	
7	circuit is in addition given in EN 50491-3:2009.	<u>c.'</u> c	<u>. ' </u>	C	<u> </u>
•	Modification to 10.2.1				
10.2.1	Add the following to c) and d) in table 39:			6	N/A
	For additional requirements, see 40.5.4			~	
v _v	For additional requirements, see 10.5.1.	. 10	- NO -		30 .1

8 Modifie	cation to 10.5.1
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Clause	Requirement + Test	Result - Remark	Verdict	

10.5.1	Add the following after the first paragraph:	0 0 0 0	N/A
	For RS 1 compliance is checked by measurement under the following conditions:	Cha Cha Cha	Sec.
	In addition to the normal operating conditions, all controls adjustable from the outside by hand, by any object such as a tool or a coin, and those internal adjustments or pre-sets which are not locked in a reliable manner, are adjusted so as to give maximum radiation whilst maintaining an intelligible picture for 1 h, at the end of which the measurement is made.	A CLA CLA CLA	
	NOTE Z1 Soldered joints and paint lockings are examples of adequate locking.	Ch Ch Ch	ST CE
	The dose-rate is determined by means of a radiation monitor with an effective area of 10 cm ² , at any point 10 cm from the outer surface of the apparatus.	A CLA CLA CLA	A Section
	Moreover, the measurement shall be made under fault conditions causing an increase of the high voltage, provided an intelligible picture is maintained for 1 h, at the end of which the measurement is made.	A CLA CLA CLA	A CAN
	For RS1, the dose-rate shall not exceed 1 µSv/h taking account of the background level.	to cate cate cate	A BORR
\$ \$	NOTE Z2 These values appear in Directive 96/29/Euratom of 13 May 1996.	A A A A	A 69
9	Modification to G.7.1		
G.7.1	Add the following note: NOTE Z1 The harmonized code designations corresponding to the IEC cord types are given in Annex ZD.	A CAR CAR CAR	N/A

10	Modification to Bibliography	



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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION					
Clause	Requirement + Test	Result - Remark	Verdict		

0	Add the following notes for	r the standards indicated:		N/A
o cho	IEC 60130-9 NOTI IEC 60269-2 NOTI IEC 60309-1 NOTI IEC 60364 NOTI IEC 60601-2-4 NOTI IEC 60664-5 NOTI IEC 61032:1997 NOTI IEC 61558-1 NOTI IEC 61558-2-1 NOTI IEC 61558-2-4 NOTI IEC 61558-2-6 NOTI IEC 61643-1 NOTI IEC 61643-21 NOTI	E Harmonized as EN 60130-9. E Harmonized as HD 60269-2. E Harmonized as EN 60309-1. E some parts harmonized in HD 384/HD 60364 series. E Harmonized as EN 60601-2-4. E Harmonized as EN 60664-5. E Harmonized as EN 61032:1998 (not modified). E Harmonized as EN 61508-1. E Harmonized as EN 61558-2-1. E Harmonized as EN 61558-2-6. E Harmonized as EN 61643-1. E Harmonized as EN 61643-1. E Harmonized as EN 61643-21. E Harmonized as EN 61643-311.		N/A
a cr	IEC 61643-321 NOTI	E Harmonized as EN 61643-321. E Harmonized as EN 61643-331.	S. "	C. C.
11	ADDITION OF ANNEXES		Ť	
ZB	ANNEX ZB, SPECIAL NA	TIONAL CONDITIONS (EN)	P	P
4.1.15	Denmark, Finland, Norwal To the end of the subclause added: Class I pluggable equipm for connection to other equipment of the safety relies reliable earthing or if surge are connected between the and accessible parts, have that the equipment shall be earthed mains socket-outled.	e the following is nent type A intended iipment or a es on connection to e suppressors e network terminals e a marking stating e connected to an	4 4 4	
B CEB	The marking text in the app be as follows:	chy chy chy chy chy chy	50	C'S'R
P CAP	In Denmark : "Apparatets s en stikkontakt med jord sor stikproppens jord." In Finland : "Laite on liitettä varustettuun pistorasiaan" In Norway : "Apparatet må stikkontakt"	m giver forbindelse til åvä suojakoskettimilla	C P	CER.
CAY	In Sweden : "Apparaten ska uttag"	all anslutas till jordat	•	C.S.



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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION				
Clause	Requirement + Test	Result - Remark	Verdict	

4.7.3	United Kingdom		N/A
	To the end of the subclause the following is added:		S. C. S.
b ch	The torque test is performed using a socket-outlet complying with BS 1363, and the plug part shall be assessed to the relevant clauses of BS 1363. Also see Annex G.4.2 of this annex	A CAP CAP CAP C	\$ C.S.
5.2.2.2	Denmark		Р
	After the 2nd paragraph add the following:	9 6 6 6 6	P C
	A warning (marking safeguard) for high touch current is required if the touch current exceeds the limits of 3,5 mA a.c. or 10 mA d.c.	to the the	4 C
5.4.11.1 and	Finland and Sweden	4 4 4 4	N/A
Annex G	To the end of the subclause the following is added:		5° C5
	For separation of the telecommunication network from earth the following is applicable:	Perpert of the criteria	S Cr
	If this insulation is solid, including insulation forming part of a component, it shall at least consist of either • two layers of thin sheet material, each of which	P CAP CAP CAP	A CA
	shall pass the electric strength test below, or		C
	 one layer having a distance through insulation of at least 0,4 mm, which shall pass the electric strength test below. 	A Charlet Charlet	S C'S
	If this insulation forms part of a semiconductor component (e.g. an optocoupler), there is no distance through insulation requirement for the insulation consisting of an insulating compound	P CAP CAP CAP	\$ 65
	completely filling the casing, so that clearances and creepage distances do not exist, if the component passes the electric strength test in accordance with the compliance clause below and in addition	the city city city	S CS
	 passes the tests and inspection criteria of 5.4.8 with an electric strength test of 1,5 kV multiplied by 1,6 (the electric strength test of 5.4.9 shall be performed using 1,5 kV), 	the city city city of	STO CE
	and A A A A A A A A A A A A A A A A A A A	4 44 44 44	P C
	is subject to routine testing for electric strength during manufacturing, using a test voltage of 1,5 kV.	the city city city	\$ C.S.
	It is permitted to bridge this insulation with a	A A A A	0

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Clause	Requirement + Test	Result - Remark	Verdic
9 6	\$\forall \phi_1 \phi_2 \phi_2 \phi_3 \phi_2 \phi_3	A 4 4 4 4	7 8 4
9 6	capacitor complying with EN 60384-14:2005, subclass Y2.	\$ \$ \$ \$ \$ \$	
	A capacitor classified Y3 according to EN 60384- 14:2005, may bridge this insulation under the following conditions:	CA CA CA	
	 the insulation requirements are satisfied by having a capacitor classified Y3 as defined by EN 60384-14, which in addition to the Y3 testing, is tested with an impulse test of 2,5 kV defined in 5.4.11; 	CAR CAR CAR CAR	
	 the additional testing shall be performed on all the test specimens as described in EN 60384- 14; 	er to cro cro	
C. C. V	the impulse test of 2,5 kV is to be performed before the endurance test in EN 60384-14, in the sequence of tests as described in EN 60384-14.		CT C
5.5.2.1	Norway		N/A
	After the 3rd paragraph the following is added:	A A A A A A	40
	Due to the IT power system used, capacitors are required to be rated for the applicable line-to-line voltage (230 V).	A CA CA CA	
5.5.6	Finland, Norway and Sweden	40 40 40 4	N/A
	To the end of the subclause the following is added:		c' c
	Resistors used as basic safeguard or bridging basic insulation in class I pluggable equipment type A shall comply with G.10.1 and the test of G.10.2.	of the cycle cycle	
5.6.1	Denmark C		N/A
	Add to the end of the subclause Due to many existing installations where the socket-outlets can be protected with fuses with higher rating than the rating of the socket-outlets the protection for pluggable equipment type A shall be an integral part of the equipment.	A CAP CAP CAP	
	Justification: In Denmark an existing 13 A socket outlet can be protected by a 20 A fuse.	A 44 44 44	***



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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION				
Clause	Requirement + Test	Result - Remark	Verdict	

5.6.4.2.1	Ireland and United Kingdom	N/A
o cho	After the indent for pluggable equipment type A , the following is added: - the protective current rating is taken to be 13 A, this being the largest rating of fuse used in the mains plug.	
5.6.4.2.1	France After the indent for pluggable equipment type A, the following is added: — in certain cases, the protective current rating of the circuit supplied from the mains is taken as 20 A instead of 16 A.	N/A
5.6.5.1	To the second paragraph the following is added: The range of conductor sizes of flexible cords to be accepted by terminals for equipment with a rated current over 10 A and up to and including 13 A is: 1,25 mm² to 1,5 mm² in cross-sectional area.	N/A
5.6.8	Norway To the end of the subclause the following is added: Equipment connected with an earthed mains plug is classified as class I equipment. See the Norway marking requirement in 4.1.15. The symbol IEC 60417-6092, as specified in F.3.6.2, is accepted.	N/A
5.7.6	Denmark To the end of the subclause the following is added: The installation instruction shall be affixed to the equipment if the protective conductor current exceeds the limits of 3,5 mA a.c. or 10 mA d.c.	N/A

5.7.6.2	Denmark		N/A
C. L. A.	To the end of the subclause the following is added: The warning (marking safeguard) for high touch	the city city city ci	S. C.L.
D LD	current is required if the touch current or the protective current exceed the limits of 3,5 mA.	Ch Lh Lh Lh	10 40
5.7.7.1	Norway and Sweden		N/A
CLA	To the end of the subclause the following is added: The screen of the television distribution system is		L. C.L.
D CLD	normally not earthed at the entrance of the building and there is normally no equipotential bonding system within the building.	has created and creating	P CYP
BCEB	Therefore the protective earthing of the building installation needs to be isolated from the screen of a cable distribution system.	and can can can	P CER
0.0	0 0 0 0 0 0	0 0 0 0	4 4

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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION				
Clause	Requirement + Test	Result - Remark	Verdict	
7.4	\$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$	\$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$	\$ \$ \$	
6,3	It is however accepted to provide the insulation		CT C	
	external to the equipment by an adapter or an	40 40 40	45 45	
	interconnection cable with galvanic isolator, which	. C . C . C . C		
	may be provided by a retailer, for example.		0 0	
	0 0 0 0 0 0 0	0 0 0	0 0	
	The user manual shall then have the following or	'e, 'e, 'e, 'e,		
	similar information in Norwegian and Swedish		0	
	language respectively, depending on in what	0 0 0	0 0	
	country the equipment is intended to be used in:			
	"Apparatus connected to the protective earthing of	4 4 4 A	9 9	
	the building installation through the mains			
	connection or through other apparatus with a			
	connection to protective earthing –	2 6 2 6 B	A 4 A 4	
	and to a television distribution system using coaxia			
	cable, may in some circumstances create a fire	A A A	A A	
	hazard. Connection to a television distribution	AN AN AN A	A "A "	
	system therefore has to be provided through a		C C	
	device providing electrical isolation below a certain		A	
	frequency range (galvanic isolator, see EN 60728-	CA CA CA C	Y AY A	
	11)"		0 0	
	NOTE In Norway, due to regulation for CATV-installations, and	40 40 40	Q0 Q0	
	in Sweden, a galvanic isolator shall provide electrical insulation		,	
	below 5 MHz. The insulation shall withstand a dielectric strengt	th o o o	0 0	
	of 1,5 kV r.m.s., 50 Hz or 60 Hz, for 1 min.	0 0 0	0 0	
	Translation to Norwegian (the Swedish text will			
	also be accepted in Norway):			
	also so accepted in the may).	0 0 0	0 0	
	"Apparater som er koplet til beskyttelsesjord via		- 10 AS	
	nettplugg og/eller via annet jordtilkoplet			
	utstyr – og er tilkoplet et koaksialbasert kabel-TV	CO CO CO	9 9	
	nett, kan forårsake brannfare.			
	For å unngå dette skal det ved tilkopling av			
	apparater til kabel-TV nett installeres en	4 4 4 A	40 40	
	galvanisk isolator mellom apparatet og kabel-TV			
	nettet."	A A A	A A	
	AY AY AY AY AY AY AY	VA VA VA V	Y AY	
	Translation to Swedish:		CC	
	"Apparater som är kopplad till skyddsjord via jorda	t as as as	Do Do	
	vägguttag och/eller via annan utrustning och	KY KY KY K	, Y A Y A	
	samtidigt är kopplad till kabel-TV nät kan i vissa fa		0 0	
	medfőra risk főr brand. Főr att undvika detta skall	00 00 00	Do Do	
	1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 -			

vid anslutning av apparaten till kabel-TV nät galvanisk isolator finnas mellan apparaten och kabel-TV nätet.".



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D CD	IEC 62368-1_ATTACHMI	ENT NO.1: NATIONAL DEVIATION	P CP C
Clause	Requirement + Test	Result - Remark	Verdict

8.5.4.2.3	United Kingdom	0 0 0 0	N/A
A CAN C	Add the following after the 2 nd dash bullet in 3 rd paragraph:	A CLACKA CLACK	W. C.
	An emergency stop system complying with the requirements of IEC 60204-1 and ISO 13850 is required where there is a risk of personal injury.	A A A A	4 CF
B.3.1 and	Ireland and United Kingdom	7 67 67 67 6	N/A
B.4	The following is applicable:	A RA RA RA	4 4
\$ CK C	To protect against excessive currents and short-circuits in the primary circuit of direct plug-in equipment , tests according to Annexes B.3.1 and B.4 shall be conducted using an external miniature	the city city city city	D CLB
P CYP C	circuit breaker complying with EN 60898-1, Type B, rated 32A. If the equipment does not pass these tests, suitable protective devices shall be included	the city city city c	P CYP
P CYP C	as an integral part of the direct plug-in equipment , until the requirements of Annexes B.3.1 and B.4 are met	en criticist criticis	P C S P

G.4.2	Denmark	0		C'Y			N/A
D CD	To the end of the subclause the following is added:	P S					D VB
B CLB	Supply cords of single phase appliances having a rated current not exceeding 13 A shall be provided with a plug according to DS 60884-2-D1:2011.	CA CA					P CEP
o ch	CLASS I EQUIPMENT provided with socket-outlets with earth contacts or which are intended to be used in locations where protection against indirect contact is required according to the wiring rules shall be provided with a plug in accordance with standard sheet DK 2-1a or DK 2-5a.	10 P					P CAR
B CLB	If a single-phase equipment having a RATED CURRENT exceeding 13 A or if a polyphase equipment is provided with a supply cord with a plug, this plug shall be in accordance with the standard sheets DK 6-1a in DS 60884-2-D1 or EN 60309-2.	10 05 10 05 10 05					\$ 55 \$ 55
P CEP	Mains socket outlets intended for providing power to Class II apparatus with a rated current of 2,5 A shall be in accordance DS 60884-2-D1:2011 standard sheet DKA 1-4a.	** c5					\$ C5.9
\$ C\$	Other current rating socket outlets shall be in compliance with Standard Sheet DKA 1-3a or DKA 1-1c.	\$ 6°	•	C. P.	c'h R	c ^r	\$ 28

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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION			
Clause	Requirement + Test	Result - Remark	Verdict

. 55		
	Mains socket-outlets with earth shall be in compliance with DS 60884-2-D1:2011 Standard Sheet DK 1-3a, DK 1-1c, DK1-1d, DK 1-5a or DK 1-7a	A A A A A
	Justification:	
	Heavy Current Regulations, Section 6c	4 4 4 4 4
G.4.2	United Kingdom	O O O N/A
	To the end of the subclause the following is added:	TO CHE CHE CHE CHE
	The plug part of direct plug-in equipment shall be assessed to BS 1363: Part 1, 12.1, 12.2, 12.3, 12.9, 12.11, 12.12, 12.13, 12.16, and 12.17, except that the test of 12.17 is performed at not less than 125 °C. Where the metal earth pin is replaced by	
5 43	an Insulated Shutter Opening Device (ISOD), the requirements of clauses 22.2 and 23 also apply.	
3.7.1	United Kingdom	N/A
	To the first paragraph the following is added:	3 3 3 3 3 3
	Equipment which is fitted with a flexible cable or cord and is designed to be connected to a mains socket conforming to BS 1363 by means of that flexible cable or cord shall be fitted with a 'standard	
	plug' in accordance with the Plugs and Sockets etc. (Safety) Regulations 1994, Statutory Instrument 1994 No. 1768, unless exempted by those regulations.	A A A A A
C.	NOTE "Standard plug" is defined in SI 1768:1994 and essentially means an approved plug conforming to BS 1363 or an approved conversion plug.	
3.7.1	Ireland	N/A
	To the first paragraph the following is added:	5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5
	Apparatus which is fitted with a flexible cable or cord shall be provided with a plug in accordance with Statutory Instrument 525: 1997, "13 A Plugs and Conversion Adapters for Domestic Use	CA CA CA CA CA
	Regulations: 1997. S.I. 525 provides for the recognition of a standard of another Member State which is equivalent to the relevant Irish Standard	Construction of the construction of
3.7.2	Ireland and United Kingdom	N/A
	To the first paragraph the following is added:	0 0 0 0
	A power supply cord with a conductor of 1,25 mm ² is allowed for equipment which is rated over 10 A and up to and including 13 A.	

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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION						
Clause	Requirement + Test	Result - Remark	Verdict			

ZC 🔷	ANNEX ZC, NATIONAL DEVIATIONS (EN)		N/A
10.5.2	Germany C	0,0,0,0,	N/A
	The following requirement applies:	A LA LA LA	10 5
	For the operation of any cathode ray tube intended for the display of visual images operating at an acceleration voltage exceeding 40 kV, authorization is required, or application of type approval (Bauartzulassung) and marking.	rb rb rb rb	
	Justification: German ministerial decree against ionizing radiation (Röntgenverordnung), in force since 2002-07-01, implementing the European Directive 96/29/EURATOM.	EB CEB CEB CEB	
	NOTE Contact address: Physikalisch-Technische Bundesanstalt, Bundesallee 100, D-38116 Braunschweig, Tel.: Int+49-531-592-6320, Internet: http://www.ptb.de	the classical	cf. to cry



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IEC 62368-1_ATTACHMENT NO.1: NATIONAL DEVIATION						
Clause	Requirement + Test	Result - Remark	Verdict			

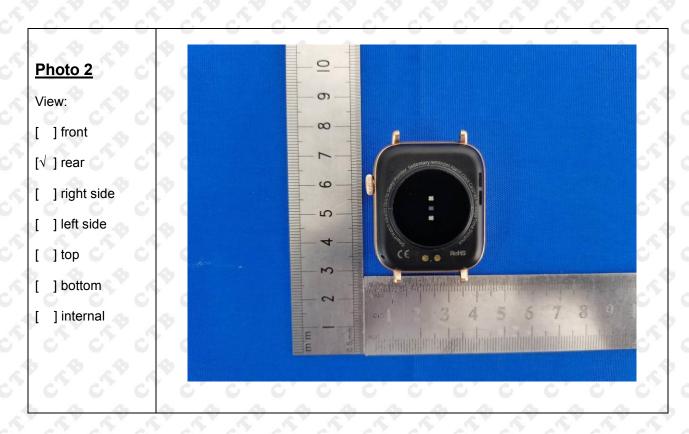
Type of flexible cord	Code designations		
	IEC	CENELEC	
PVC insulated cords			
Flat twin tinsel cord	60227 IEC 41	H03VH-Y	
Light polyvinyl chloride sheathed flexible cord	60227 IEC 52	H03VV-F H03VVH2-F	
Ordinary polyvinyl chloride sheathed flexible cord	80227 IEC 53	H05VV-F H05VVH2-F	
Rubber insulated cords			
Braided cord	60245 IEC 51	H03RT-F	
Ordinary tough rubber sheathed flexible cord	60245 IEC 53	H05RR-F	
Ordinary polychloroprene sheathed flexible cord	60245 IEC 57	H05RN-F	
Heavy polychloroprene sheathed flexible cord	60245 IEC 66	H07RN-F	
Cords having high flexibility	•	•	
Rubber insulated and sheathed cord	60245 IEC 86	H03RR-H	
Rubber insulated, crosslinked PVC sheathed cord	60245 IEC 87	H03 RV4-H	
Crosslinked PVC insulated and sheathed cord	60245 IEC 88	H03V4V4-H	
Cords insulated and sheathed with halogen- free thermoplastic compounds			
Light halogen-free thermoplastic insulated and sheathed flexible cords		H03Z1Z1-F H03Z1Z1H2-	
Ordinary halogen-free thermoplastic insulated and sheathed flexible cords		H05Z1Z1-F H05Z1Z1H2-	

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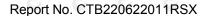
Report No. CTB220622011RSX

PHOTO DOCUMENTATION_ATTACHMENT NO. 2 <u>Photo documentation</u>

Photo 1 View: [√] front [] rear [] left side [] lop [] bottom [] internal



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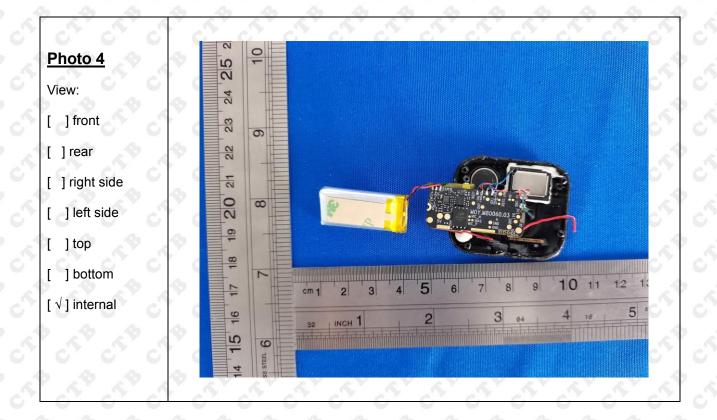




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Photo documentation

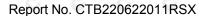
Photo 3 26 25 View: 24 [] front 23 [] rear 22 [] right side 2 [] left side 20 [] top 6 [] bottom [√] internal 5 10 11 16 3 2



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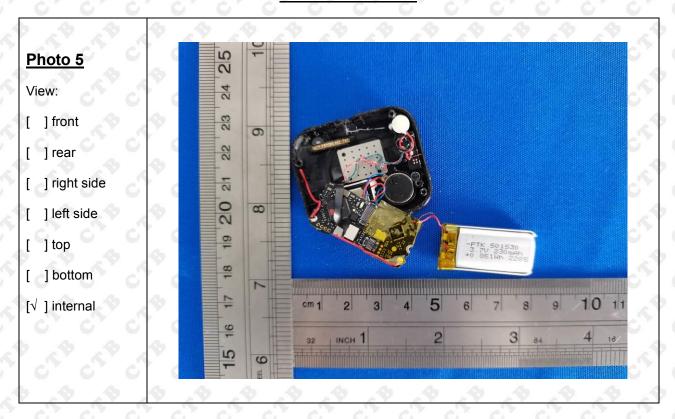
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Photo documentation



******End of test report*****



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Shenzhen Xiangmingda Technology Co., Ltd. Applicant:

8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial Zone), Huangbu Community, Address:

Hangcheng Street, Baoan District, Shenzhen

Manufacturer: Shenzhen Xiangmingda Technology Co., Ltd.

8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial Zone), Huangbu Community, Address:

Hangcheng Street, Baoan District, Shenzhen

The following samples were submitted and identified on behalf of the clients as:

Smart Watch Sample name:

Brand:

Model(s): See next pages

Batch No.:

Sample received date: June 10,2022

Testing period: June 10,2022 to June 23,2022

Test Method: Please refer to next page(s). Test Result: Please refer to next page(s).

Result Summary:

Test Requested	Conclusion
European Directive 2011/65/EU and amendment (EU) 2015/863 on the restriction of the use of certain hazardous substances in electrical and electronic equipment	PASS

Tested By:

Check By:

Spair Weng



Date: June 23, 2022

Note: If there is any objection to the inspection results in this report, please submit a written report to the company within 15 days from the date of receiving the report. The test report is effective only with both signature and specialized stamp. This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen CTB Testing Technology Co., Ltd. this report can't be reproduced except in full. The tested sample(s) and the sample information are provided by the client. "*" indicates the testing items were fulfilled by subcontracted lab. "#" indicates the items are not in CNAS accreditation scope.

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Series models as below (page 2)

Model(s)

SW/29, T48, T49,T12, E300,S2, S2P, S3, S5,S6,S6P, S6T, S7, S8, S9, S10, T40, T42, T41, T41S, T42S,T43, T33S,T30,T46S, T32S, T34S, T45S, T60, T66, T11, T68, T69, T90, TW26, TW27, E86, E87, E88, E89, E80,E66, E10, E90, E98, E200, E400, E500, E510, E600, E800, E900, E88pro,E88mini, F100, F12,F100,F18, F45,F60,F11,F12, F28, F80, M6, M5, M4S, X5

Test Method:

A. Screening test by XRF spectroscopy

XRF screening limits for regulated elements according to IEC 62321-3-1:2013

	Screening lim	MDL			
Element□	Polymers and metals Composite material		Polymers	Other material	
Pb	BL≤(700-3σ) <x <(1300+3σ)<br="">≤OL □</x>	BL≤(500-3σ) <x <(1500+3σ)<br="">≤OL</x>	10mg/kg	50mg/kg	
Cd	BL≤(70-3σ) <x <(130+3σ)<br="">≤OL</x>	LOD≤(50-3σ) <x <(150+3σ)<br="">≤OL□</x>	10mg/kg	50mg/kg	
Hg	BL≤(700-3σ) <x <(1300+3σ)="" <(1500+<br="" bl≤(500-3σ)<x="">≤OL□ ≤OL□</x>		10mg/kg	50mg/kg	
Cr	BL≤(700-3σ)< X	BL≤(500-3σ)< X	10mg/kg	50mg/kg	
Br BL≤(300-3σ)< X (non-metal only)		BL≤(250-3σ)< X	10mg/kg	50mg/kg	

B. Chemical Test

Test Item(s)	Test Method□	Analysis Equipment(s)	MDL	Limit□
Lead (Pb)	IEC 62321-5:2013	ICP-OES	10mg/kg	1000mg/kg
Cadmium (Cd)	IEC 62321-5:2013	ICP-OES	10mg/kg	100mg/kg□
Mercury (Hg)	IEC 62321-4:2013+AMD1:2017	ICP-OES	10mg/kg	1000mg/kg
Hexavalent Chromium Cr(VI)	IEC 62321-7-1:2015 & IEC 62321-7-2:2017	UV-VIS	10mg/kg	1000mg/kg
Polybrominated Biphenyls (PBBs)□	IEC 62321-6:2015	GC-MS	10mg/kg	1000mg/kg
Polybrominated Diphenyl Ethers (PBDEs)□	IEC 62321-6:2015	GC-MS	10mg/kg	1000mg/kg
Dibutyl Phthalate	IEC 62321-8:2017	GC-MS	30mg/kg	1000mg/kg
Benzylbutyl Phthalate	IEC 62321-8:2017	GC-MS	30mg/kg	1000mg/kg
Bis-(2-ethylhexyl)Phthalate	IEC 62321-8:2017	GC-MS	30mg/kg	1000mg/kg
Diisobutyl phthalate	IEC 62321-8:2017	GC-MS	30mg/kg	1000mg/kg



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Tested material list

Sample No.	Description
\$ 1 _{\$}	Black glass (display)
2	Rose gold plated metal frame
3	White plastic (display)
4	Transparent plastic (display)
5	Black plastic (display)
6	Black plastic case (dial)
7	Black PCB
8	Yellow plastic film
9	Silver magnet
10	Silver metal screws

Note: test samples were specified by applicant.



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Test Result(s):

No.	6	XRF :	screeni	ng Resu	ılt	Chemical confirm Result	Remark	Conclusion
	Pb	Cd	Hg	Cr	Br	(mg/kg)		
♦ 1	BL	BL	BL	BL	BL	\$ \$ \$ · \$ \$	\$ - \$	PASS
2	BL	BL	BL	BL	N/A	& & & & &	\$ <u>0</u>	PASS
3	BL	BL	BL	BL	BL		c	PASS
4	BL	BL	BL	BL	BL	Charles Charles	5 C C	PASS
5	BL	BL	BL	BL	BL	A A A A	28 -28	PASS
6	BL	BL	BL	BL	BL	& & .	,	PASS
7	BL	BL	BL	BL	BL		~ c	PASS
8	BL	BL	BL	BL	BL	The Care Care	5 C C	PASS
9	BL	BL	BL	BL	N/A	AB AB AB AB	A -A	PASS
10	BL	BL	BL	BL	N/A	4 4 4	~ - ~	PASS



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Test Item(s)	Dibutyl Phthalate (DBP) (mg/kg)	Benzylbutyl Phthalate (BBP) (mg/kg)	Bis-(2-ethylhexyl) Phthalate (DEHP) (mg/kg)	Diisobutyl phthalate (DIBP) (mg/kg)	\$ 5 C	
CAS No.	84-74-2	85-68-7	117-81-7	84-69-5	Conclusion	
Limit	1000	1000	1000	1000	5,50	
No.	Result (mg/kg)					
3+4+5	N.D	N.D	N.D	N.D	PASS	
6	N.D	N.D	N.D	N.D	PASS	
8	N.D	N.D	N.D	N.D	PASS	

Remark:

- 1. BL = below the limit
- 2. OL = over the limit
- 3. X = inconclusive, chemical confirm test is needed
- 4. NA = not applicable
- 5. mg/kg = milligram per kilogram = ppm
- 6. N.D = not detected
- 7. Negative = The Cr⁶⁺ concentration is below the limit of quantification. The coating is considered a non- Cr⁶⁺ based coating.
- 8. Positive = The Cr⁶⁺ concentration is above the limit of quantification and the statistical margin of error, The sample coating is considered to contain Cr⁶⁺.
- 9. The limit for composite test should be divided by the mixed number.

Note:

- 1. When perform screening tests, it is the result on total Br while test item on restricted substances is PBBs/PBDEs, it is the result on total Cr while test item on restricted substances is Cr⁶⁺.
- Pb, Cd, Hg, Cr and Br results are obtained by EDXRF for primary screening, and further chemical testing by ICP-OES (for Cd, Pb, Hg), UV-VIS (for Cr⁶⁺) and GC-MS (for PBBs, PBDEs) is needed to be performed, if the concentration falls into the inconclusive area according to IEC 62321-3-1:2013.
- For the XRF screening test for RoHS elements, the reading may be different to the actual content in the sample be of non-uniformity composition.

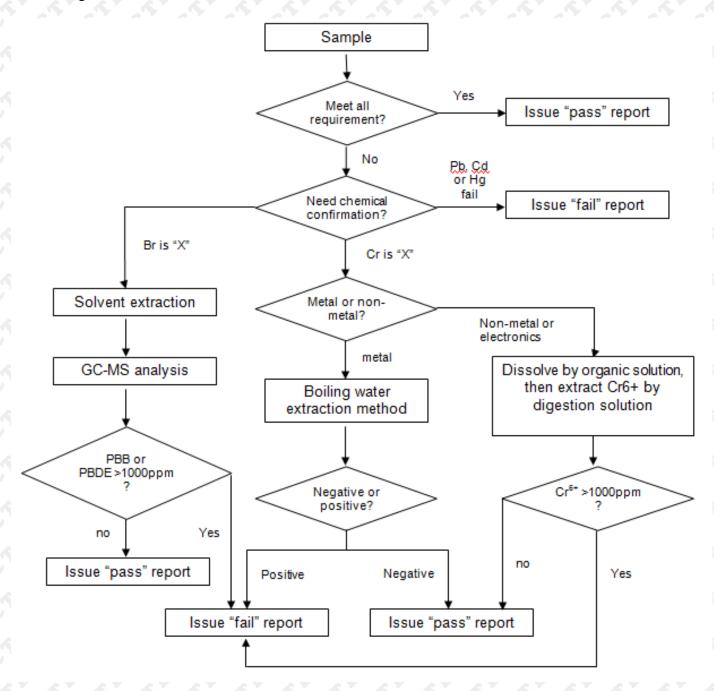


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Test flow chart

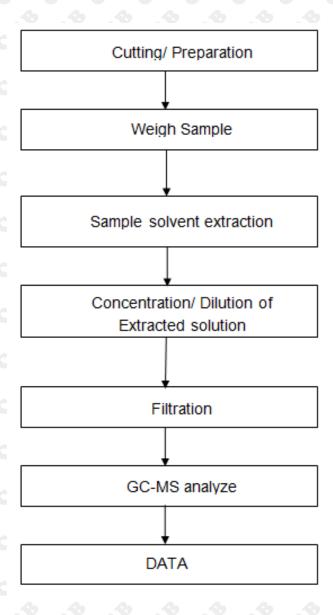
1. Pb/Cd/Hg/Cr⁶⁺/PBBs/PBDEs





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2. Phthalate test flow chart



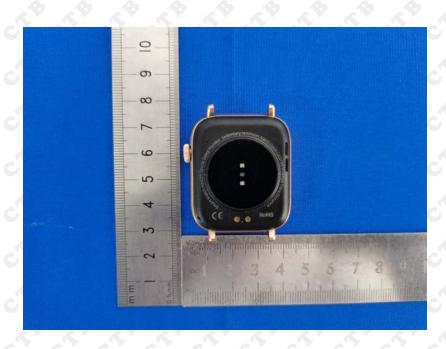


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Photo documentation







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*** End of Report ***



CERTIFICATE OF CONFORMITY

EU - Restriction of the use of certain hazardous substances (RoHS) - No. CTB220623010CX -ZS

Applicant : Shenzhen Xiangmingda Technology Co., Ltd.

Address : 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial

Zone), Huangbu Community, Hangcheng Street, Baoan District,

Shenzhen

Manufacturer : Shenzhen Xiangmingda Technology Co., Ltd.

Address : 8F, Block A, Building C4, No.3 Industrial Park (Tianlong Industrial

Zone), Huangbu Community, Hangcheng Street, Baoan District,

Shenzhen

Product: Smart Watch

Trade mark : /

Model(s) : See page 2

Test Report No. : CTB220623010CX

Test Standards : IEC 62321-3-1:2013, IEC 62321-4:2013+AMD1:2017,

IEC 62321-5:2013, IEC 62321-6:2015,

IEC 62321-7-1:2015 & IEC 62321-7-2:2017, IEC 62321-8:2017

The test results based on the above specified products comply with the EU RoHS Directive 2011/65 / EU Appendix II and amendment Directive (EU) 2015/863 limit on the restriction of the use of certain hazardous substances in electrical and electronic equipment.

The test results apply only to the particular sample tested and to the specific tests carried out.





This Declaration is for the exclusive use of CTB's Client and is provided pursuant to the agreement between CTB and its Client.

The observations and test results referenced from this Declaration are relevant only to the sample tested. This Declaration by itself does not imply that the material, product, or service is or has ever been under a CTB certification program.



Shenzhen CTB Testing Technology Co., Ltd

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CERTIFICATE OF CONFORMITY

- Restriction of the use of certain hazardous substances (RoHS) - No. CTB220623010CX -ZS

Series models as below (page 2):

conce incubic de belon (page 1)						
		SW/29, T48, T49,T12, E300,S2, S2P, S3, S5,S6,S6P, S6T, S7, S8, S9,				
		S10, T40, T42, T41, T41S, T42S,T43, T33S,T30,T46S, T32S, T34S,				
		T45S, T60, T66, T11, T68, T69, T90, TW26, TW27, E86, E87, E88,				
N # 1.17.3		E89, E80,E66, E10, E90, E98, E200, E400, E500, E510, E600, E800,				
Model(s)	:	E900, E88pro, E88mini, F100, F12, F100, F18, F45, F60, F11, F12, F28,				
		F80, M6, M5, M4S, X5				



Web: http://www.ctb-lab.net Tel: 4008-707-283 Email: ctb@ctb-lab.net